



Semiconductor disk lasers and SESAMs: material and design optimization

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Online Conference, May 9-13, 2021
Plenary Talk, 10. May 2021, 3 pm

Acknowledgements, near-IR effort



Jacob Nürnberg
(2020)



Cesare
Alfieri (2018)



Dominik
Waldburger
(2018)



Aline
Mayer (2018)



Sandro
Link (2017)



Christian
Zaugg (2014)



Mario
Mangold (2015)



Alexander
Klenner (2015)



Dr. Bauke
Tilma (2015)



Oliver
Sieber (2013)



Valentin
Wittwer (2012)



Martin
Hoffmann
(2011)



Dr. Thomas
Südmeyer
(2011)



Benjamin
Rudin (2010)



Dr. Matthias
Golling



Deran
Maas (2008)



Aude-Reine
Bellancourt
(2009)

ETH Acknowledgements, long-wavelength effort ($> 2 \mu\text{m}$)



Jonas
Heidrich



Marco
Gaulke



Dr. Ajanta
Barh



Dr. Matthias
Golling

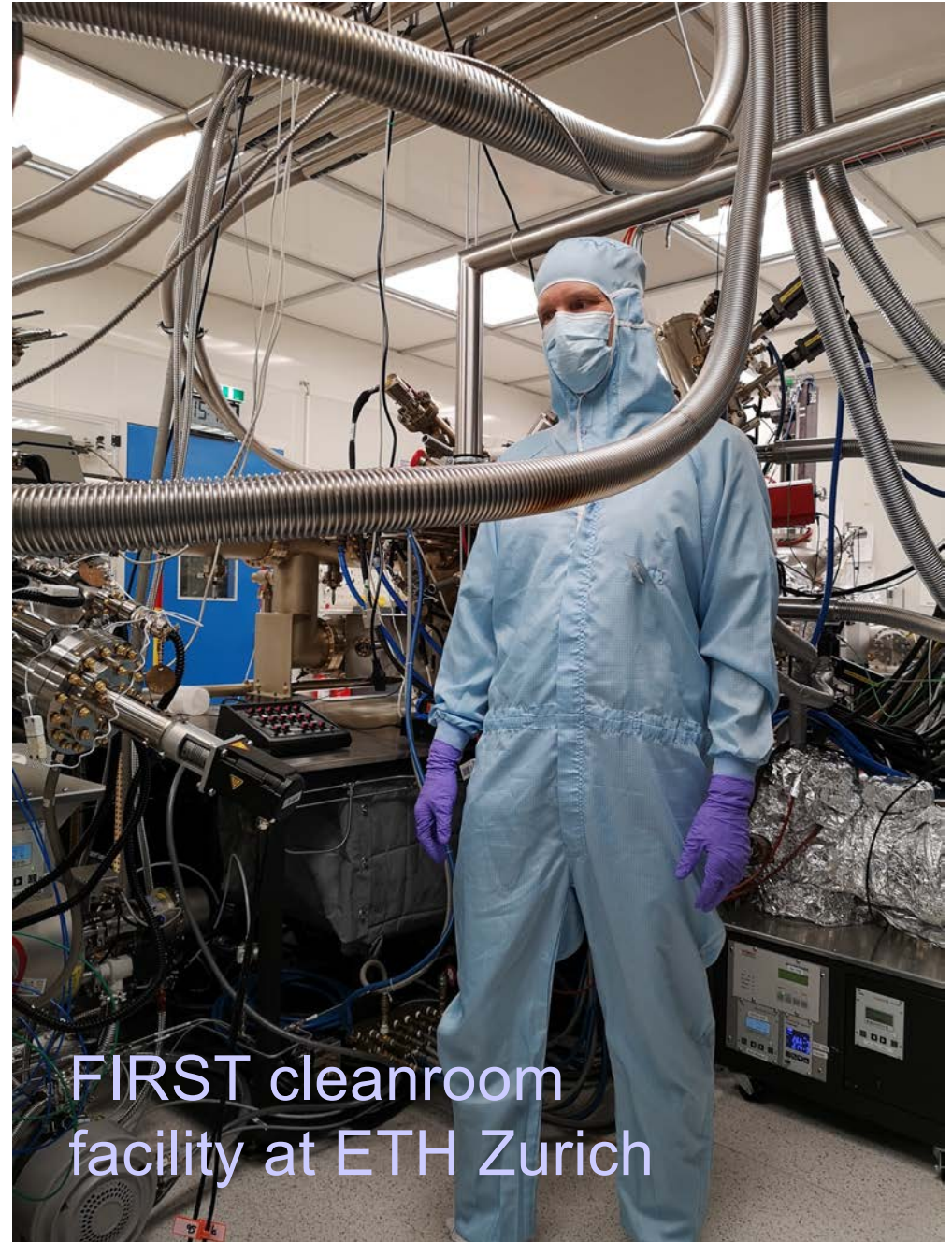


Dr. Özgür
Alaydin

FIRST | | | | | | | | | | | |
Center for Micro- and Nanoscience



This project has received funding from the European Research Council (ERC) under the European Union's Horizon 2020 research and innovation programme grant agreement No 787097



FIRST cleanroom
facility at ETH Zurich





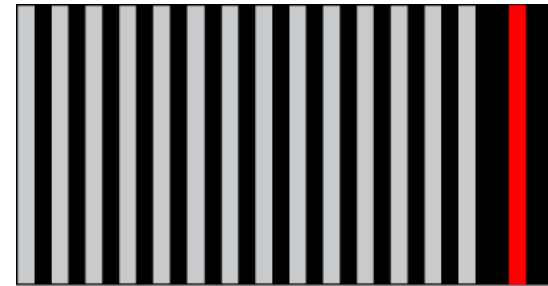
- 1. SESAM, VECSEL and MIXSEL basic device structure**
- 2. Dual-comb modelocking and application demonstration**
- 3. III-V semiconductor material**
- 4. MIXSEL and SESAM modelocked VECSEL**
- 5. Long wavelength SESAMs ($> 2\mu\text{m}$)**
- 6. Outlook**



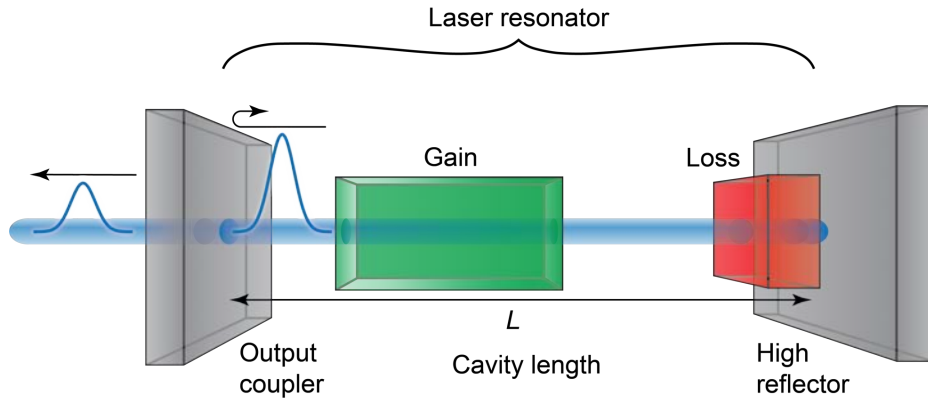
Passively modelocked lasers

Semiconductor Saturable Absorber Mirror
SESAM

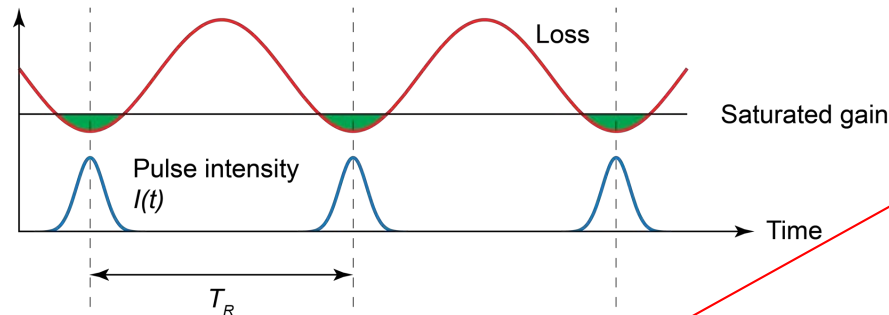
30 pair DBR saturable absorber



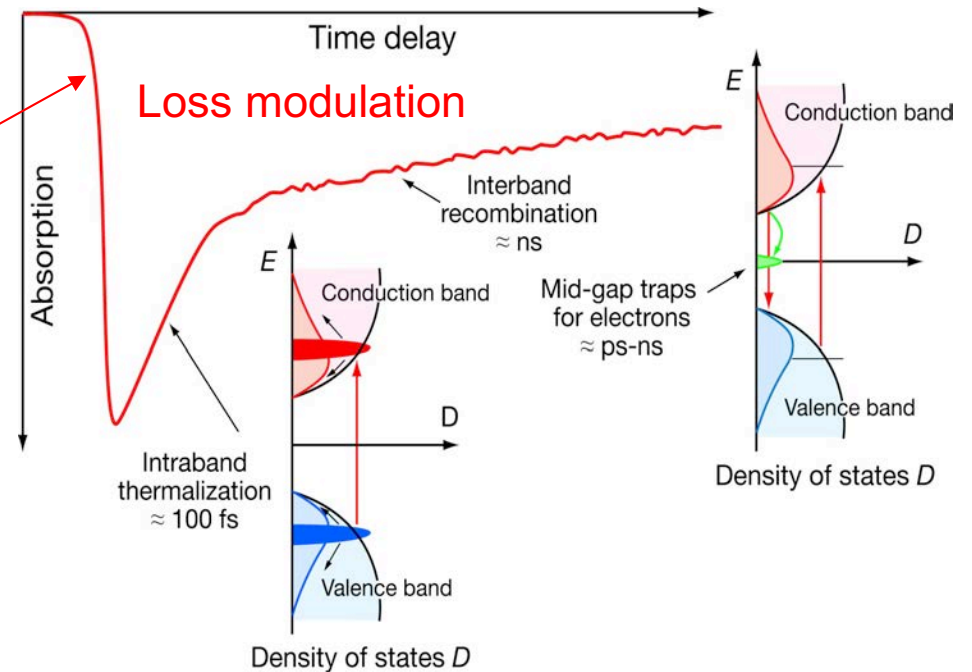
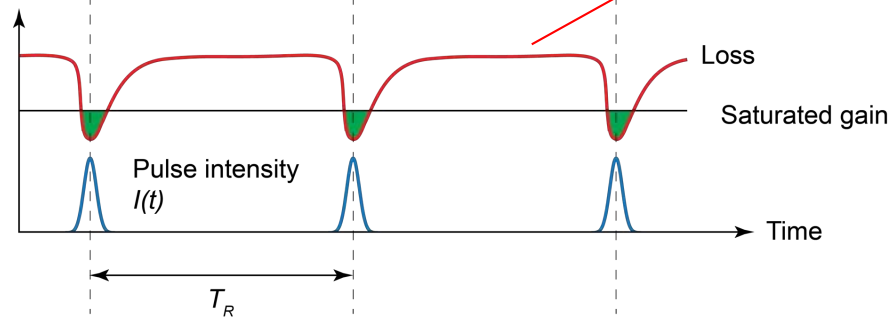
incident field



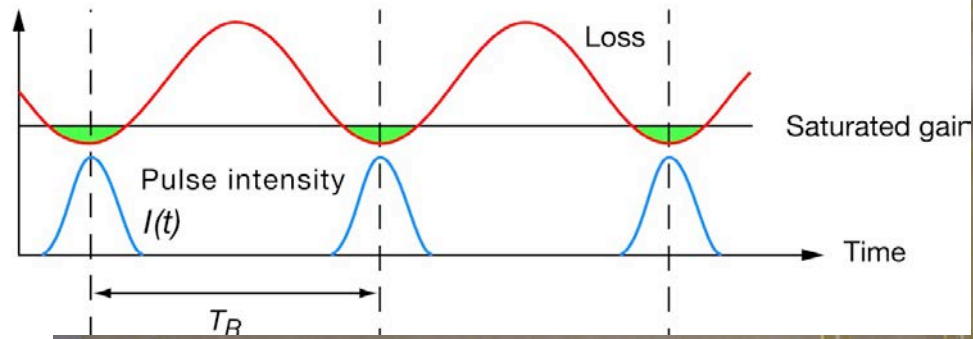
Active modelocking



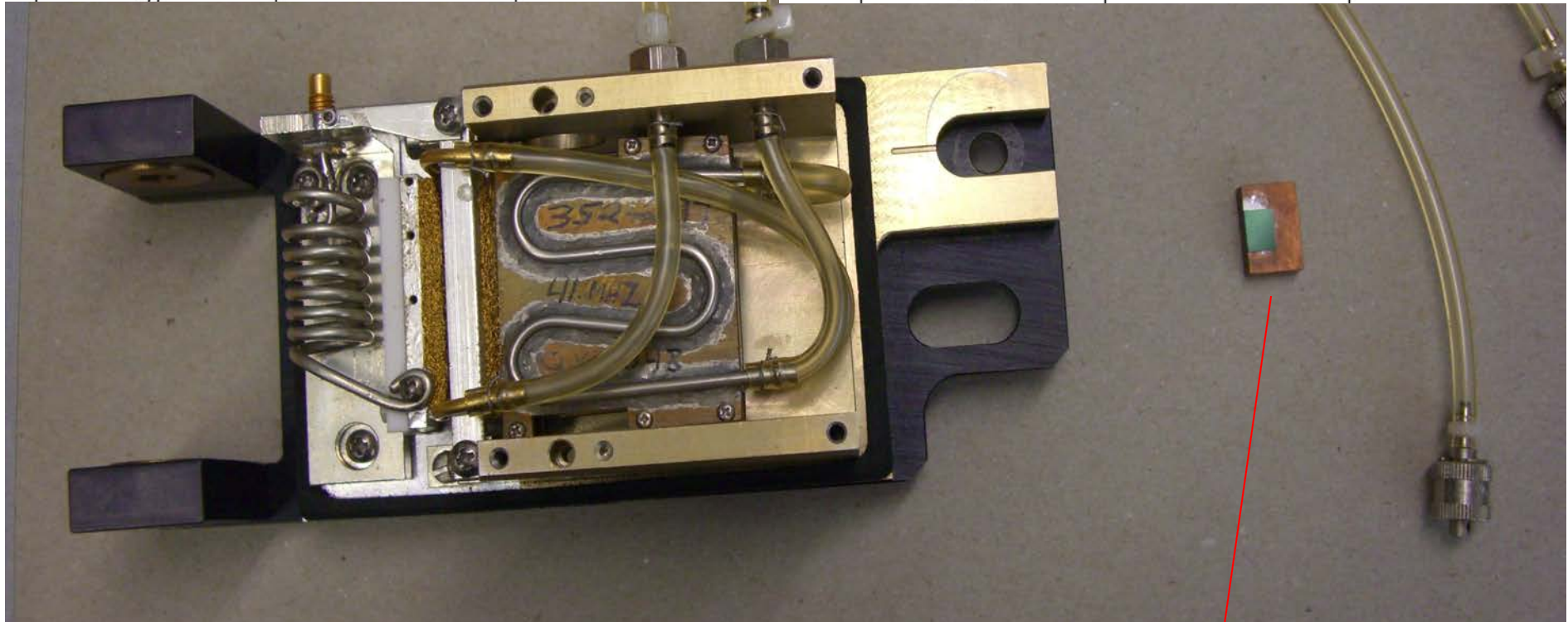
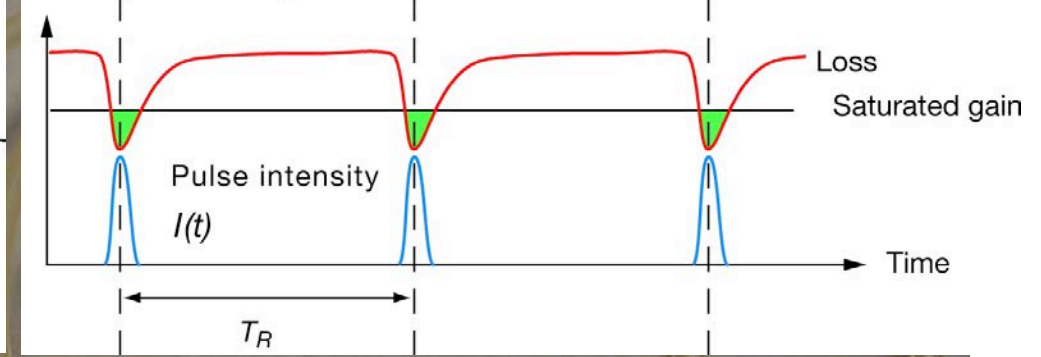
Passive modelocking



Active modelocking



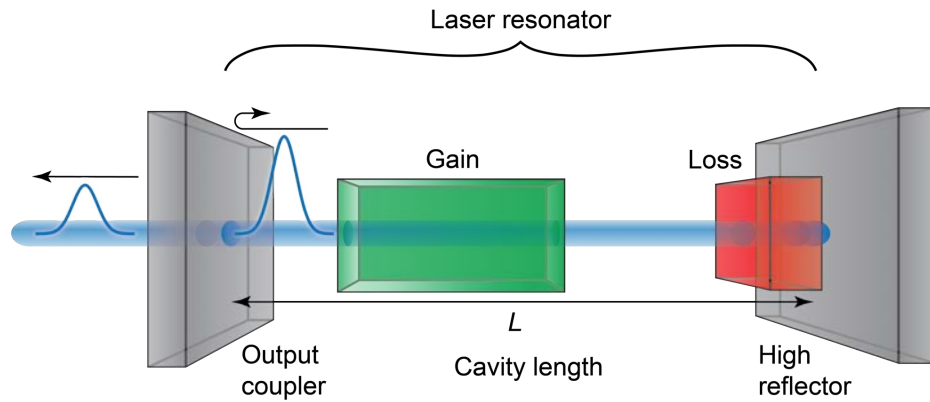
Passive modelocking



acousto-optic modelocker
needs RF power and water cooling

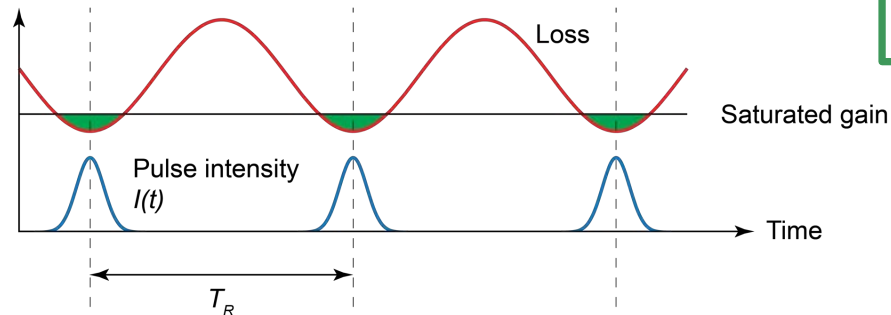
SESAM modelocker

Passively modelocked lasers

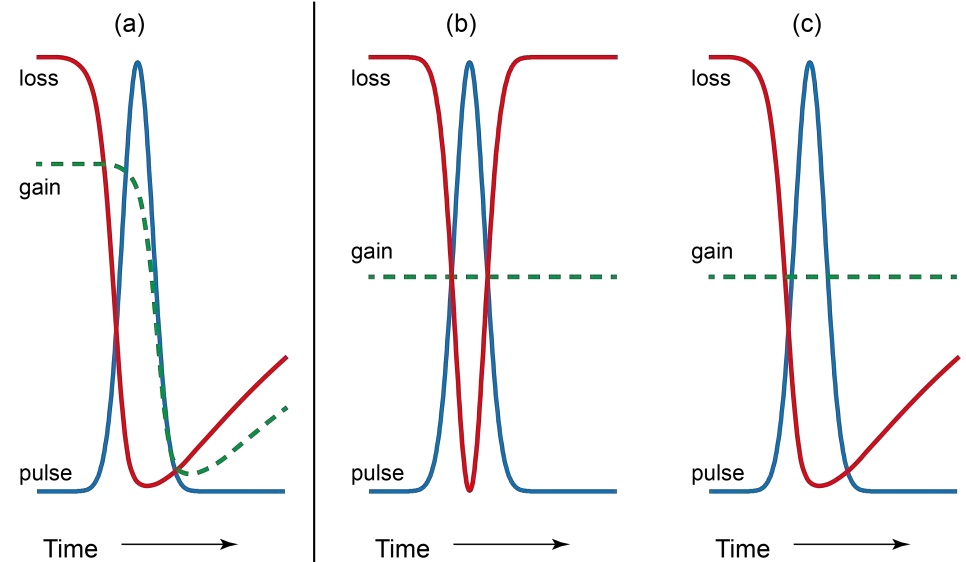
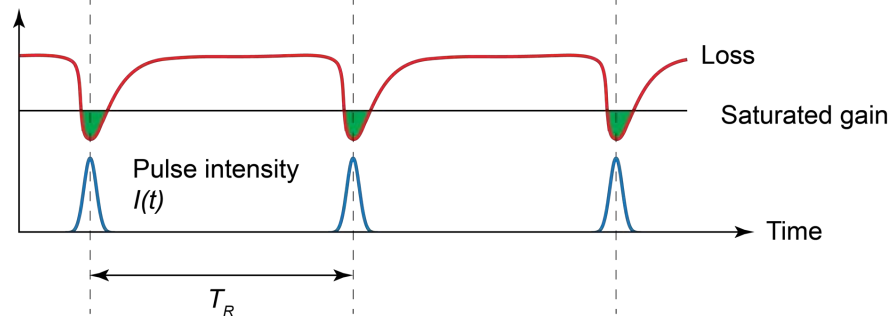


Laser material	σ [cm ²]	τ_L
Semiconductor laser	$\approx 10^{-14}$	≈ 1 ns
Dye laser:rhodamine 6G	$\approx 10^{-16}$	≈ 5 ns
Ti:sapphire @ 780 nm	3.8×10^{-19}	2.5 μ s
Cr:LiSAF @ 830 nm	4×10^{-20}	67 μ s
Nd:YAG @ 1.064 μ m	6.5×10^{-19}	250 μ s
Yb:YAG @ 1.03 μ m	2×10^{-20}	950 μ s
Nd:glass @ 1.054 μ m	4×10^{-20}	350 μ s

Active modelocking



Passive modelocking



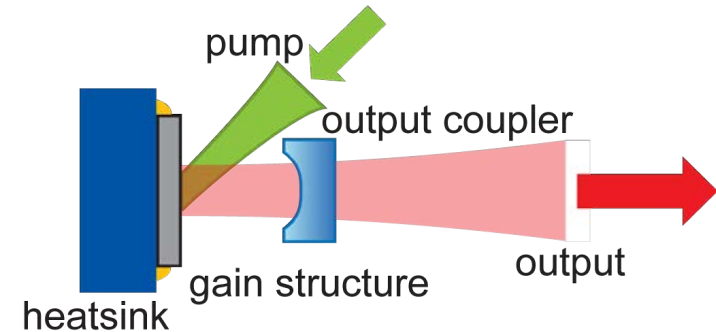
semiconductor and dye lasers

ion-doped solid-state lasers



VECSEL (Vertical External-Cavity Surface-Emitting Laser) #1

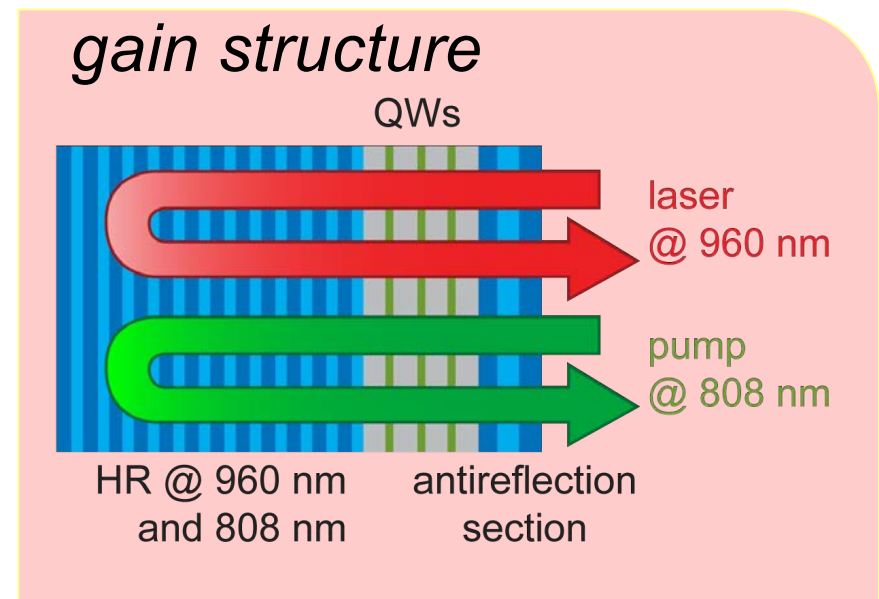
- gain structure (low gain)
- output coupler (a few percent)
- high-Q cavity
- low noise

**External cavity:**

- intracavity frequency doubling
- **modelocking**
- **single mode operation (TEM₀₀)**

Diode-pumped semiconductor laser:

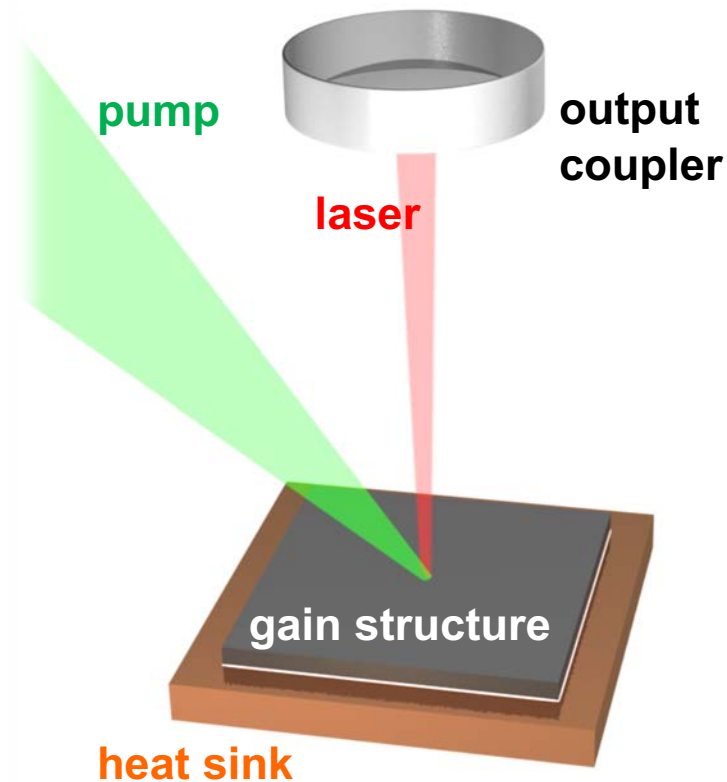
- bandgap engineering
- **high level of integration**
- wafer scale technology
- power scaling



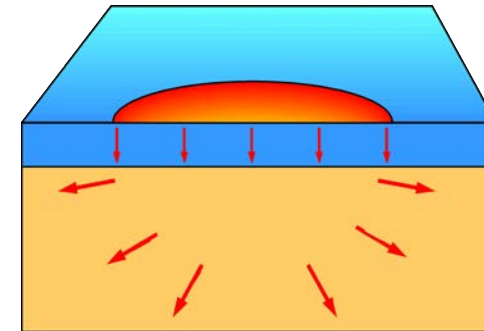
#1 Kuznetsov et al., IEEE Photonics Technology Letters **9**, 1063 (1997)

OP-VECSEL = **O**ptically **P**umped **V**ertical-**E**xternal-**C**avity
Surface-**E**mitting Semiconductor **L**aser

M. Kuznetsov et al., *IEEE Photon. Technol. Lett.* **9**, 1063 (1997)



- Semiconductor gain structure with reduced thickness ($\approx 10 \mu\text{m}$)

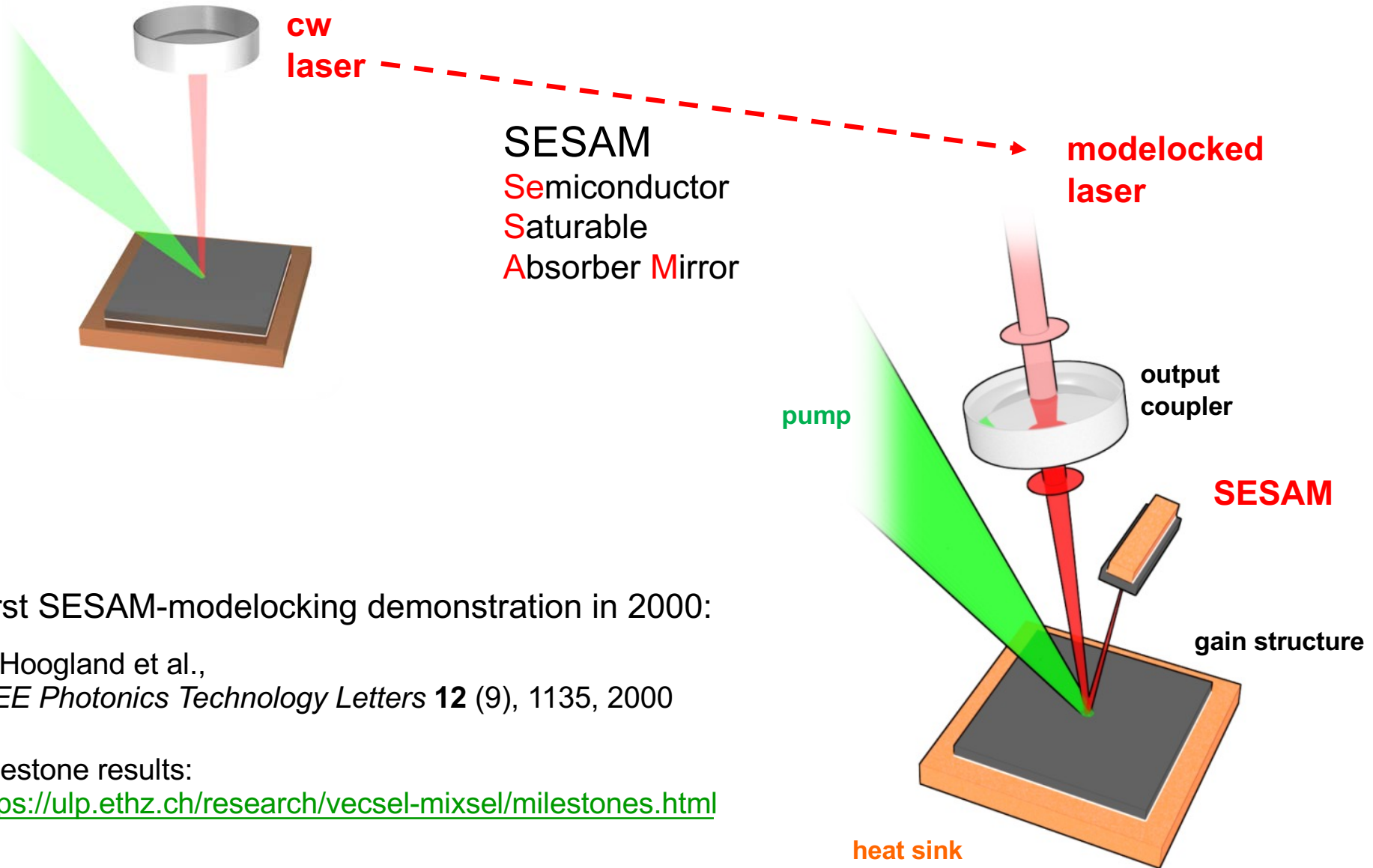


IEEE JQE 38, 1268 (2002)

- Pump: high power diode bar
- External cavity for diffraction-limited output

SDLs = semiconductor disk lasers

Ultrafast VECSELs: Modelocking with SESAMs



First SESAM-modelocking demonstration in 2000:

S. Hoogland et al.,
IEEE Photonics Technology Letters **12** (9), 1135, 2000

Milestone results:

<https://ulp.ethz.ch/research/vecsel-mixsel/milestones.html>

Review article for VECSELs: U. Keller and A. C. Tropper, *Physics Reports* **429**, Nr. 2, pp. 67-120, 2006



2015 Review: B. W. Tilma *et al.*, “Recent advances in ultrafast semiconductor disk lasers”,
Light Sci Appl **4**, e310 (2015) 3-GHz pulse repetition rate: cavity length of ≈ 5 cm

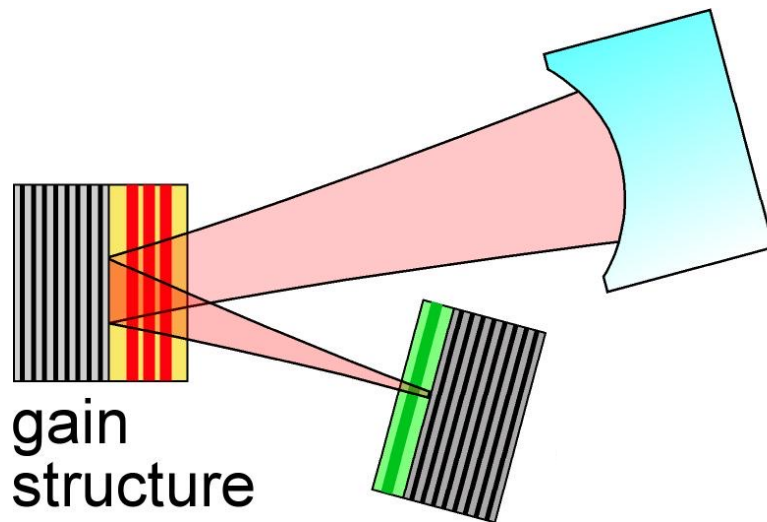
Passively modelocked VECSEL

vertical **e**xternal-**c**avity **s**urface-**e**mitting **l**aser

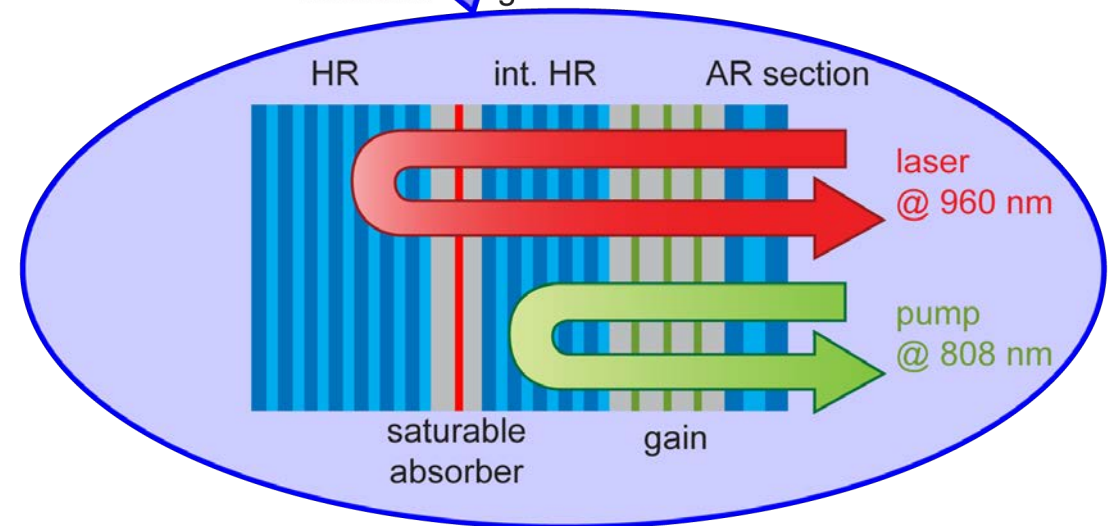
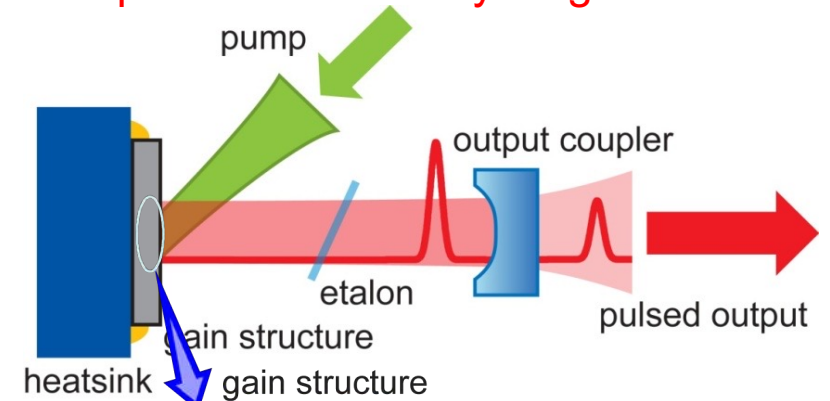
S. Hoogland *et al.*, *IEEE PTL* **12** (9), 1135, 2000

Review with Anne Tropper:

Physics Reports **429**, 67-120, 2006



SESAM

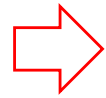


MIXSEL

modelocked **i**ntegrated **e**xternal-cavity **s**urface **e**mitting **l**aser

D. J. H. C. Maas *et al.*, *Appl. Phys. B* **88**, 493, 2007

1. **SESAM, VECSEL and MIXSEL basic device structure**



2. **Dual-comb modelocking and application demonstration**

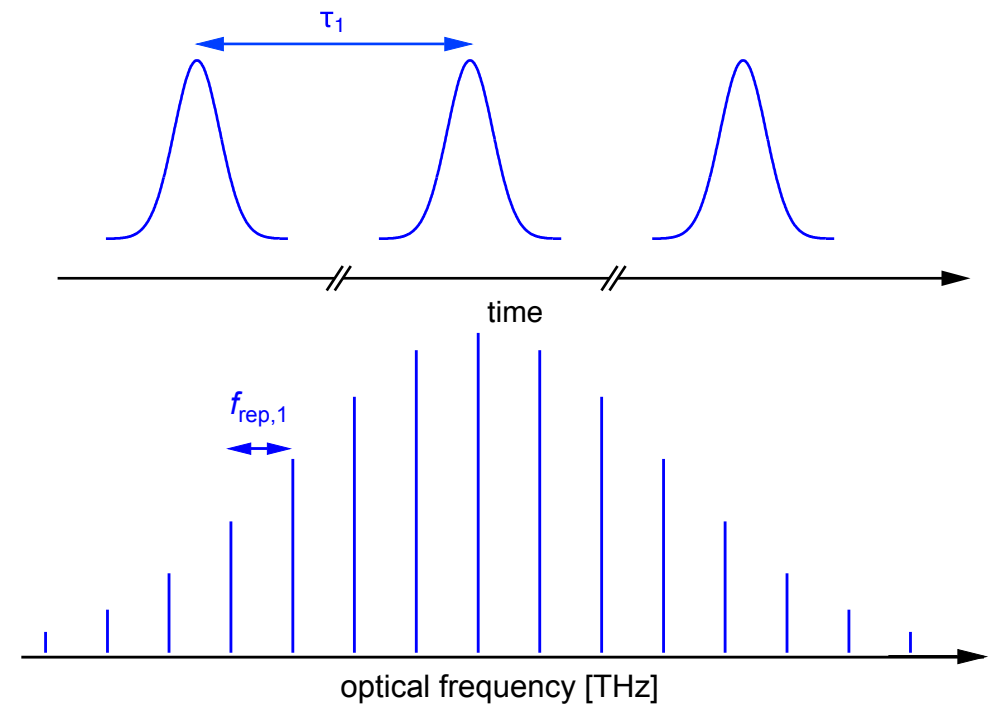
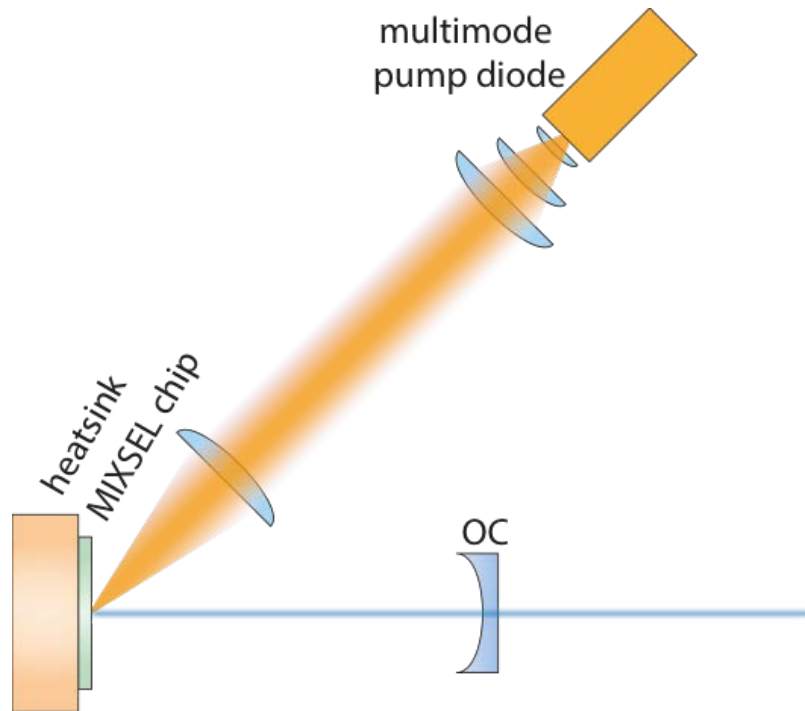
3. **III-V semiconductor material**

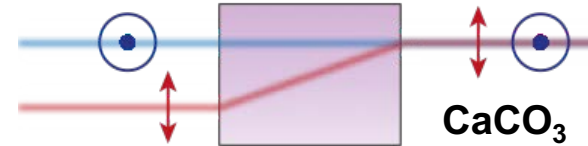
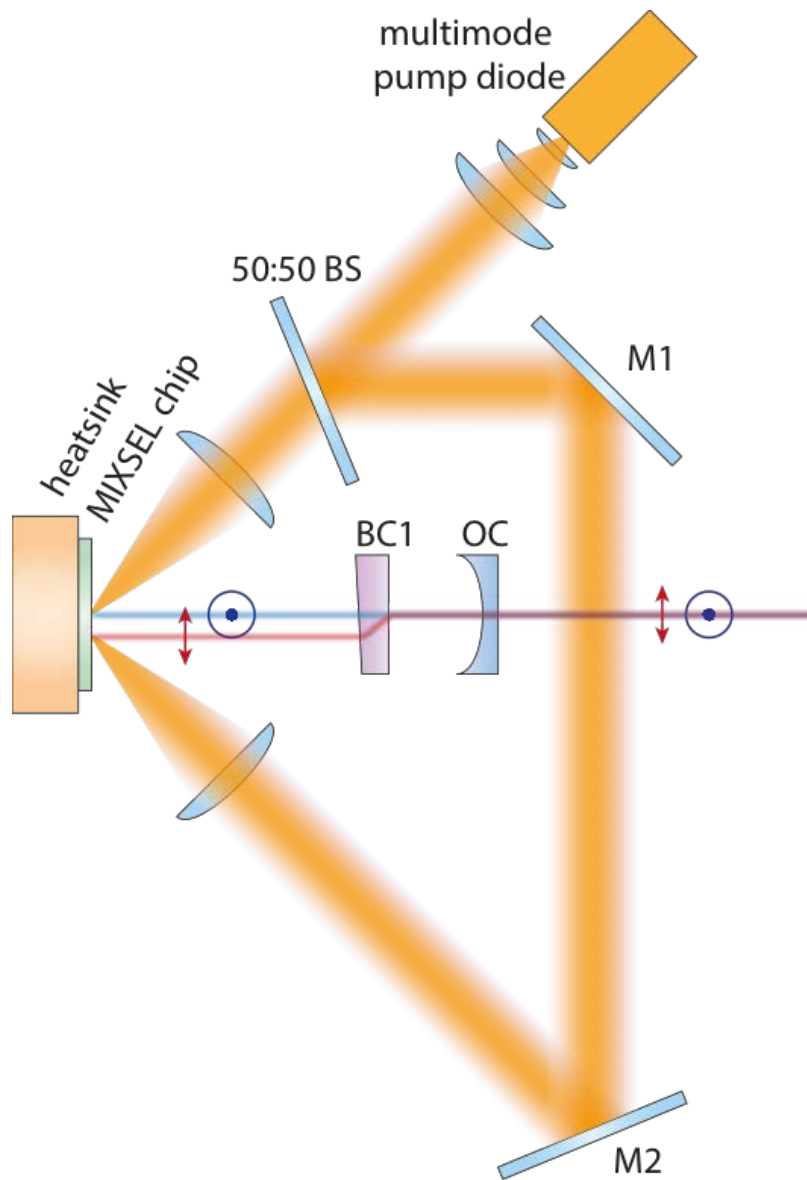
4. **MIXSEL and SESAM modelocked VECSEL**

5. **Long wavelength SESAMs ($> 2\mu\text{m}$)**

6. **Outlook**



Sandro
Link (2017)

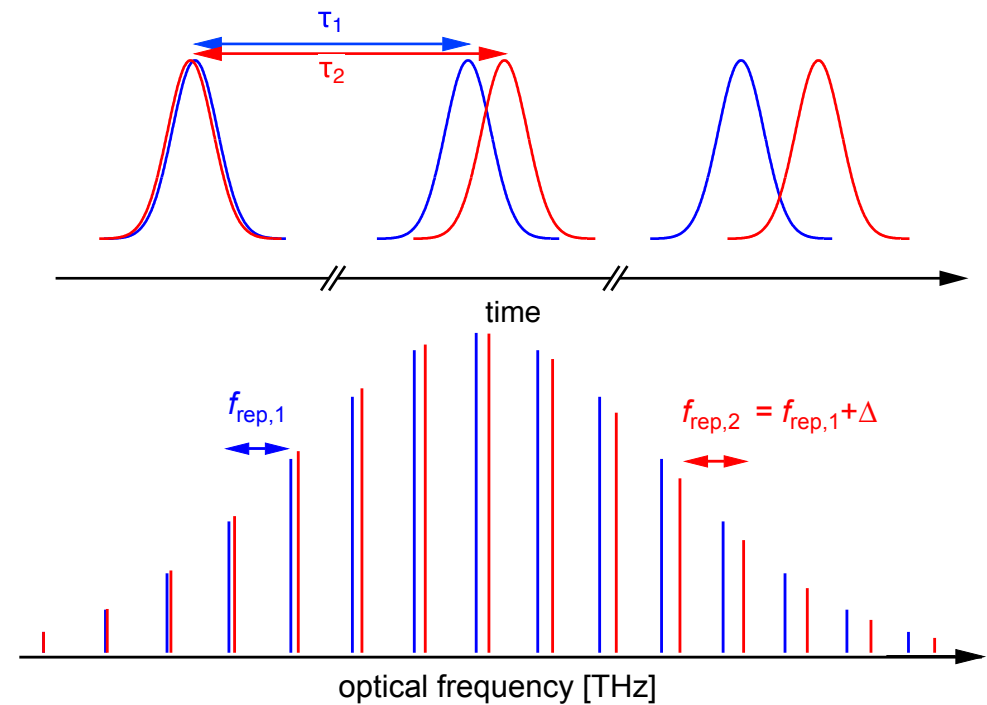


Intracavity birefringent crystal (BC)

- Two spatially separated beams
- Orthogonal polarizations
- Different optical path length

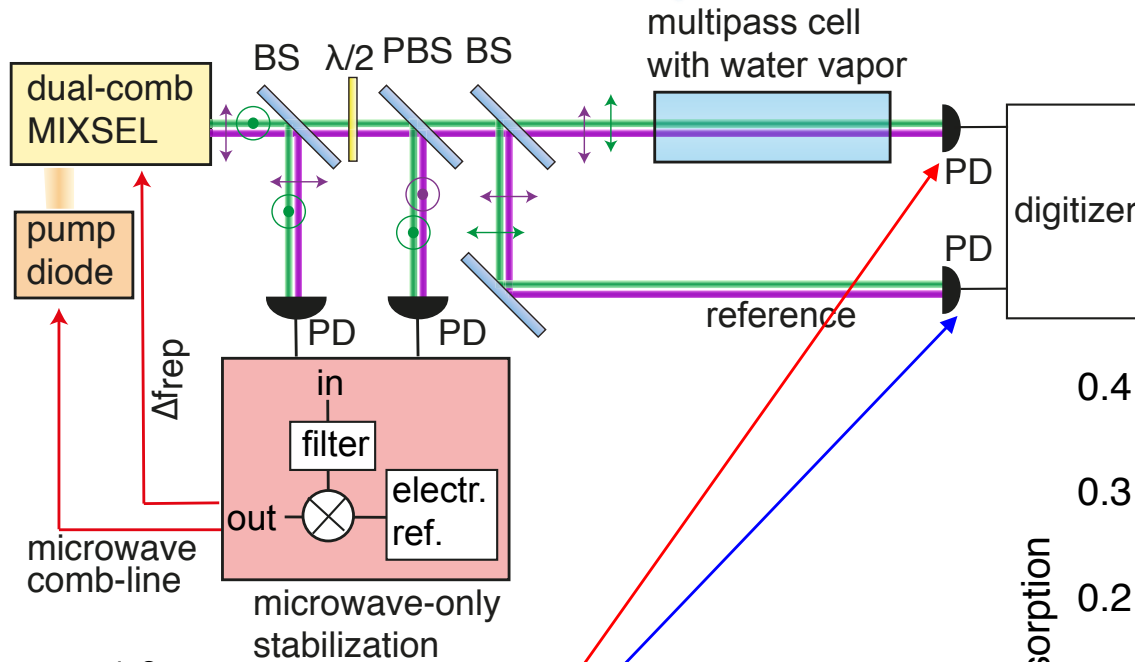


Sandro Link (2017)

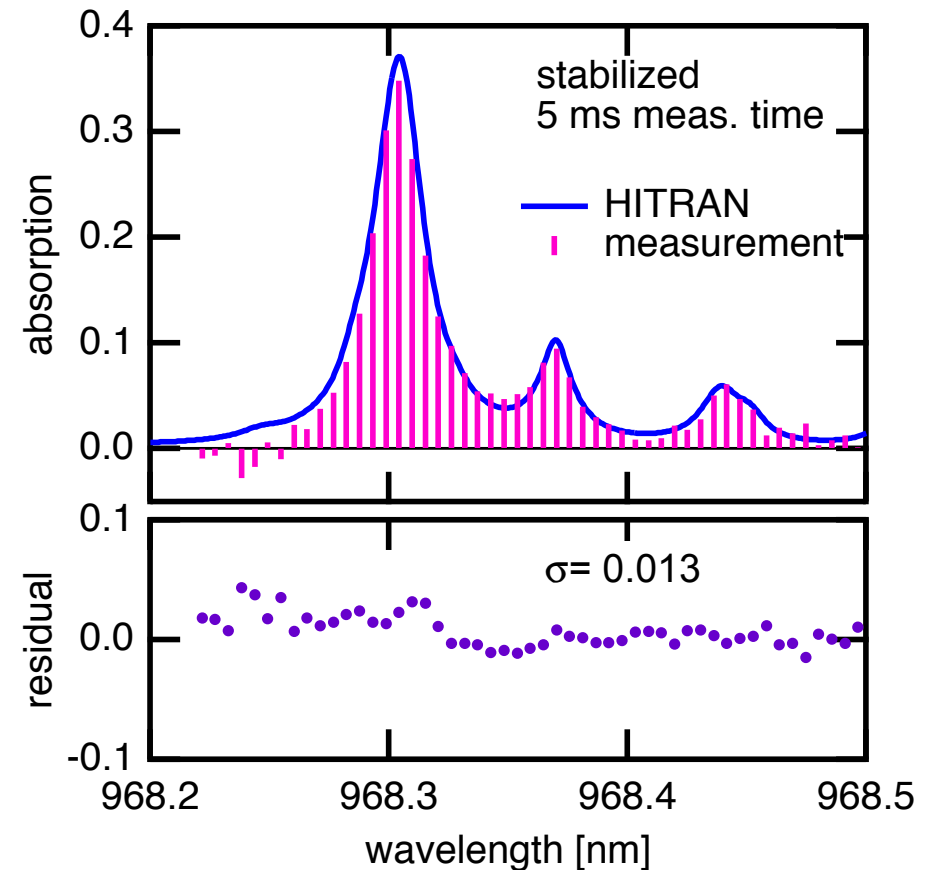
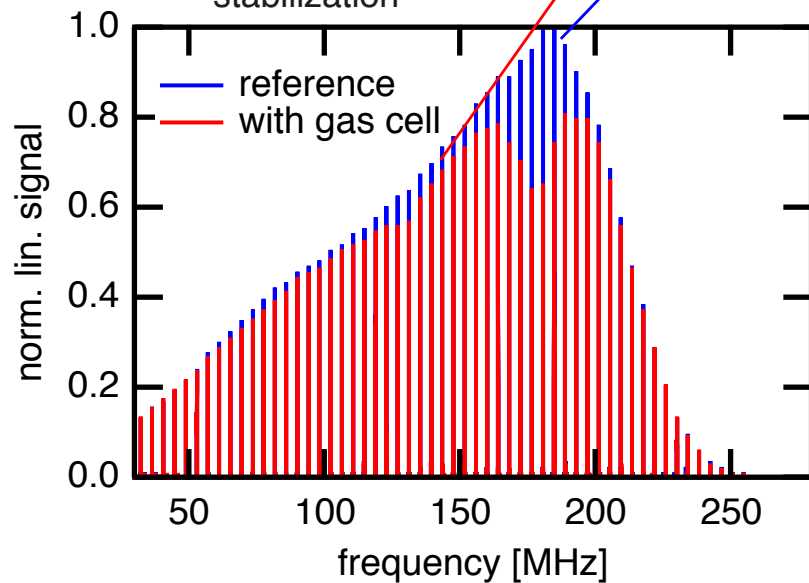


S. M. Link, A. Klenner, M. Mangold, C. A. Zaugg, M. Golling, B. W. Tilma, U. Keller, *Opt. Express* **23**, 5521 (2015).
 S. M. Link, A. Klenner, U. Keller, *Opt. Express* **24**, 1889 (2016): SESAM decouples noise stabilization

Dual-comb spectroscopy with dual-comb 968-nm MIXSEL

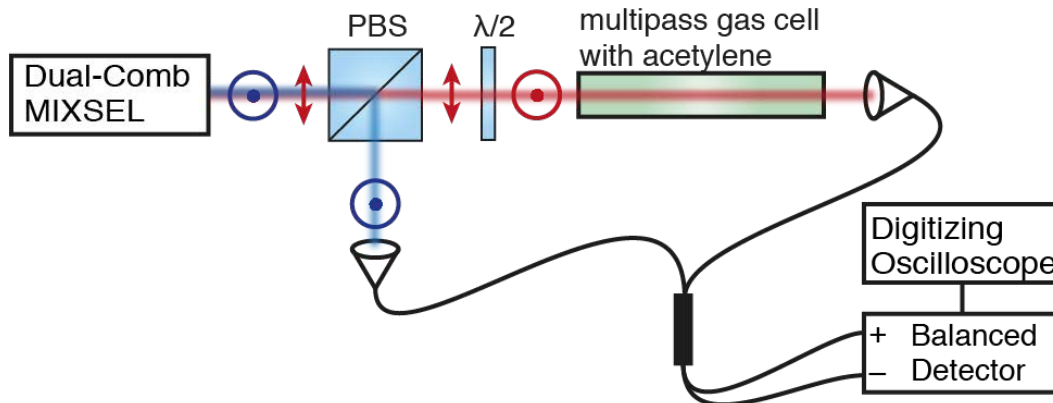


measurement with **stabilized microwave comb** of dual-comb MIXSEL!
But also with free-running laser!

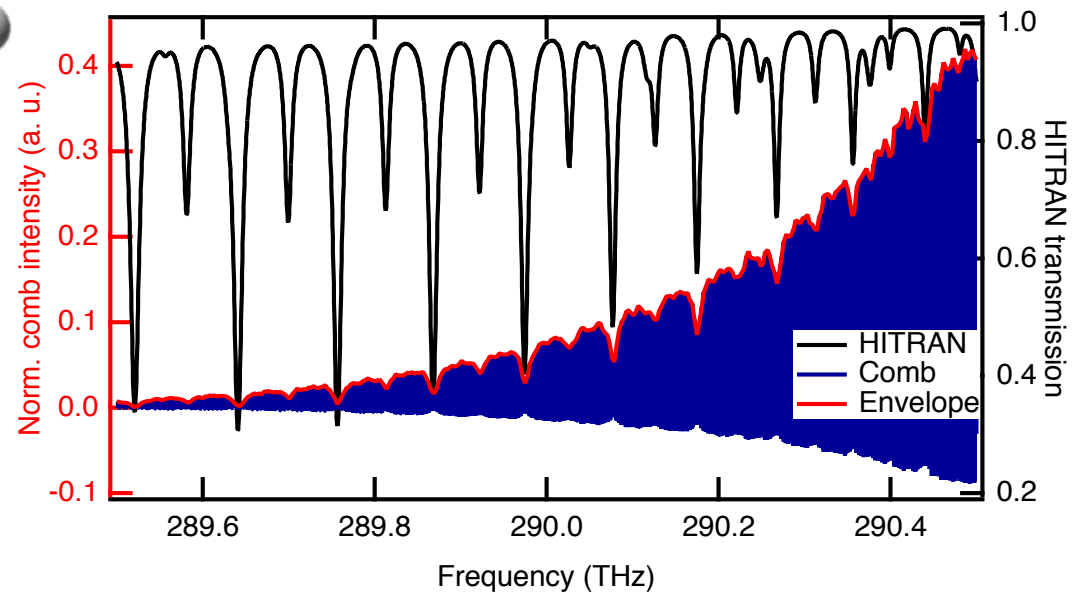
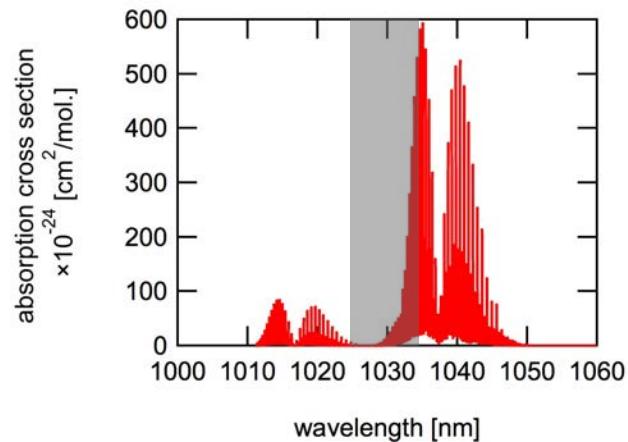


S. M. Link, D. J. H. C. Maas, D. Waldburger, U. Keller, "Dual-comb spectroscopy of water vapor with a free-running semiconductor disk laser", *Science* 356, 1164-1168 (16 Jun 2017)

Dual-comb spectroscopy with dual-comb 1.03- μm MIXSEL



Dual-comb spectroscopy of acetylene C_2H_2



- Acetylene absorption lines (HITRAN 2016)
- Weak absorption in the near IR
- MIXSEL spectrum not perfectly matched

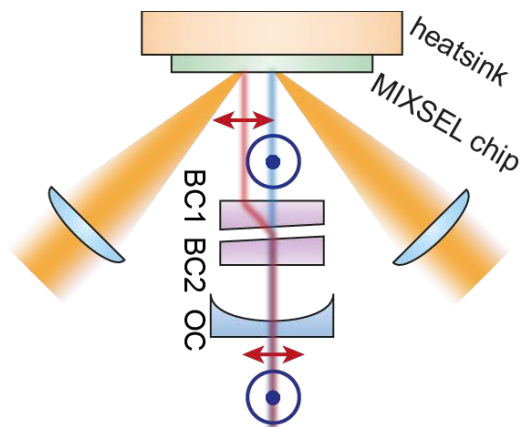
- Absorption in commercial fiber coupled multipass gas cell*
*Manufacturer: Wavelength References
- 740 Torr pressure of acetylene (C_2H_2)
- 80 cm absorption path length



Jacob Nürnberg
(2020)

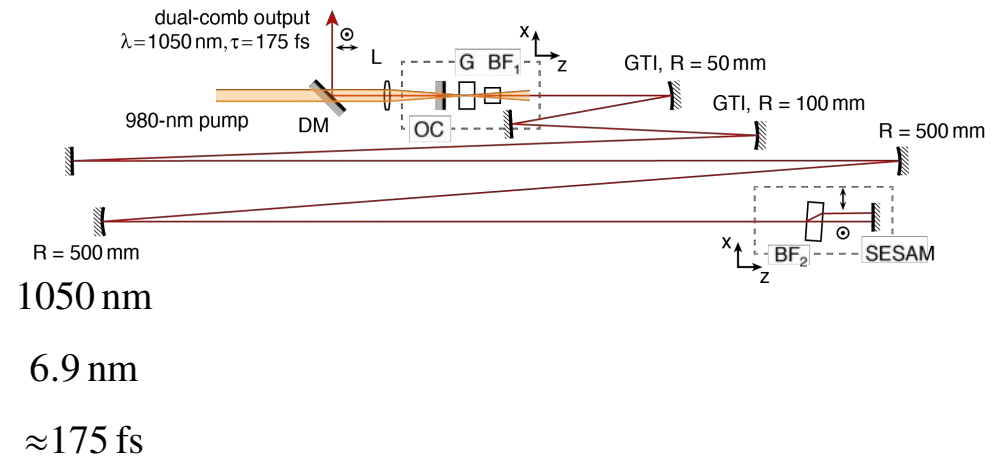
J. Nürnberg*, C. G. E. Alfieri*, Z. Chen, D. Waldburger, N. Picqué, U. Keller, *Optics Express* **27**, 3190 (2019)





1028 nm

3 nm

 ≈ 390 fs

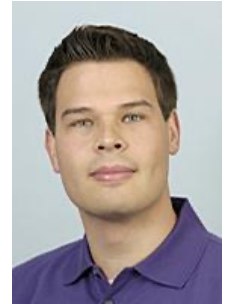
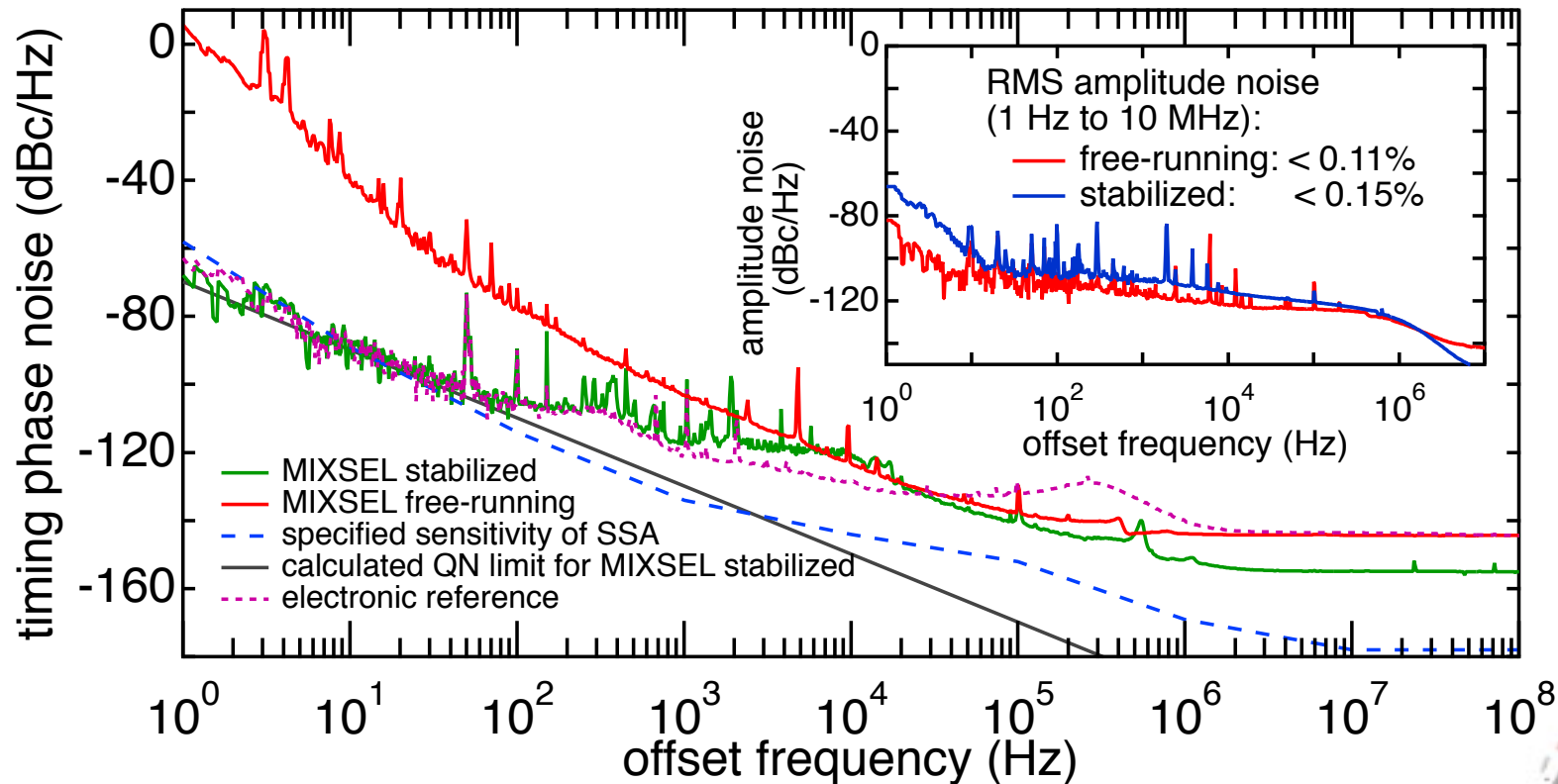
R = 500 mm

1050 nm

6.9 nm

 ≈ 175 fs

	Dual-comb MIXSEL	Dual-comb Yb:CaF ₂
Update rate (= Δf_{rep})	51 kHz	952 Hz
Ambiguity range (f_{rep})	55 mm (2.7 GHz)	≈ 1 m (136.5 MHz)
Precision	1.4 μm	0.5 μm
Theoretical ext. ambiguity range	2.8 km	157 km
Application	Short range but fast	Long range but slower
	Industrial and manufacturing	Satellite and spacecraft links



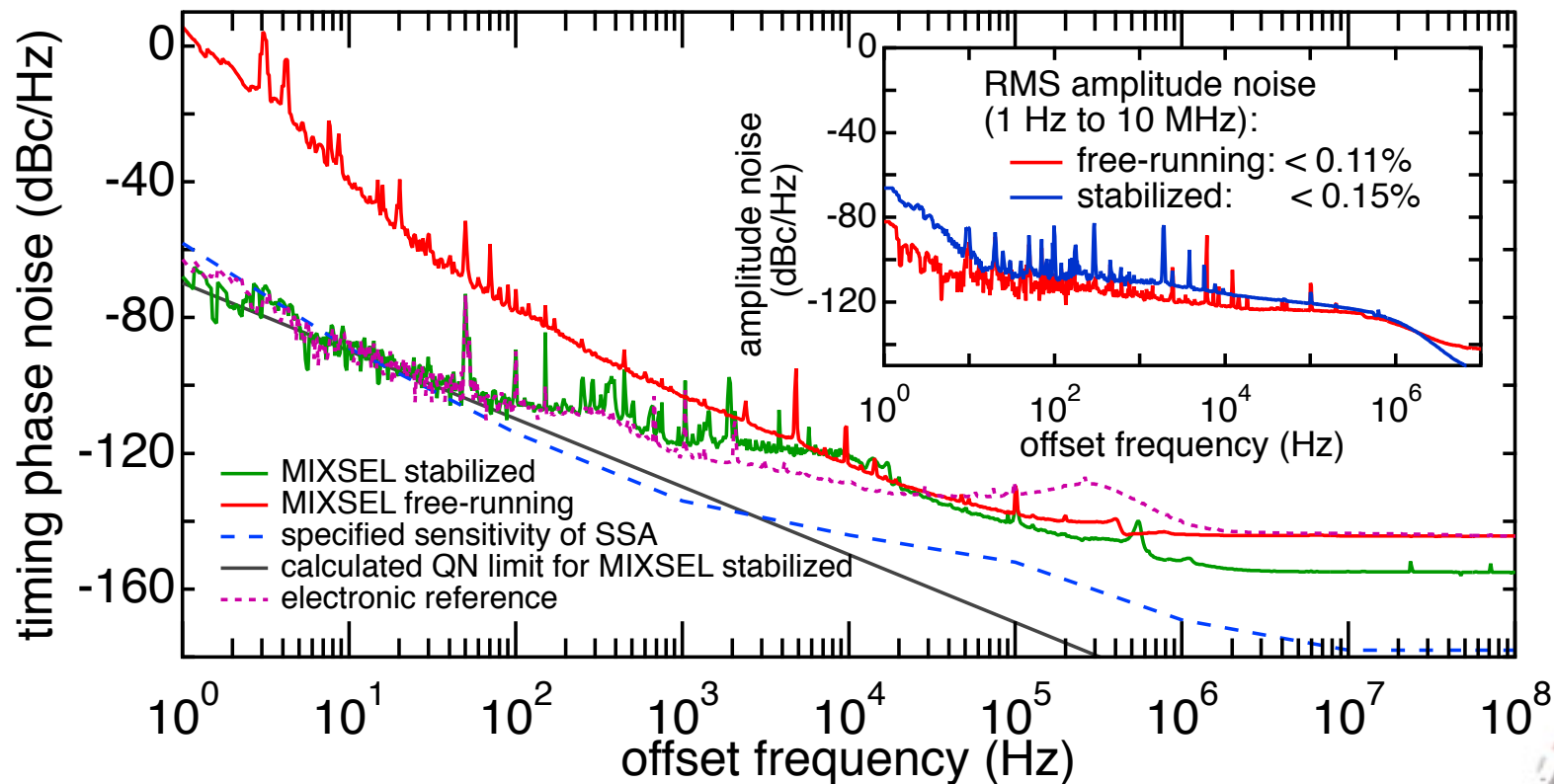
Mario
Mangold (2015)

MIXSEL: >645 mW output power, 14.3 ps pulses, 2 GHz pulse replate

- **127 fs** timing jitter – free-running [100 Hz, 100 MHz]
- **31 fs** timing jitter – stabilized [100 Hz, 100 MHz]
- **< 0.15%** amplitude noise [1 Hz, 10 MHz]



M. Mangold, S. M. Link, A. Klenner, C. A. Zaugg, M. Golling, B. W. Tilma, U. Keller,
IEEE Photonics Journal **6**, 1500309 (2014)



Mario
Mangold (2015)

MIXSEL: >645 mW output power, 14.3 ps pulses, 2 GHz pulse rate

- **127 fs** timing jitter – **free-running integrated over [100 Hz, 100 MHz]**
- Pulse repetition rate 2 GHz \rightarrow 0.5 ns between the pulses = $1 / (2 \text{ GHz})$
- $127 \text{ fs} / 0.5 \text{ ns} \approx 2.5 \cdot 10^{-4}$ **comb line spacing variations, integrated over $1 / (100 \text{ Hz}) = 10 \text{ ms}$!**



M. Mangold, S. M. Link, A. Klenner, C. A. Zaugg, M. Golling, B. W. Tilma, U. Keller,
IEEE Photonics Journal **6**, 1500309 (2014)

Optics Express **27**, 1786 (2019)

Tightly locked optical frequency comb from a semiconductor disk laser

D. WALDBURGER,^{1,*} A. S. MAYER,¹ C. G. E. ALFIERI,¹ J. NÜRNBERG,¹ A. R. JOHNSON,² X. JI,³ A. KLENNER,² Y. OKAWACHI,² M. LIPSON,³ A. L. GAETA,² AND U. KELLER¹

¹Department of Physics, Institute for Quantum Electronics, ETH Zurich, Auguste-Piccard-Hof 1, 8093 Zürich, Switzerland

²Department of Applied Physics and Applied Mathematics, Columbia University, New York, New York 10027, USA

³Department of Electrical Engineering, Columbia University, New York, New York 10027, USA

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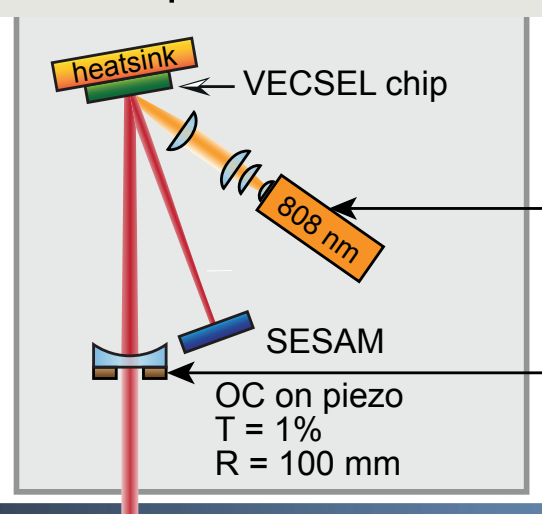


Dominik Waldburger (2018)

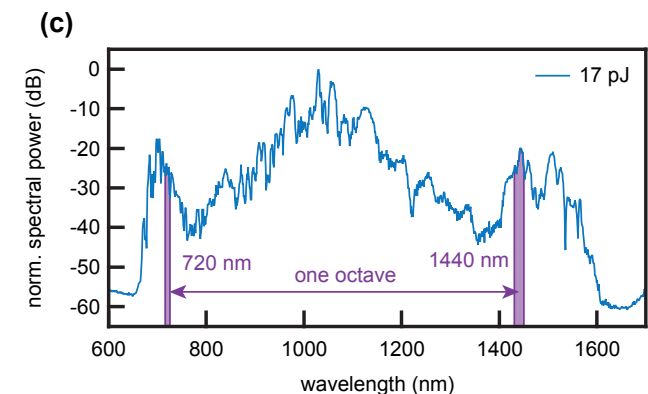
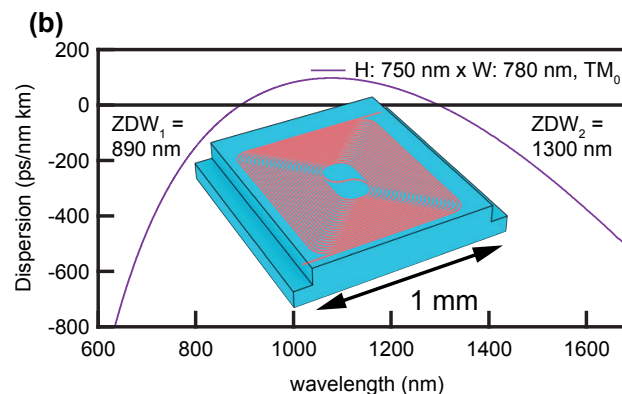



Aline Mayer (2018)

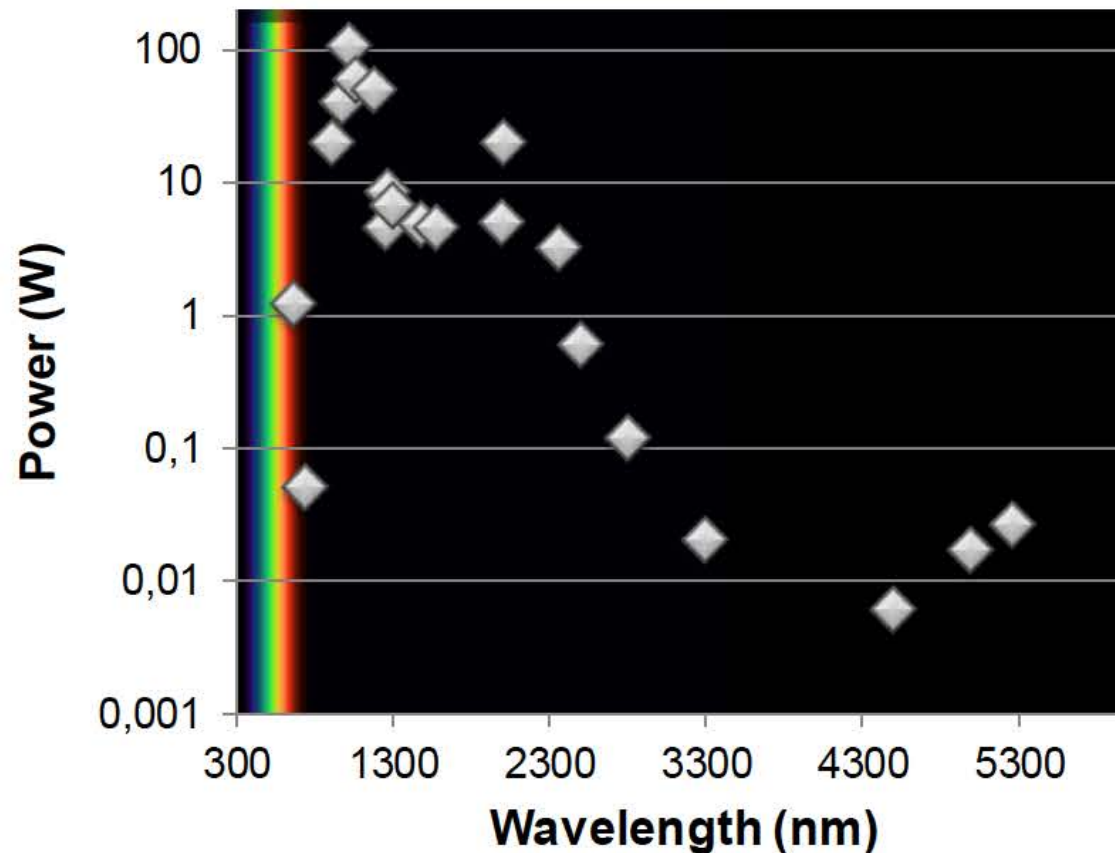
122-fs pulses & 160-mW



No additional amplification and pulse compression with Silicon nitride waveguide



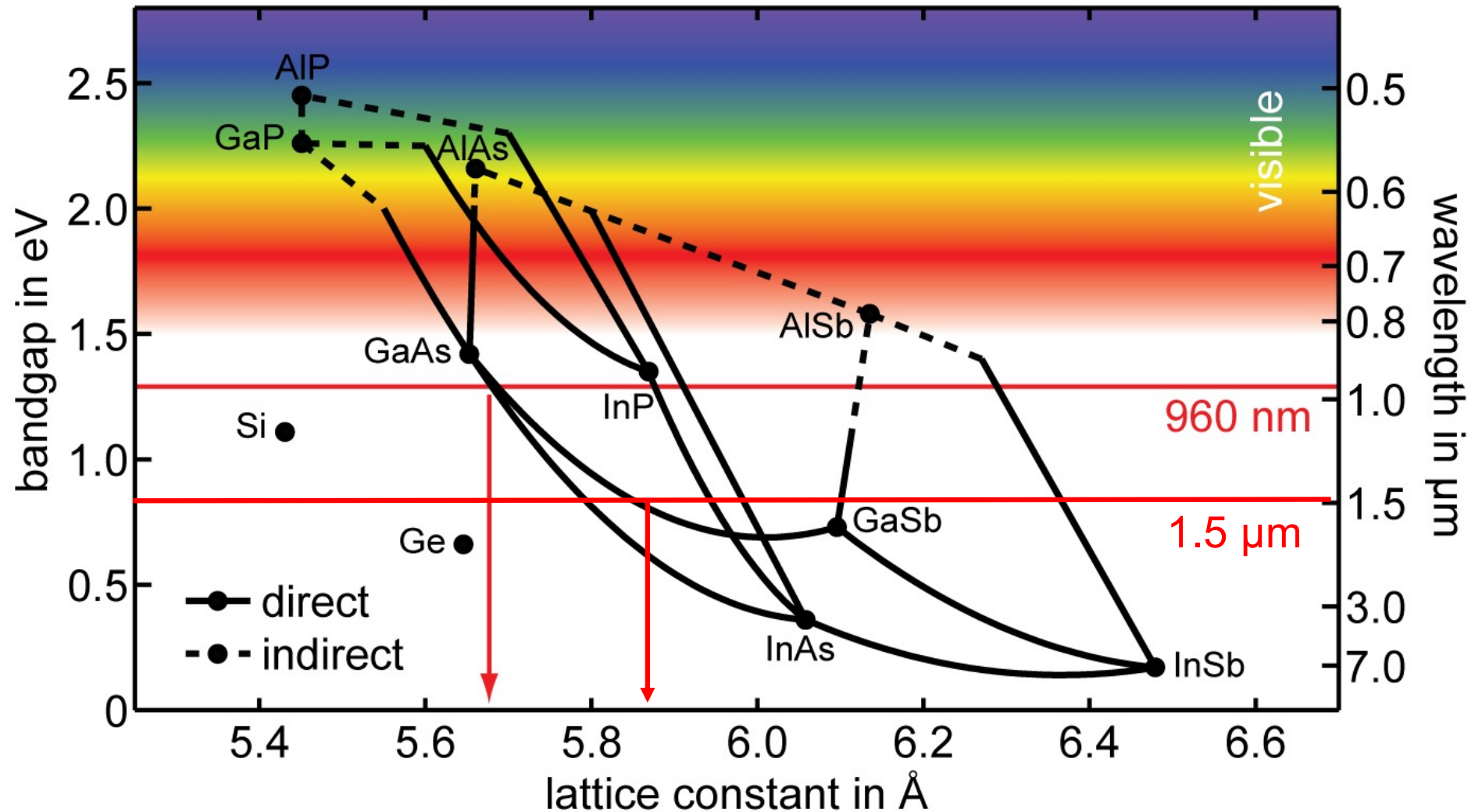
1. **SESAM, VECSEL and MIXSEL basic device structure**
2. **Dual-comb modelocking and application demonstration**
-  **3. III-V semiconductor material**
4. **MIXSEL and SESAM modelocked VECSEL**
5. **Long wavelength SESAMs ($> 2\mu\text{m}$)**
6. **Outlook**



- 2-2.8 μm – GaInAsSb / AlGaAsSb
- 1.5 μm – InGaAs / InGaAsP
- **1.2-1.5 μm – AlGaInAs / InP (fused)**
- 1.2-1.3 μm – GaInNAs / GaAs
- 1-1.3 μm – InAs QDs
- **0.9-1.18 μm – InGaAs / GaAs**
- 850-870 nm – GaAs / AlGaAs
- 700-750 nm – InP QDs
- 640-690 nm – InGaP / AlGaInP
- **Frequency-doubled** VECSELS have been reported throughout the visible and into the UV

M. Guina et al., “Optically pumped VECSELS: review of technology and progress”
J. Phys. D: Appl. Phys. **50**, 383001 (2017)

SDLs = semiconductor disk lasers



- GaAs/AlAs Distributed Bragg Reflectors (DBR) with near-perfect lattice match
- Low-temperature (LT) MBE grown for faster absorbers and strain-relaxed structures
- LT InGaAs SESAMs used up to 1.5 μm

Self-starting and self-Q-switching dynamics of passively mode-locked Nd:YLF and Nd:YAG lasers

U. Keller, T. H. Chiu, and J. F. Ferguson

AT&T Bell Laboratories, Crawfords Corner Road, Holmdel, New Jersey 07733

Received August 12, 1992

The semiconductor antiresonant Fabry-Perot saturable absorber (A-FPSA) has a bitemporal absorption response with a slow time component that is due to carrier recombination and a fast time component that is due to intraband thermalization. We demonstrate that the slow component provides the self-starting mechanism and without significant Kerr lens contribution the fast component is necessary for steady-state pulse formation in passively cw mode-locked solid-state lasers. The carrier lifetime of the bitemporal A-FPSA was varied by the molecular-beam-epitaxy growth temperature to characterize its switching dynamics of cw mode-locked Nd:YLF and Nd:YAG lasers. The reflector of the A-FPSA can be adjusted to optimize the self-starting performance of cw mode-locked solid-state lasers.

Adjustable parameter:
absorber recovery time

More on [LT MBE growth](#) and [ion implantation](#) to reduce recovery time of SESAMs:

Appl. Phys. Lett., vol. 74, 3134-3136, 1999

Appl. Phys. Lett., vol. 74, pp. 1269-1271, 1999

Physica B: Condensed Matter, vol. 273-274, pp. 733-736, 1999

Appl. Phys. Lett., vol. 75, pp. 1437-1439, 1999

Appl. Phys. Lett., vol. 74, pp. 1993-1995, 1999

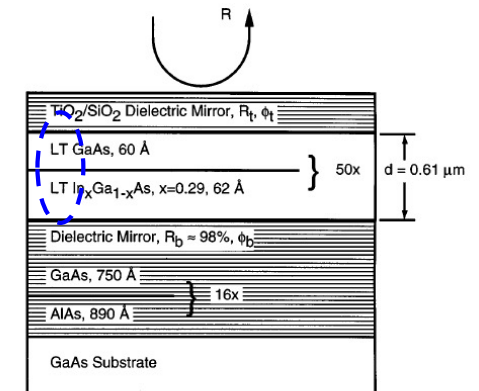
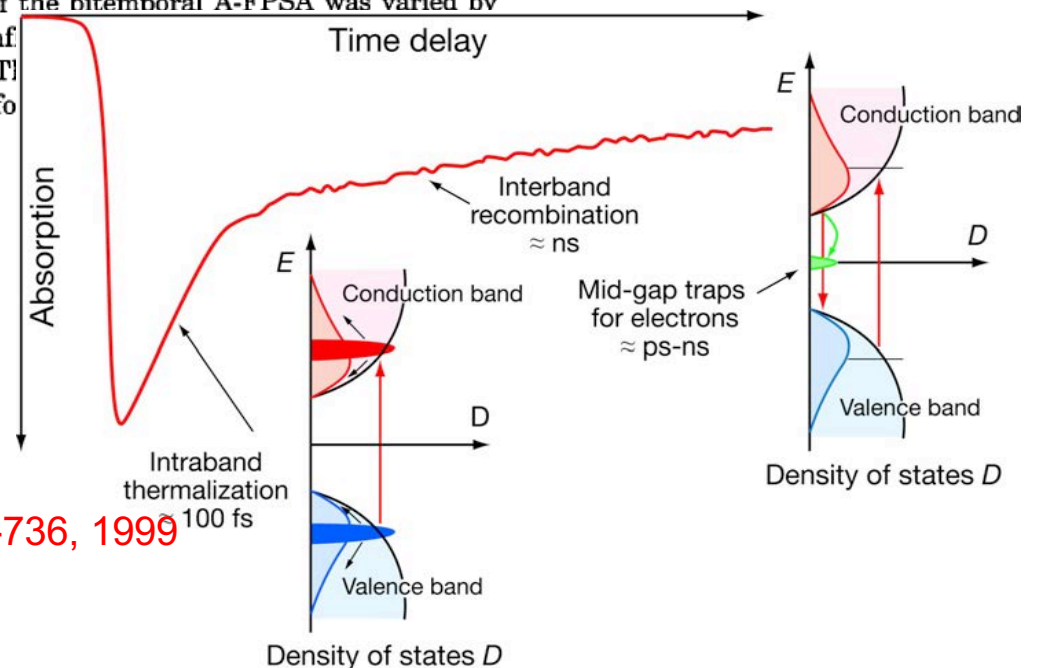
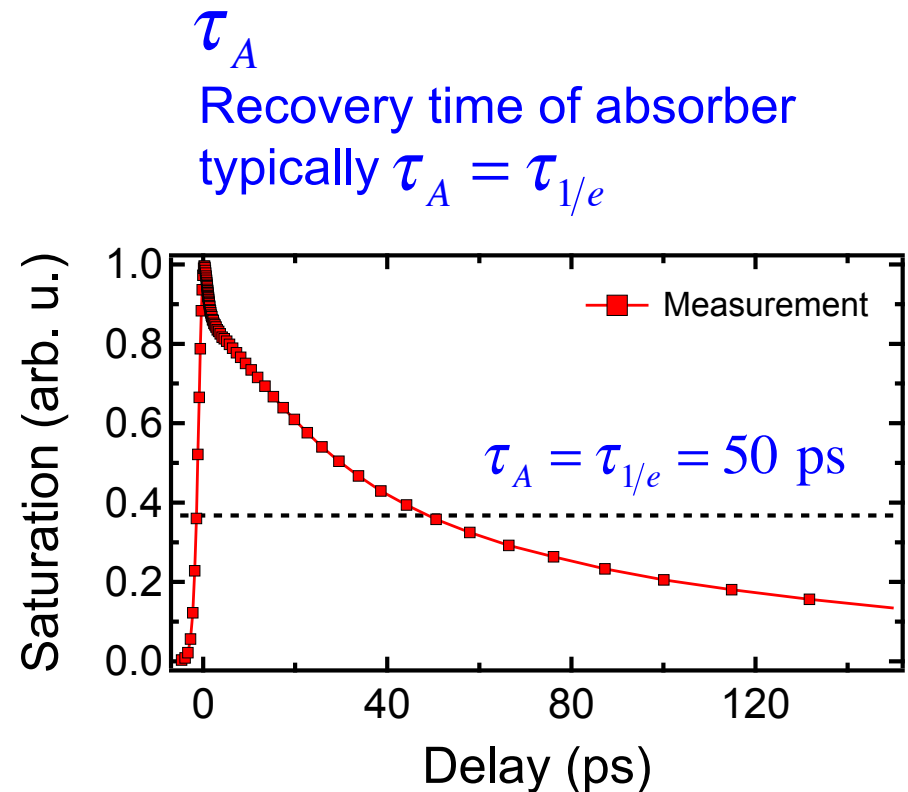
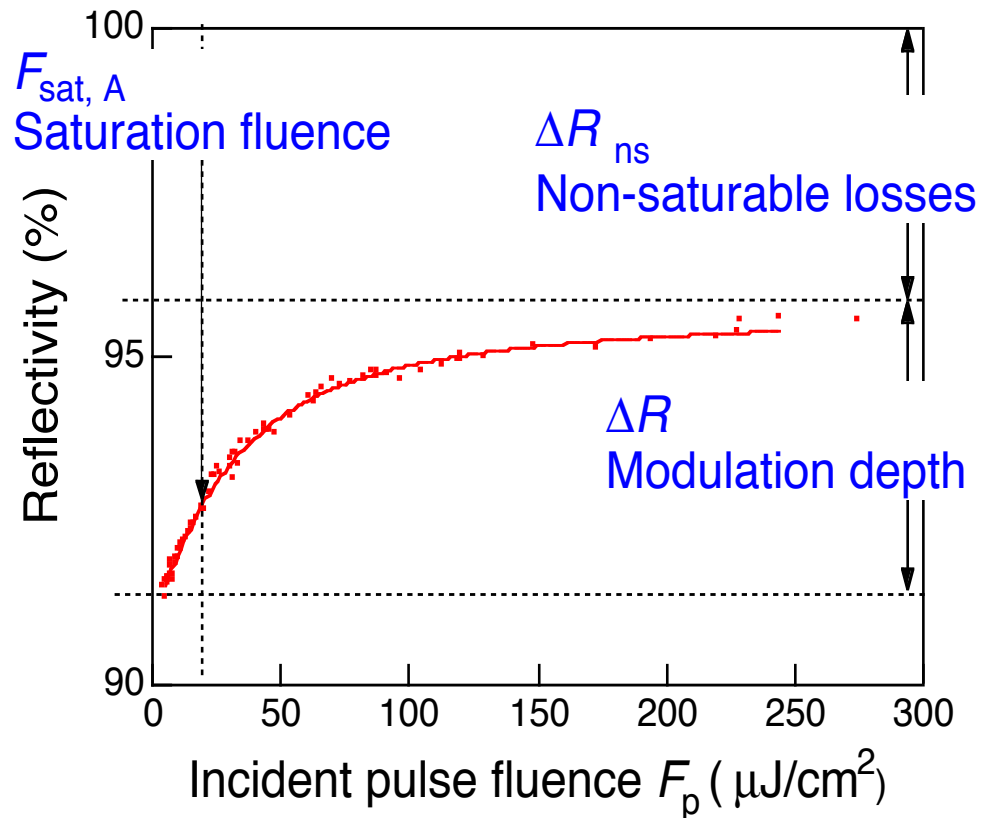


Fig. 1. Structure of an A-FPSA designed for an operation wavelength of $\approx 1 \mu\text{m}$.





Guidelines how to measure these parameters:

M. Haiml, R. Grange, U. Keller, *Appl. Phys. B* **79**, 331, 2004

with improved accuracy: D. J. H. Maas, et al., *Optics Express* **16**, 7571, 2008

Recovery time: how short?

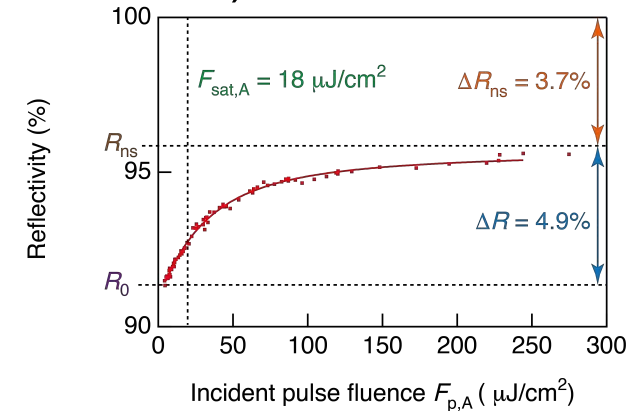
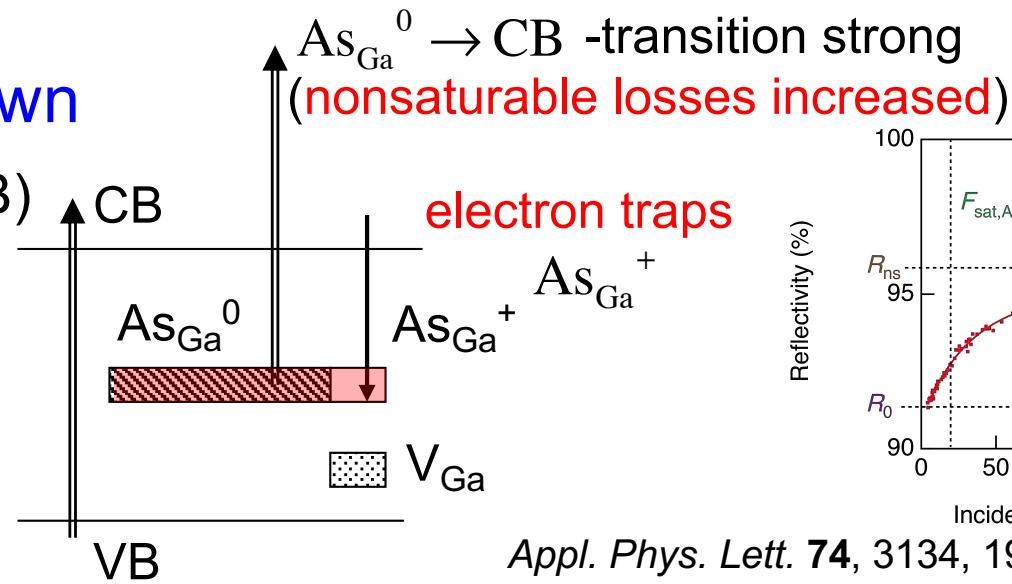
Depends on laser parameter. Soliton modelocking helps.

(a) LT GaAs: as grown

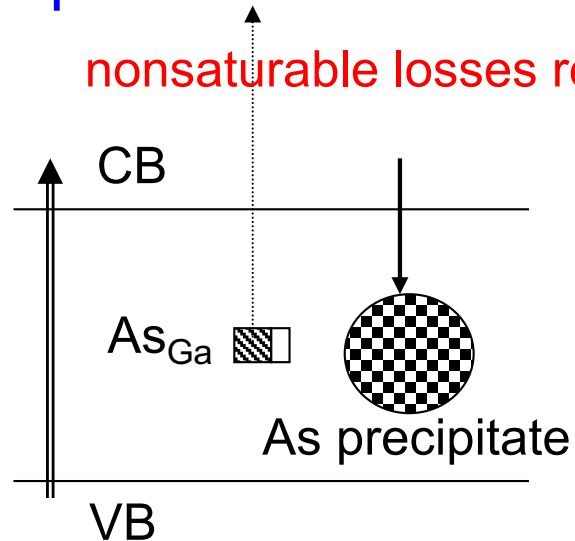
Conduction band (CB)

mid-gap defects:
As antisites

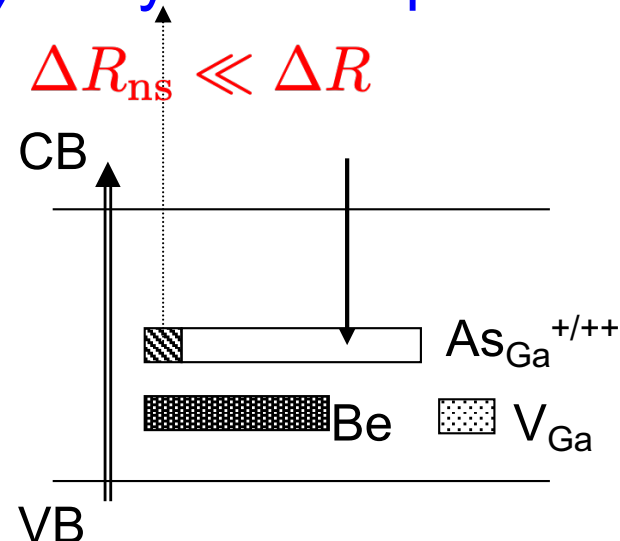
Valence band (VB)

*Appl. Phys. Lett.* **74**, 3134, 1999*Appl. Phys. Lett.* **74** 1269, 1999*Physica B: Condensed Matter* **273-274**, 733, 1999

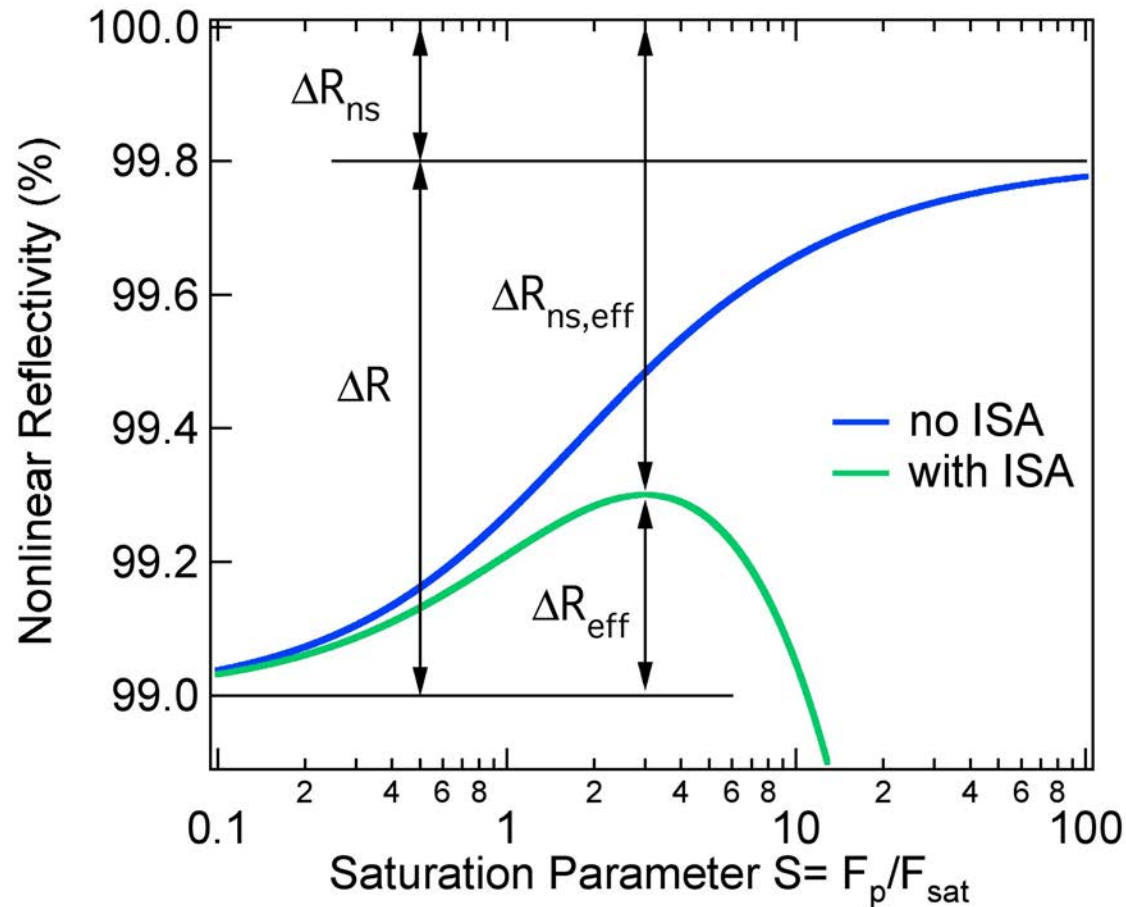
(b) Undoped annealed



(c) Beryllium doped as grown



SESAM reflectivity for a pulse fluence F_p



Reflectivity decreases
with shorter pulses:
two photon absorption



the roll-over =
inverse saturable absorption

$$R_{ISA}(F_p) = R_P(F_p) - \frac{F_p}{F_2}$$

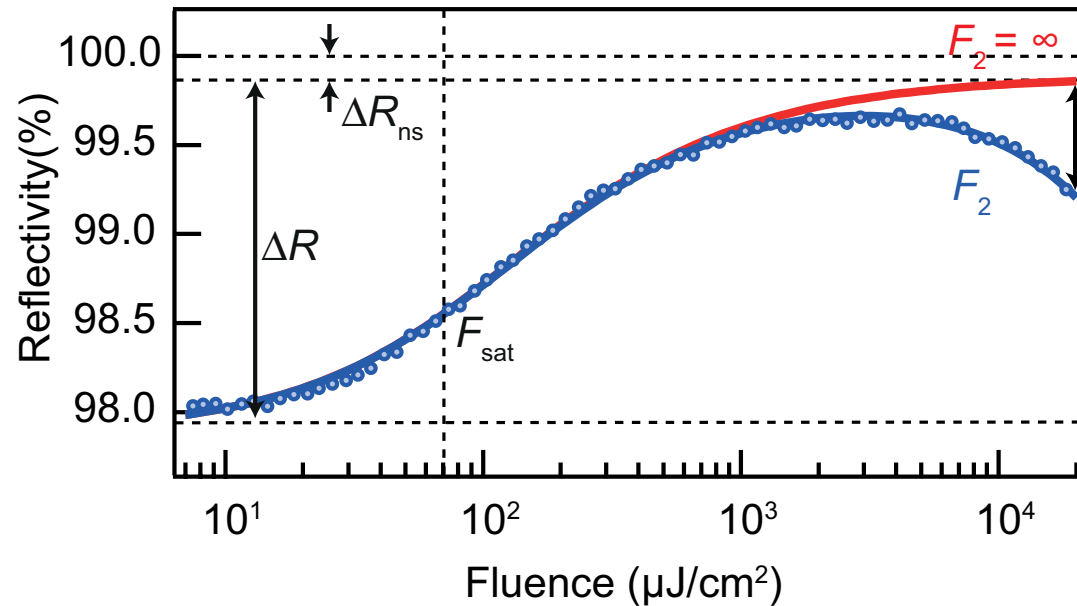
- F_2 is the inverse slope of the roll over
- The smaller F_2 , the stronger is the roll-over

Fluence on absorber at maximum reflectivity and damage:

$$F_0 \approx \sqrt{\Delta R \cdot F_{sat,A} \cdot F_2}$$

$$F_d \propto \sqrt{F_2}$$

SESAM reflectivity for a pulse fluence F_p



Reflectivity decreases
with shorter pulses:
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$$R_{ISA}(F_p) = R_P(F_p) - \frac{F_p}{F_2}$$

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Fluence on absorber at maximum reflectivity and damage:

$$F_0 \approx \sqrt{\Delta R \cdot F_{sat,A} \cdot F_2}$$

$$F_d \propto \sqrt{F_2}$$

Strain compensation for InGaAs SESAM & MIXSEL

Two-photon absorption (TPA) losses $\propto \frac{\beta_{TPA}}{\tau_{pulse}}$



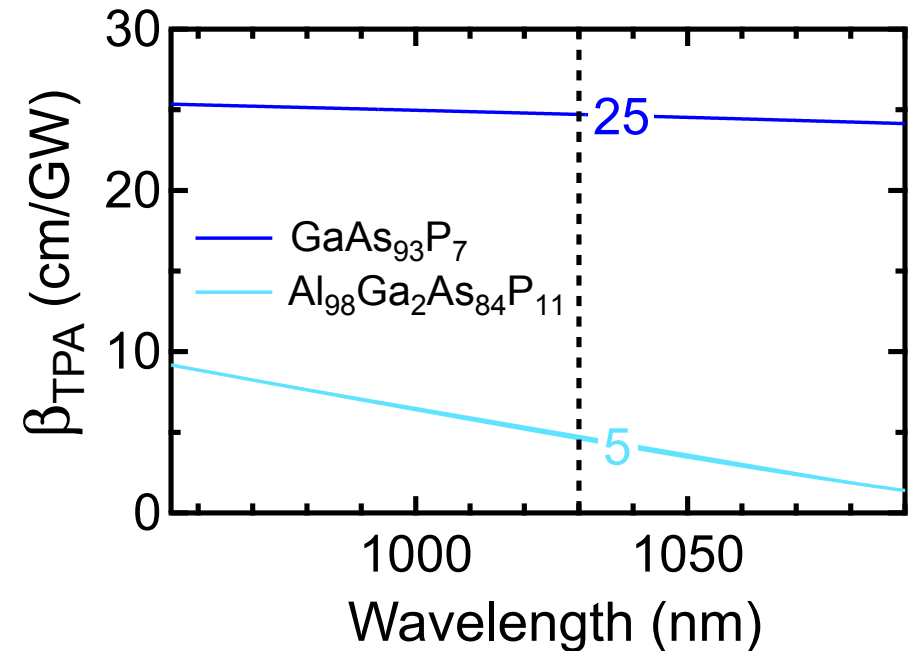
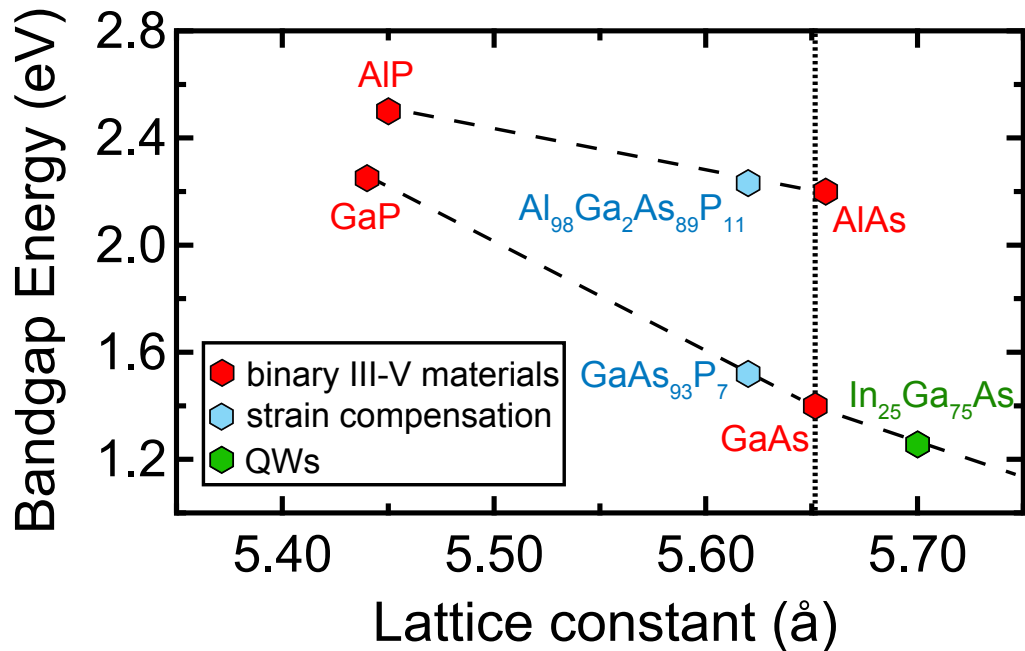
Dominik Waldburger (2018)



Cesare Alfieri (2018)

Large-bandgap AlAsP for strain-compensation for InGaAs SESAMs and MIXSELS:
For example allowed for 139-fs MIXSEL

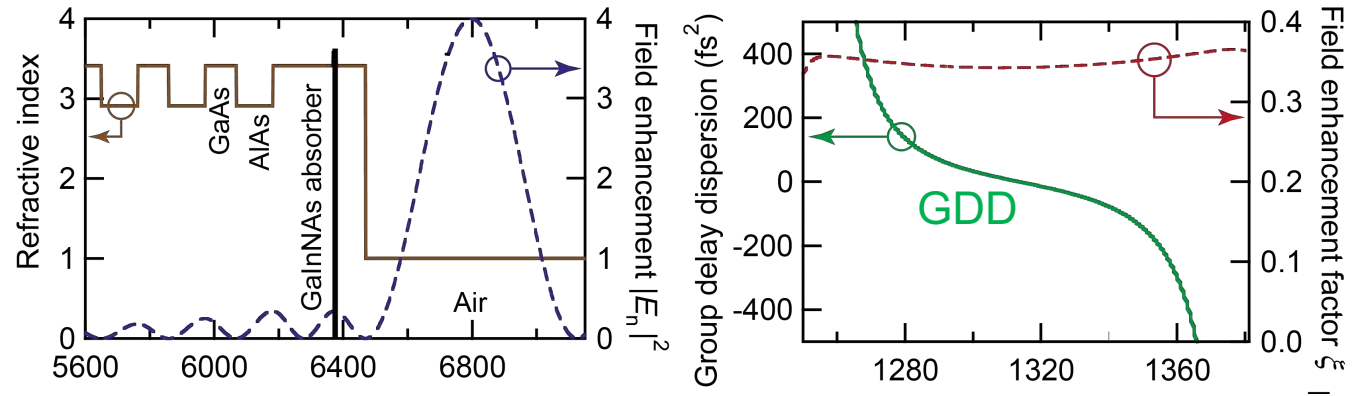
C. G. E. Alfieri*, D. Waldburger*, J. Nürnberg, M. Golling, U. Keller, "Sub-150-fs from a broadband MIXSEL", *Opt. Letters* **44**, 25 (2019)



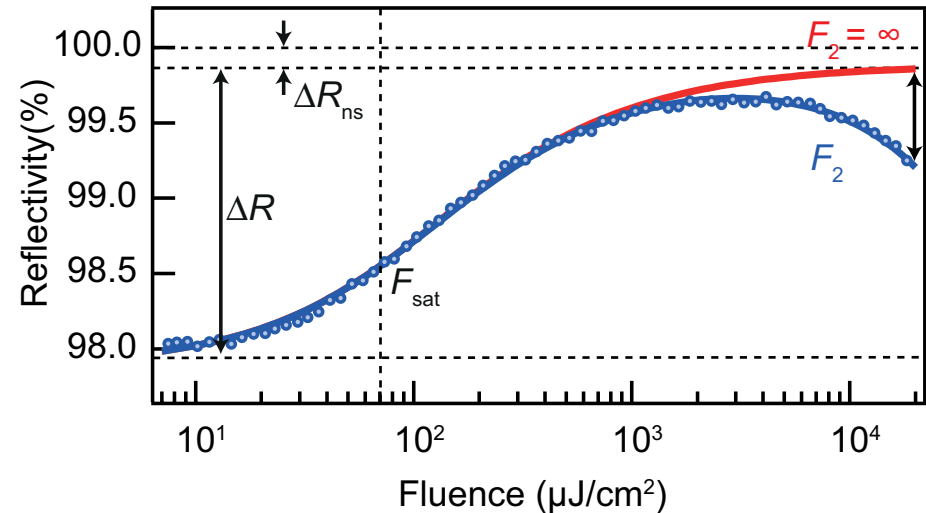
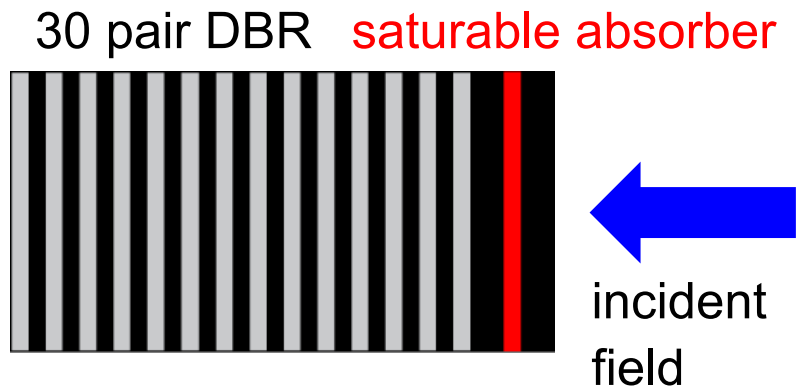
C. G. E. Alfieri, A. Diebold, F. Emaury, E. Gini, C. J. Saraceno, U. Keller. *Opt. Express* **24**, 27587-27599 (2016)

Antiresonant versus Resonant

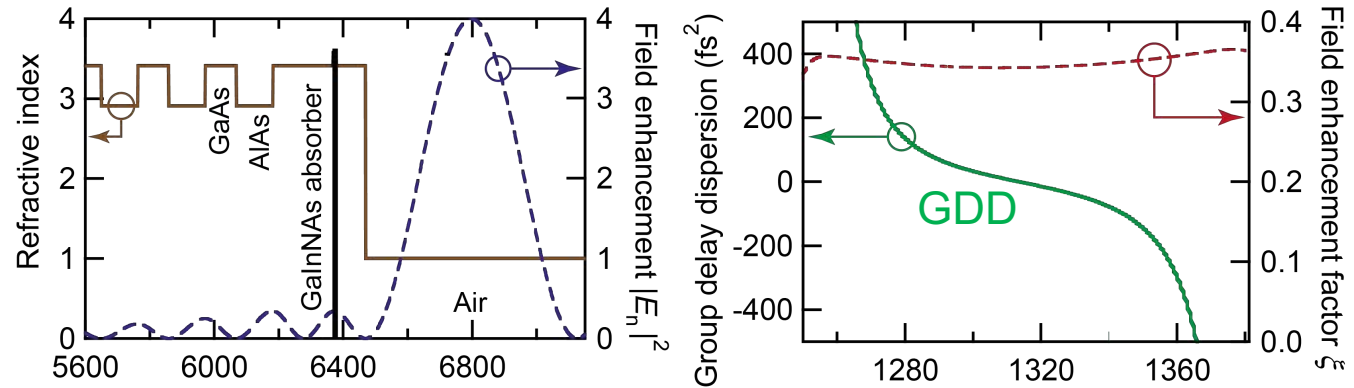
antiresonant
SESAM



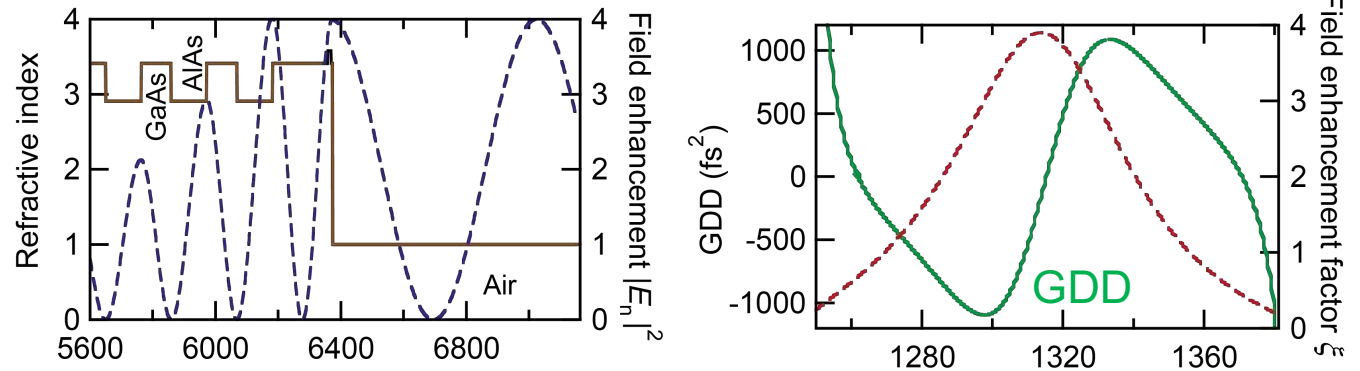
Very often need low saturation fluence F_{sat}



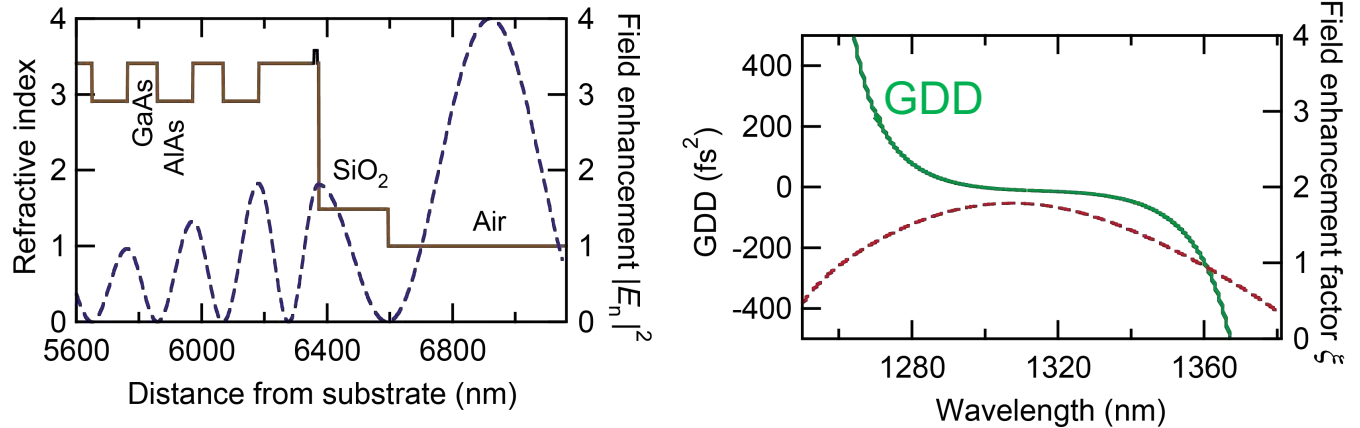
antiresonant
SESAM



resonant
SESAM



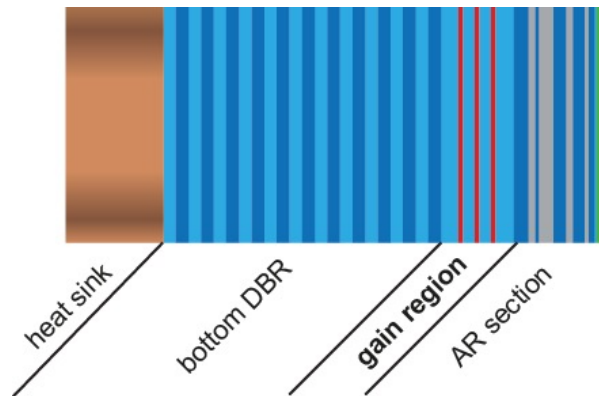
“optimized” SESAM
for low saturation fluence



1. **SESAM, VECSEL and MIXSEL basic device structure**
2. **Dual-comb modelocking and application demonstration**
3. **III-V semiconductor material**
- ➔ 4. **MIXSEL and SESAM modelocked VECSEL**
5. **Long wavelength SESAMs ($> 2\mu\text{m}$)**
6. **Outlook**

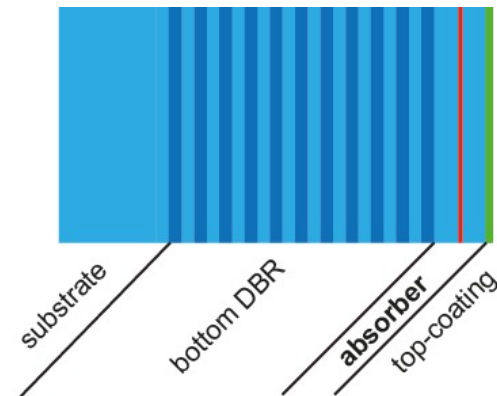
3-GHz pulse repetition rate: cavity length of ≈ 5 cm

VECSEL



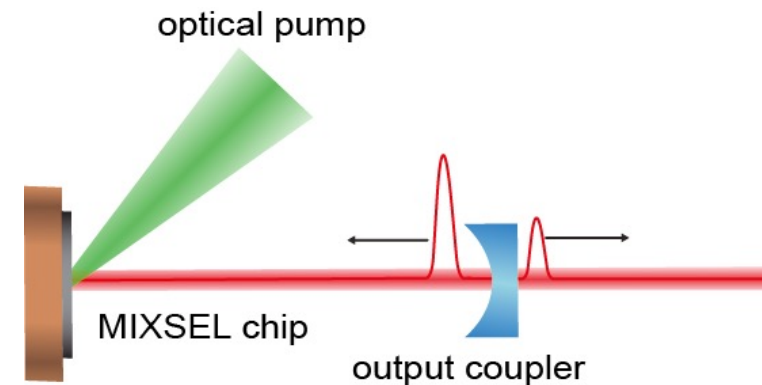
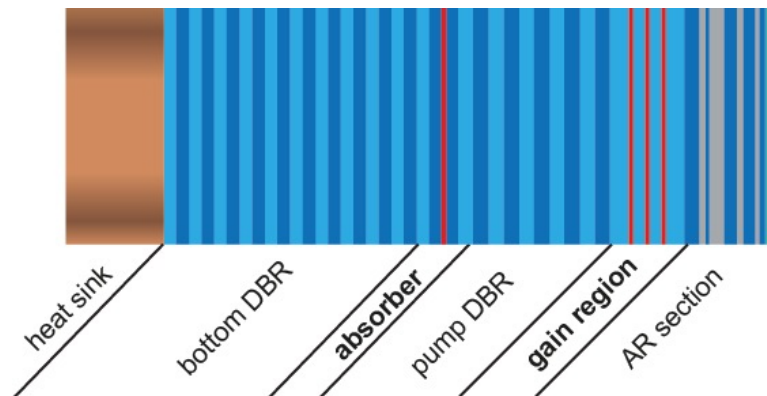
&

SESAM



MIXSEL

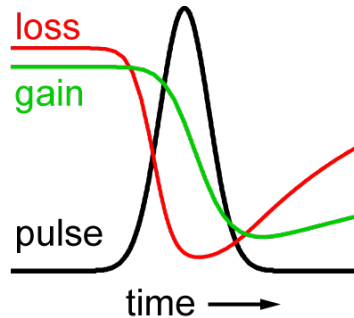
modelocked integrated external-cavity surface-emitting laser



D. J. H. C. Maas et al., *Appl. Phys. B* **88**, 493, 2007

Low saturation fluence $F_{sat,a}$ of saturable absorber

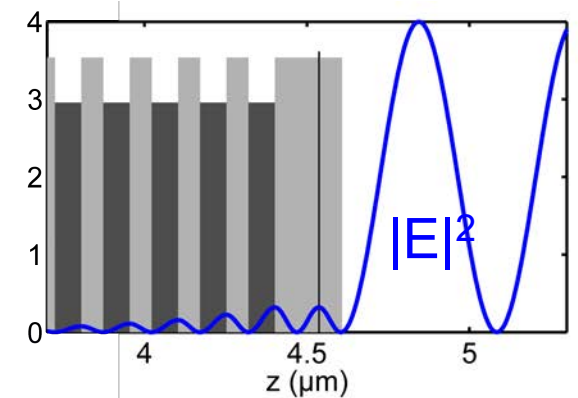
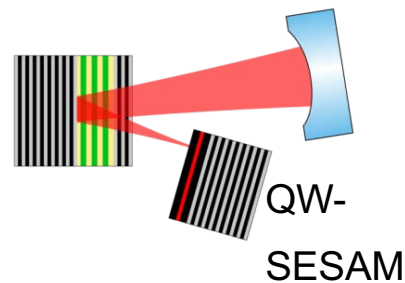
requirement for stable modelocking



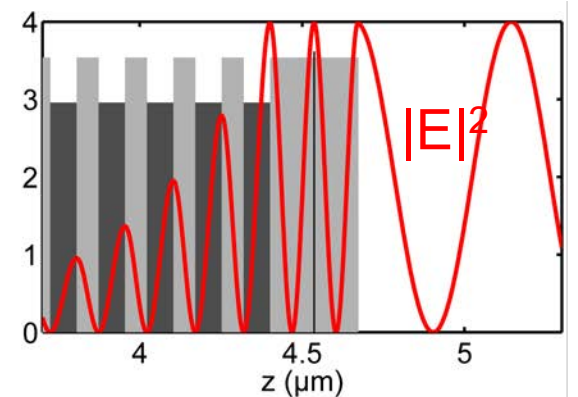
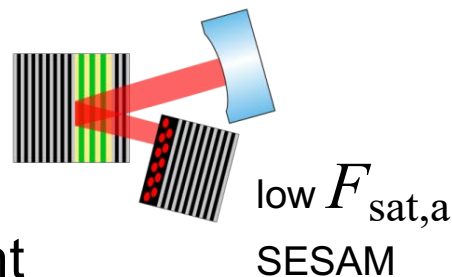
$$\frac{E_{sat,a}}{E_{sat,g}} = \frac{F_{sat,a} A_a}{F_{sat,g} A_g} < 0.1$$

QW-SESAMs: $A_a < A_g$

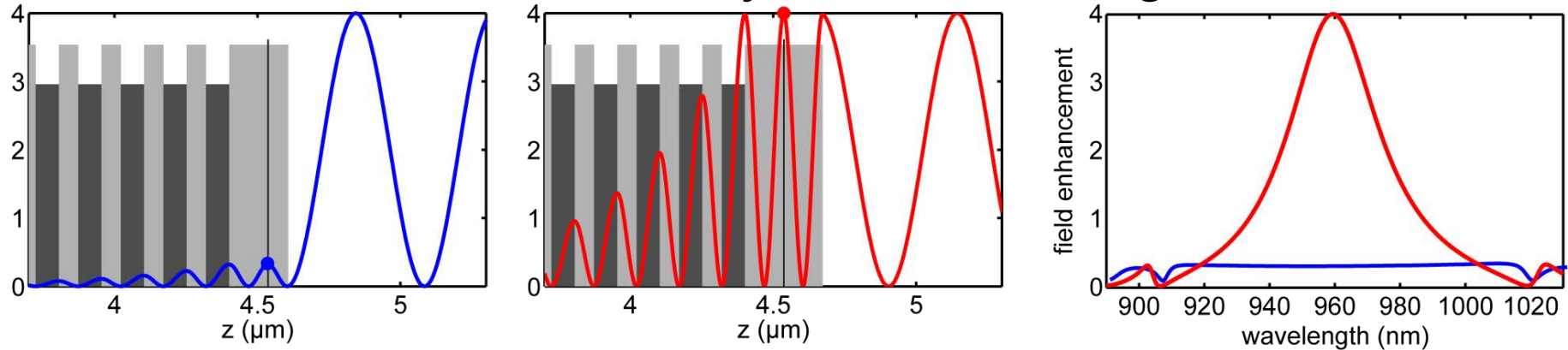
- More difficult for MIXSEL integration!



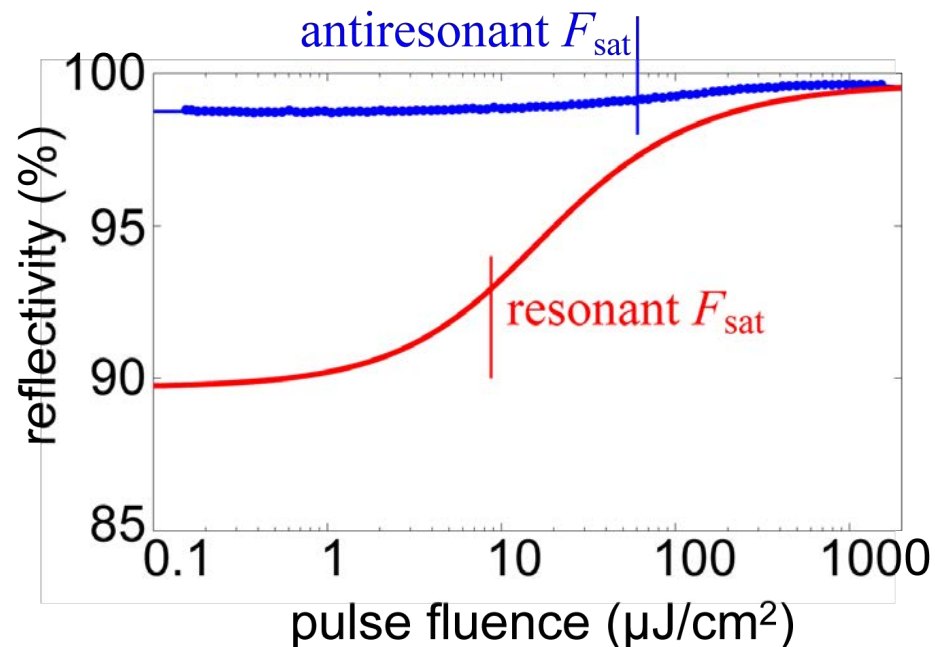
- Need: $F_{sat,a} < F_{sat,g}$
- increase field enhancement
move from antiresonant to resonant



- Increase field enhancement by resonant design^{#1}



- Modulation depth increases



	ΔR (%)	F_{sat} ($\mu\text{J}/\text{cm}^2$)	$\Delta R F_{\text{sat}}$ ($\mu\text{J}/\text{cm}^2$)
antiresonant	1.16	60.5	0.70
resonant	10.03	8.7	0.87

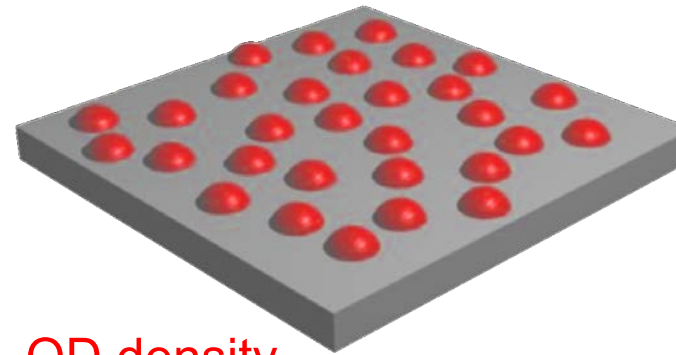
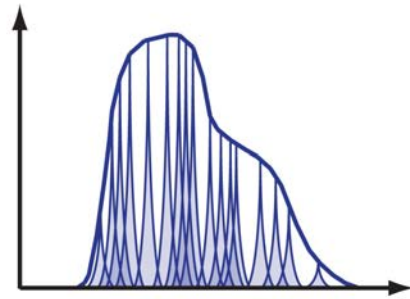
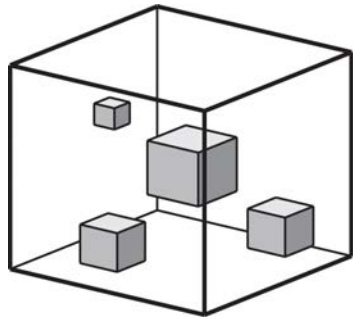
→ too large

$\Delta R F_{\text{sat}}$ is independent of design!

^{#1} Spühler et al., Appl. Phys. B **81**, 27-32 (2005)

Towards Absorber Integration: Quantum Dots (QDs)

QDs absorbers offer more growth parameters than QWs absorbers



Deran Maas (2008)

QD size and size distribution

⇒ determine absorption spectrum

QD density

⇒ determines modulation depth

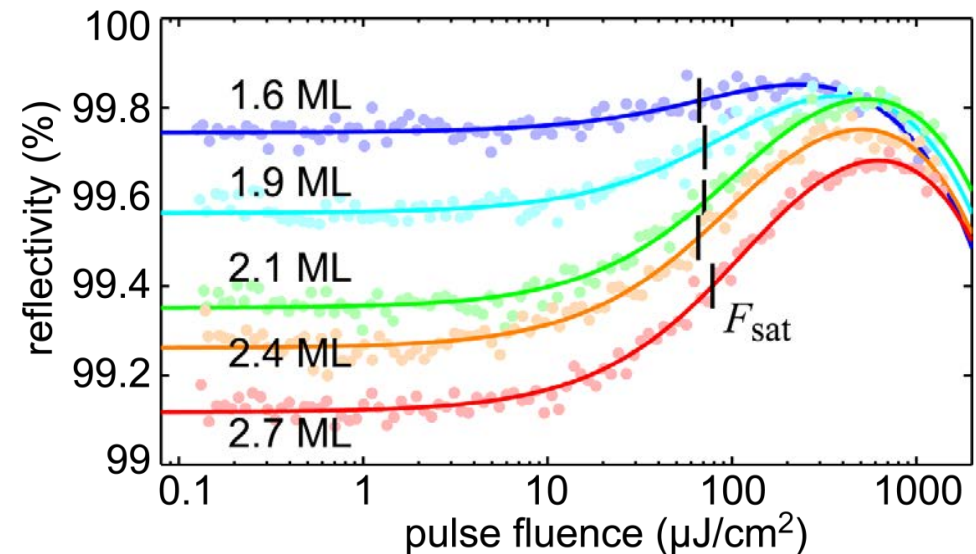
QD growth

- Stranski-Krastanov growth on MBE
- InAs on GaAs substrate
- In ML coverage determines density

Self-assembled QD formation:

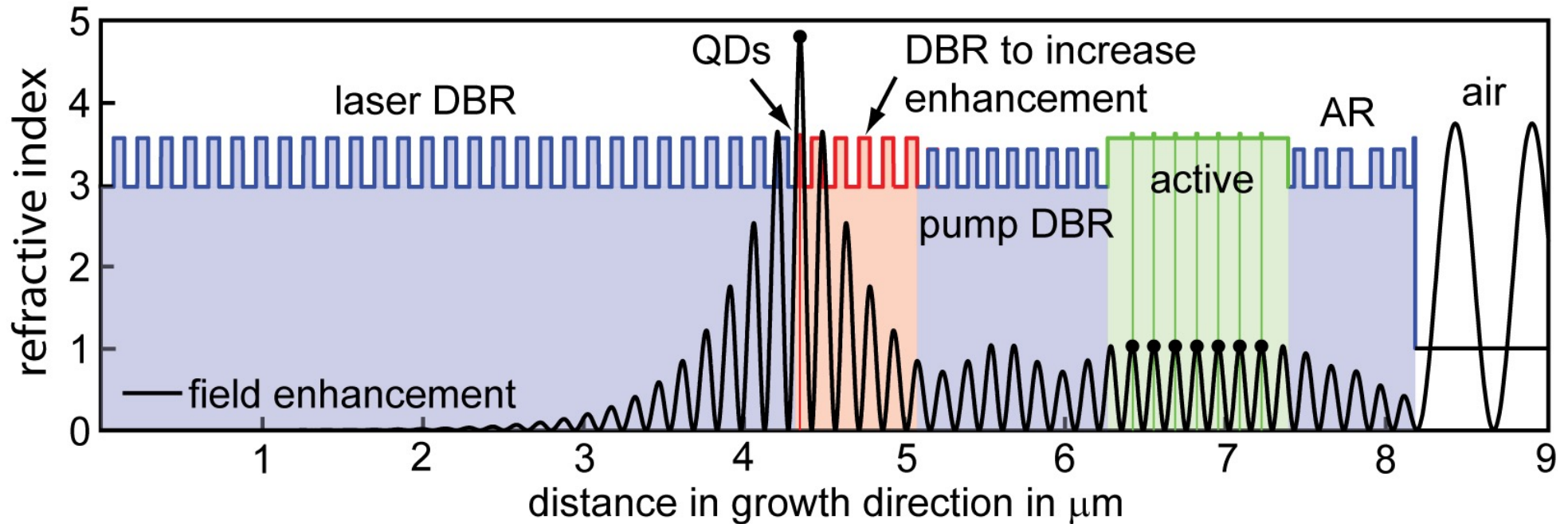


ΔR can be tuned with dot density, while F_{sat} stays constant!



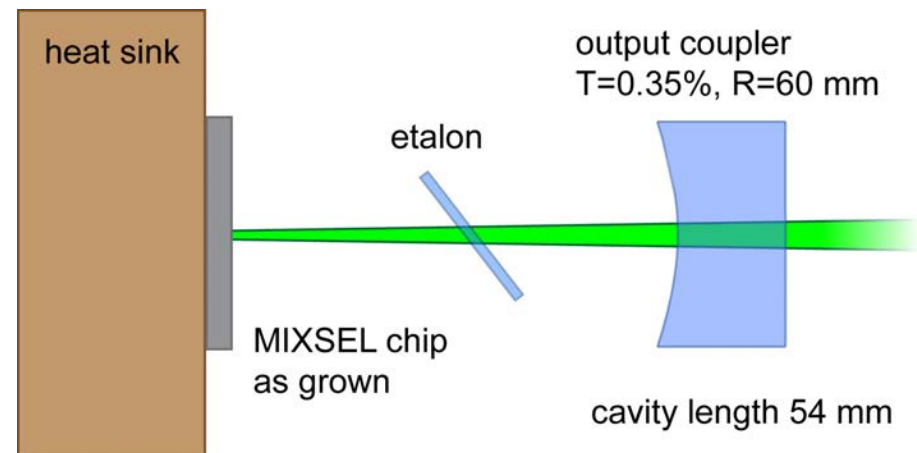
First MIXSEL demonstration: 35 ps, 40 mW, 2.8 GHz

Resonant design



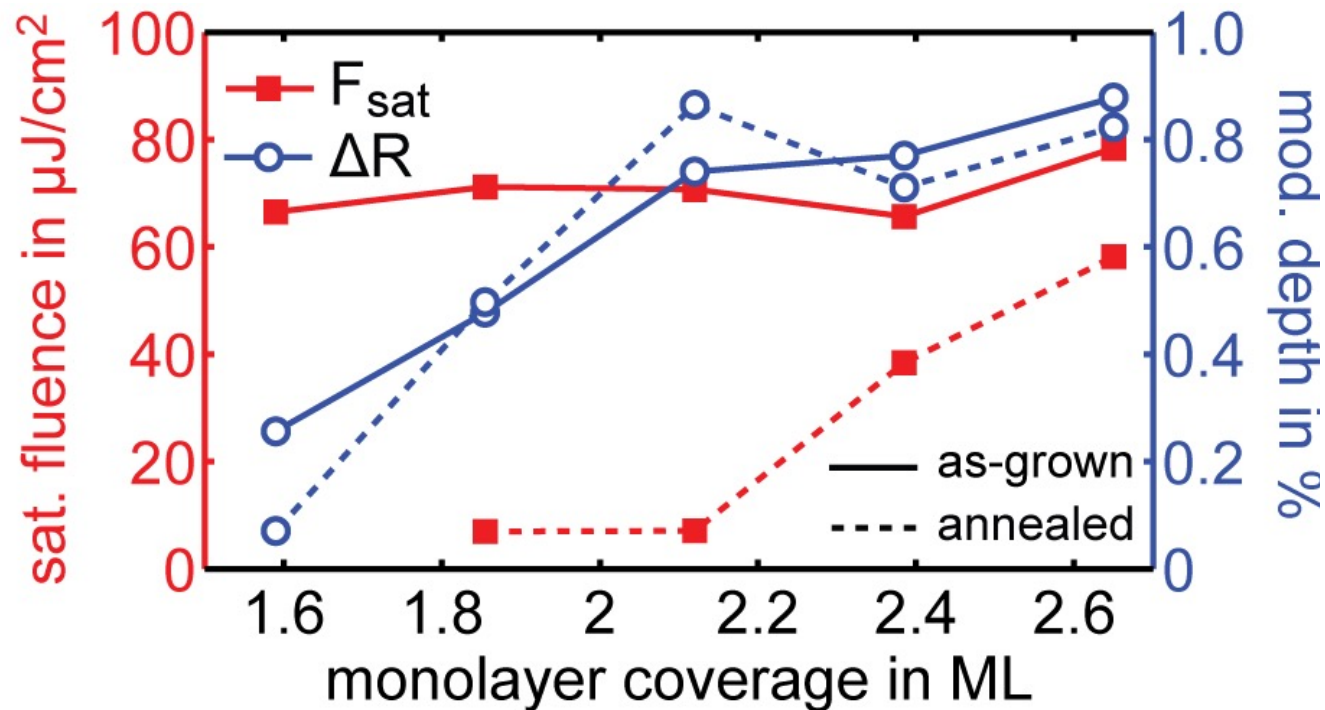
Sections:

- 30 pair bottom mirror for the laser
- 1 layer of self-assembled InAs QD
- DBR to increase field in absorber
- 9 pair mirror for the pump
- active region with 7 InGaAs QWs
- AR coating



D. J. H. C. Maas et al., Applied Physics B **88**, 493-497 (2007)

Optics Express **16**, 18646 (2008)

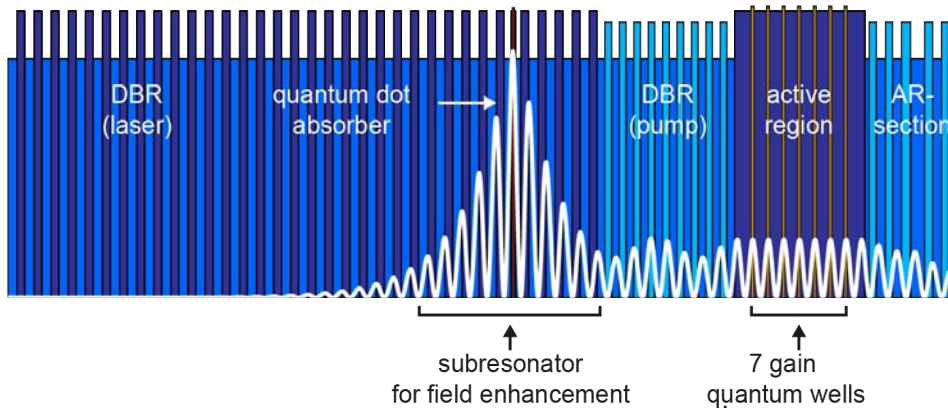


Deran
Maas (2008)

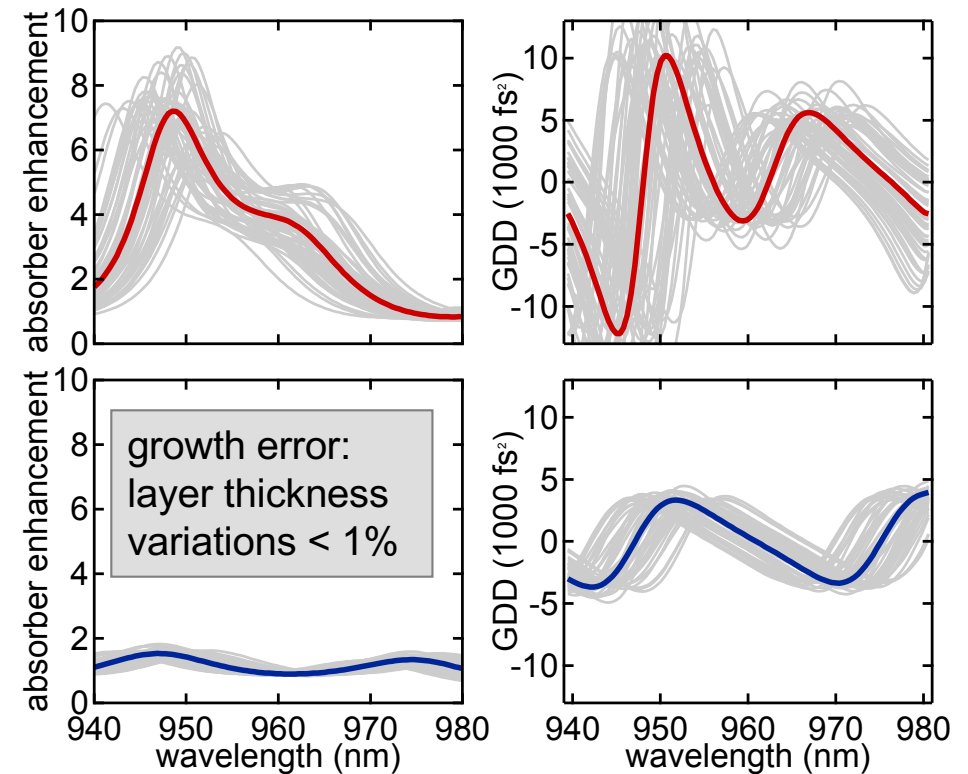
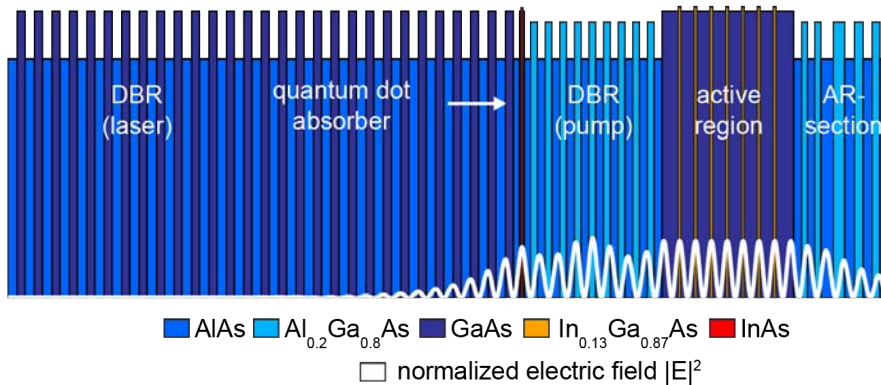
→ F_{sat} decreased by annealing and $\Delta R \approx \text{constant}$



resonant MIXSEL structure



antiresonant MIXSEL structure



Advantages

- less variations in absorber enhancement
- reduced GDD for shorter pulses
- less sensitive to growth errors

Requirement

- QDs with strong saturation
- study on QD-growth parameters optimization of growth temperature and post-growth annealing

A.-R. Bellancourt, Y. Barbarin, D. J. H. C. Maas, M. Shafiei, M. Hoffmann, M. Golling, T. Südmeyer, U. Keller, OE, 17, 12, (2009)
 D. J. H. C. Maas, A. R. Bellancourt, M. Hoffmann, B. Rudin, Y. Barbarin, M. Golling, T. Südmeyer, U. Keller, OE, 16, 23, (2008)



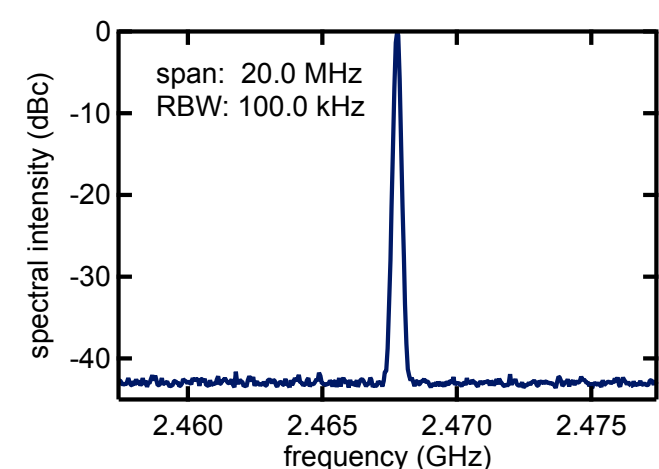
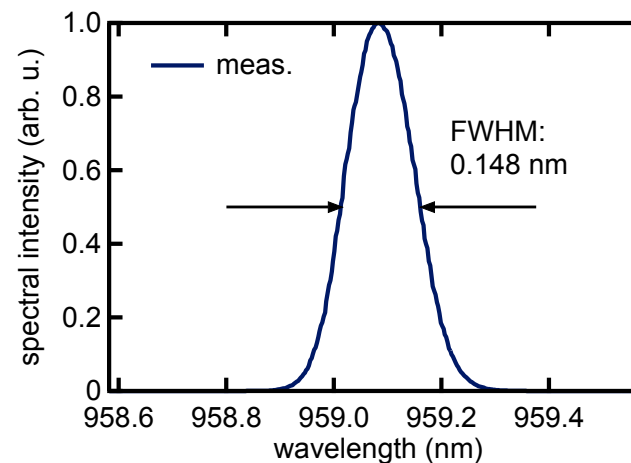
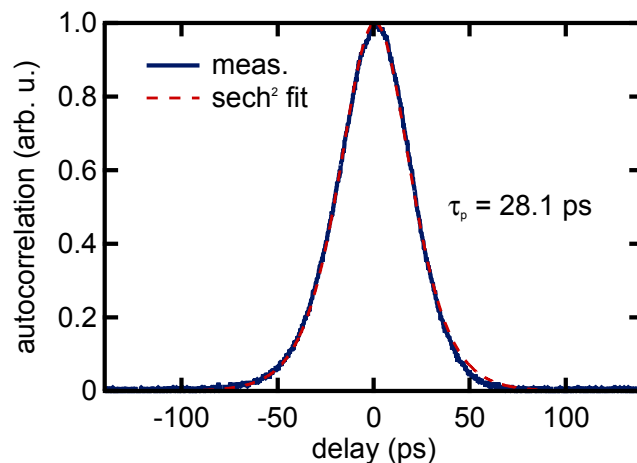
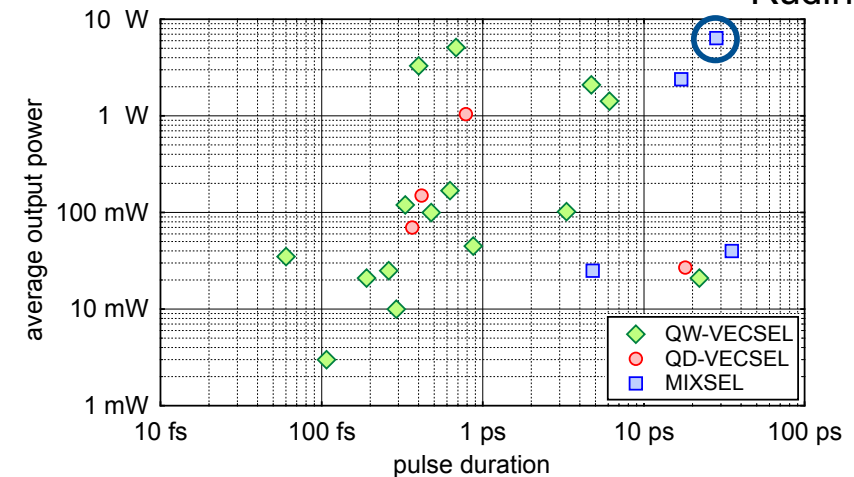
Benjamin Rudin (2010)

highest average power from an ultrafast semiconductor laser

Optics Express **18**, 27582 (2010)

Average power	6.4 W
Center wavelength	959.1 nm
Pulse duration	28.1 ps
FWHM spectral width	0.15 nm

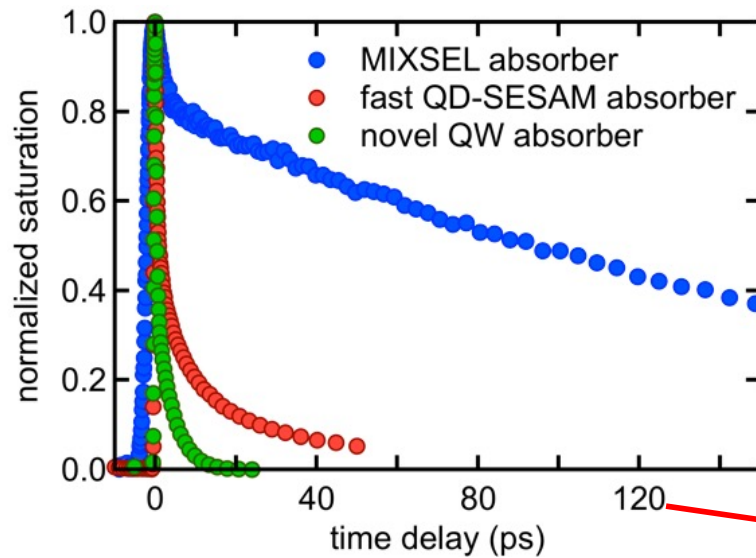
- optical pumping **36.7 W** at **808 nm**
- pump / laser spot radius: $\approx 215 \mu\text{m}$
- cavity length: **60.8 mm** \Rightarrow **2.47 GHz**
- fluence on the MIXSEL : **$252 \mu\text{J}/\text{cm}^2$**



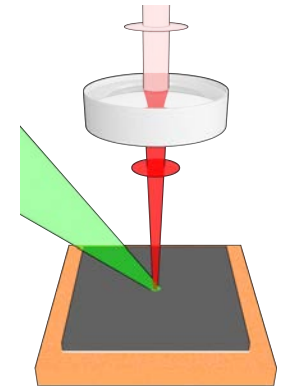
B. Rudin, V.J. Wittwer, D.J.H.C. Maas, M. Hoffmann, O.D. Sieber, Y. Barbarin, M. Golling, T. Südmeyer, U. Keller, *OE* **18**, 27582 (2010)

Pulse Shortening

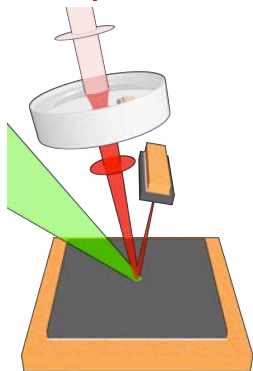
absorber recombination



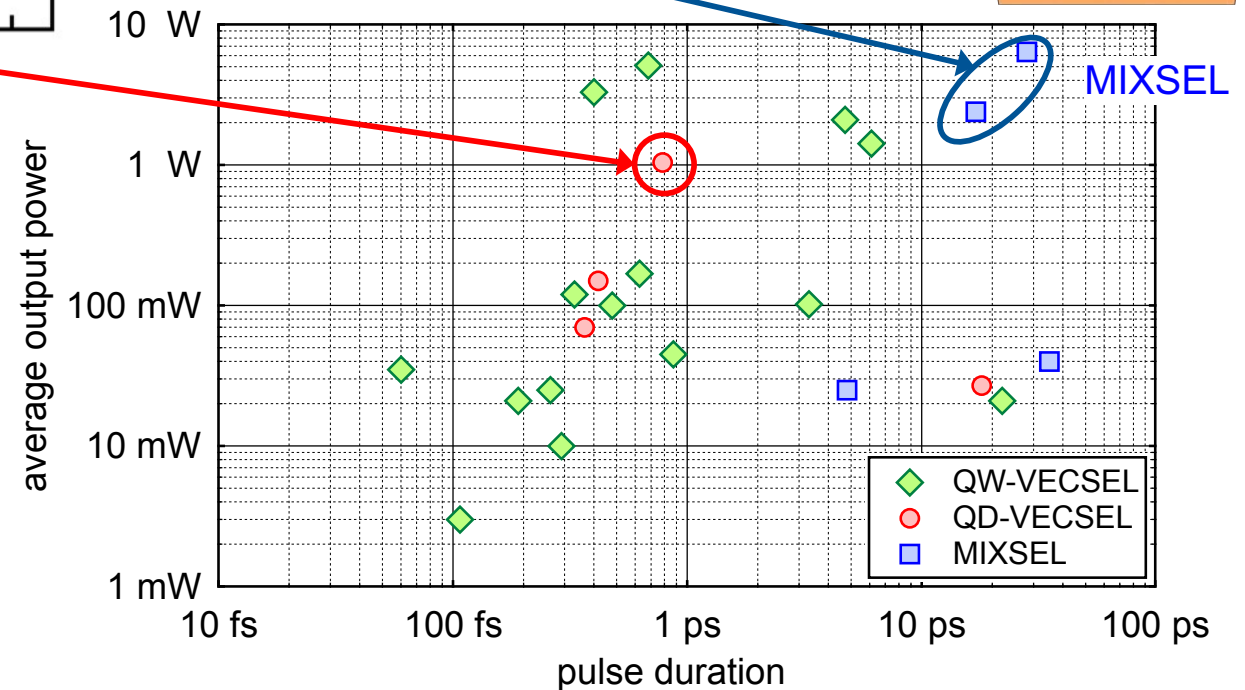
- slow recombination of the QD absorber in the MIXSEL *Optics Express* **18**, 27582 (2010)

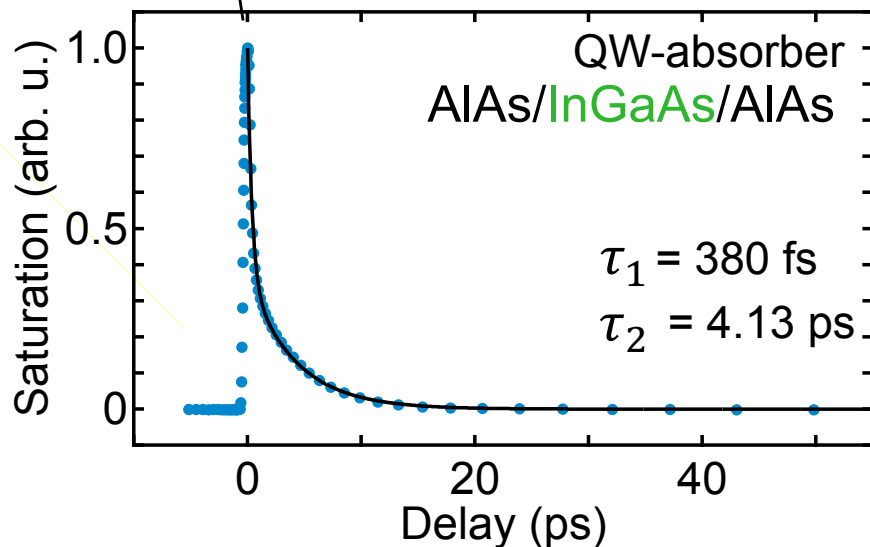
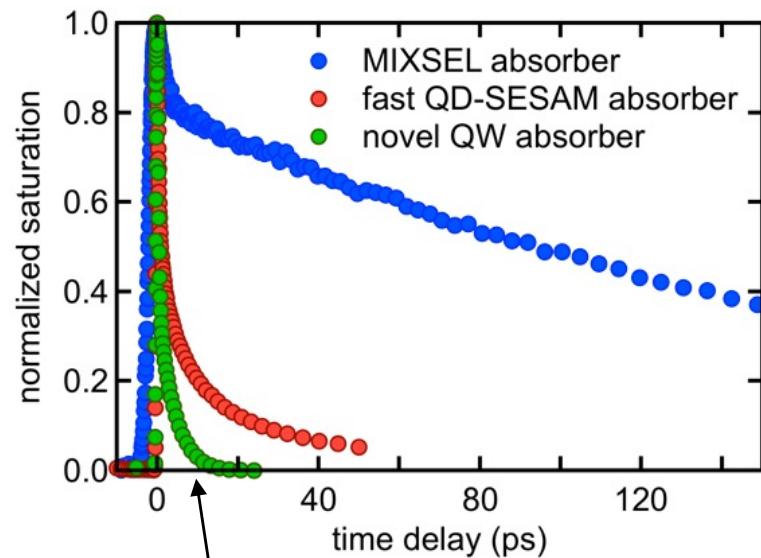


SESAM-modelocked QD-VECSEL:
M. Hoffmann et al.,
Opt. Express **19**, 8108 (2011)



Martin Hoffmann
(2011)





Saturable absorber

M. Mangold et al., *Opt. Express* **21**, 24904 (2013)

- Single LT **InGaAs quantum well**
- Embedded in LT **AIAs**
- Grown by molecular beam epitaxy (MBE)
- Low-temperature grown ($< 300^\circ \text{ C}$)
- Operated close to the **bandedge**

Absorbers for integration

	InGaAs QWs	InAs QDs
Low saturation fluence	+	+
Fast recovery dynamics	+	-
Simple fabrication	+	-
Non-saturable losses	+	+
Temperature sensitivity	-	+
Design freedom	-	+

Lattice parameter changes and point defect reactions in low temperature electron irradiated AIAs

In AIAs defects are rather fixed at their positions and cannot be easily moved by annealing.

A. Gaber, H. Zillgen, P. Ehrhart, P. Partyka, and R. S. Averback

Journal of Applied Physics 82, 5348 (1997)

Jiang *et al.* *Nanoscale Research Letters* (2018) 13:301 Nanoscale Research Letters
<https://doi.org/10.1186/s11671-018-2719-7>

NANO EXPRESS

Open Access



First-Principles Study of Point Defects in GaAs/AIAs Superlattice: the Phase Stability and the Effects on the Band Structure and Carrier Mobility

Antisite defects

i.e. Ga_{As} , Al_{As} , As_{Ga}

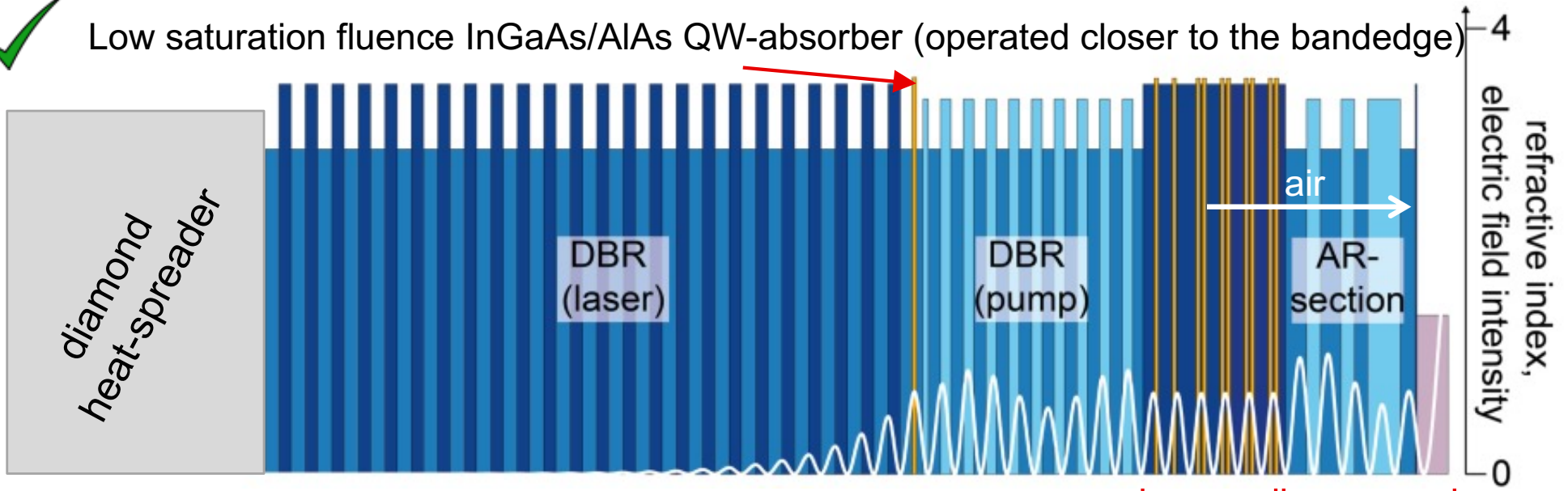
are energetically more favorable than vacancy and interstitial defects in GaAs/AIAs superlattices

Ming Jiang¹, Haiyan Xiao^{1*} , Shuming Peng², Liang Qiao¹, Guixia Yang², Zijiang Liu³ and Xiaotao Zu¹

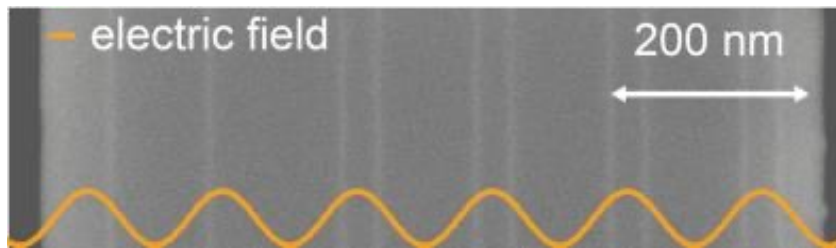




Low saturation fluence InGaAs/AIAs QW-absorber (operated closer to the bandedge)

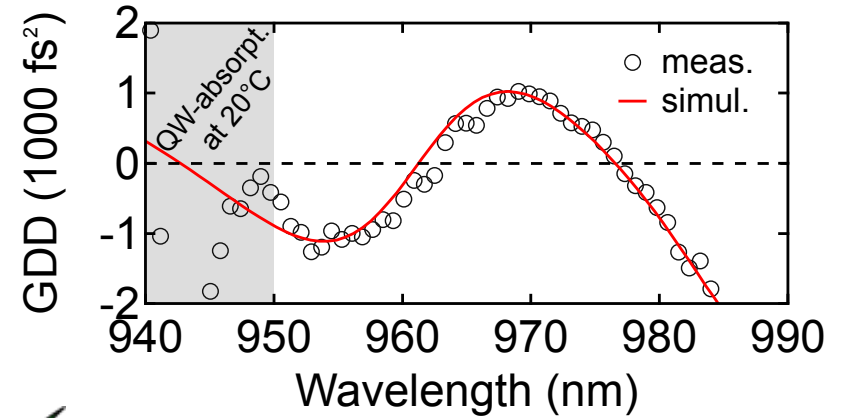


10 quantum well active region



Higher gain saturation fluence and more broadband gain

Anti-reflection section

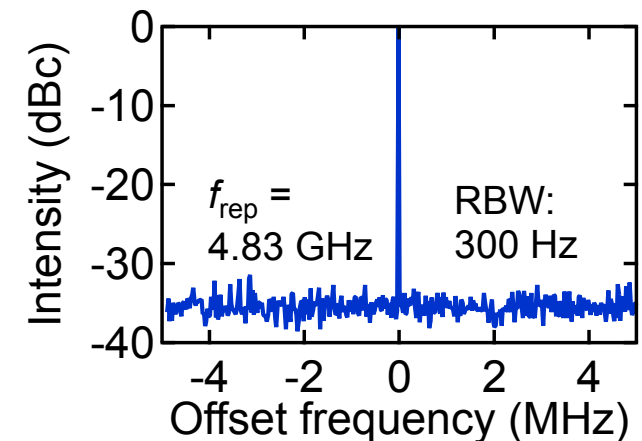
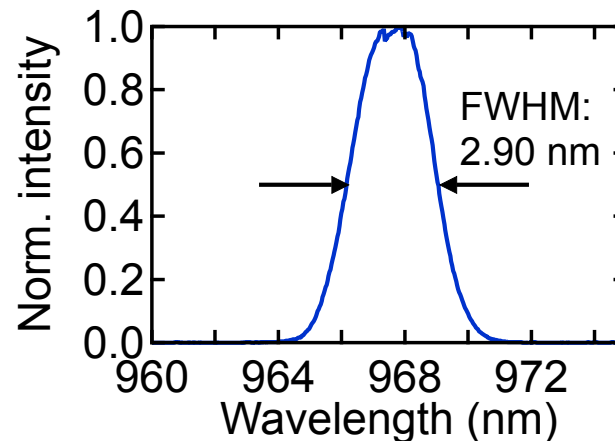
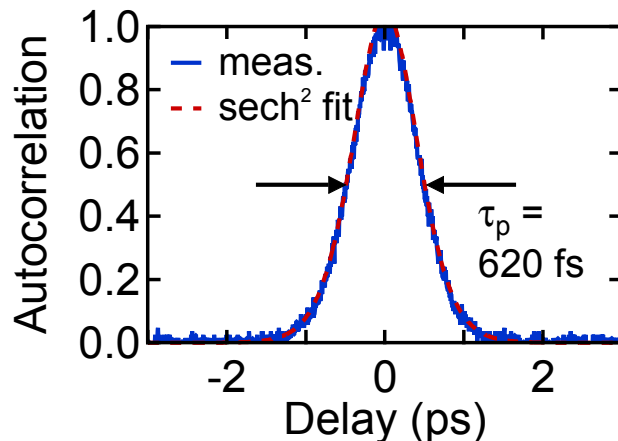
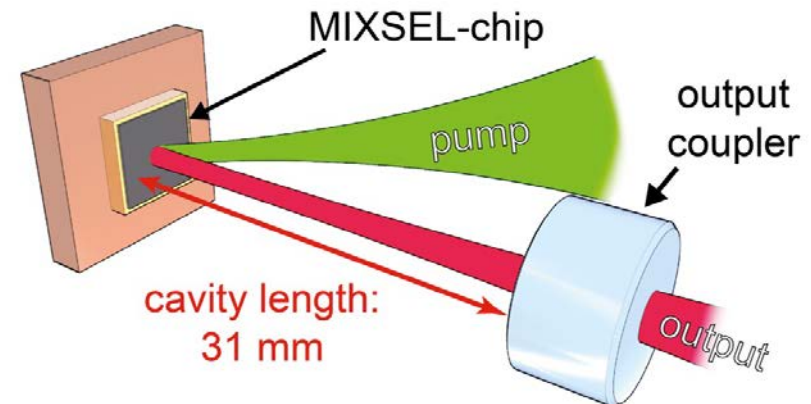


Low and flat group-delay dispersion

M. Mangold et al., *Opt. Express* **21**, 24904 (2013)



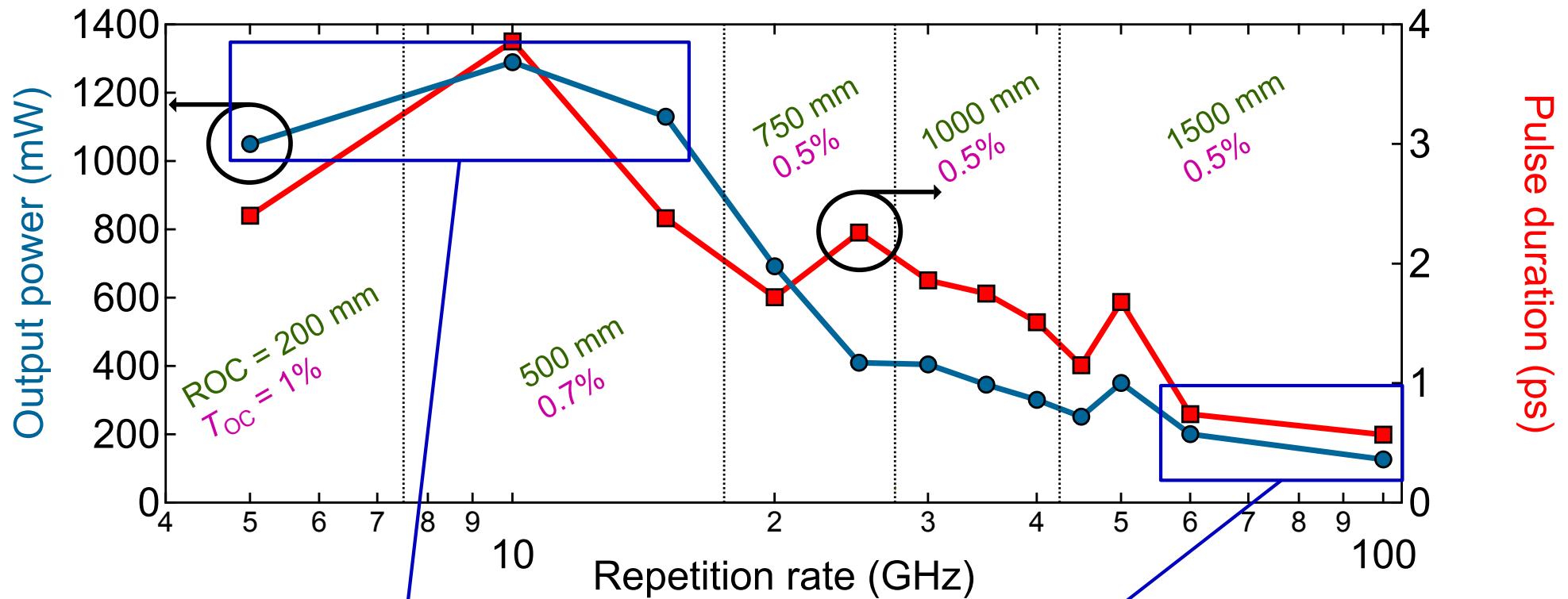
Pulse duration: **620 fs**
 Average output power: 101 mW
 Repetition rate: 4.83 GHz
 Center wavelength: 967.7 nm



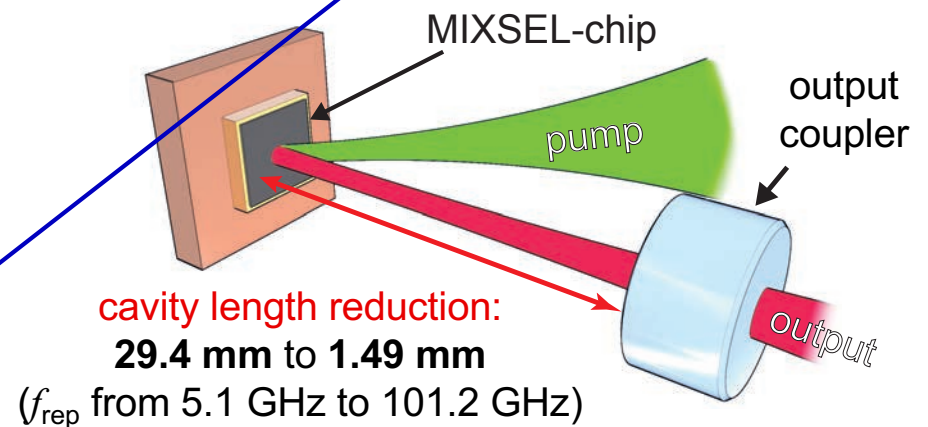
- Optical pumping **24.9 W** at **808 nm**
- Heat sink temperature: **+ 11 ° C**
- Output coupling: **0.35 % (ROC 200 mm)**
- Beam quality: **$M^2 < 1.05$**

**Shorter pulse duration enable
scaling to higher repetition rates**

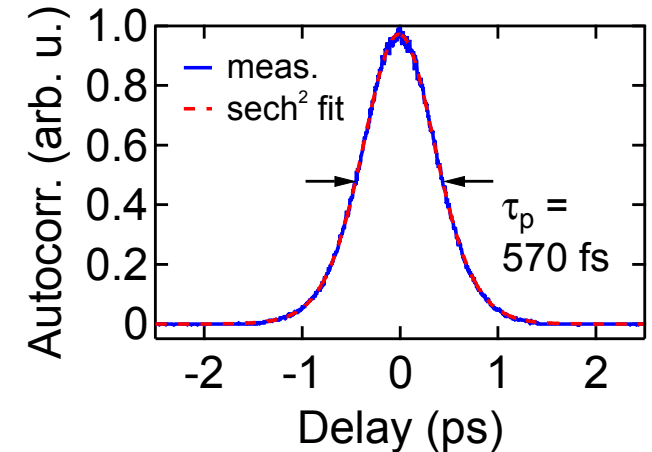
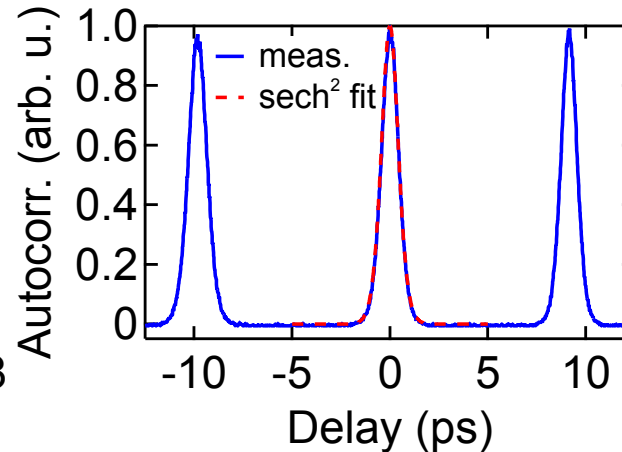
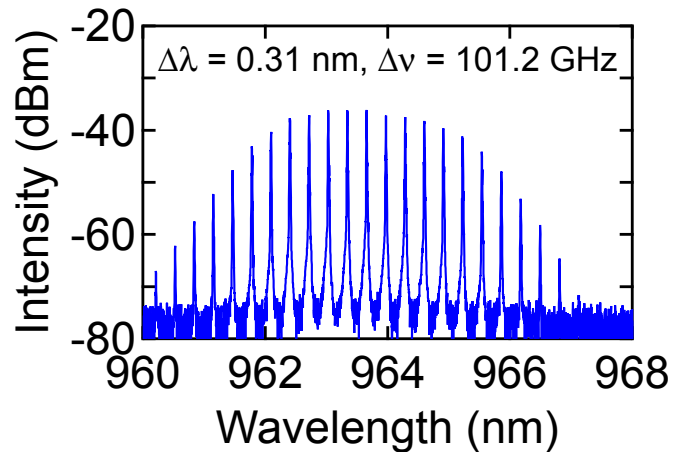
M. Mangold et al., *Opt. Express* **21**, 24904 (2013)



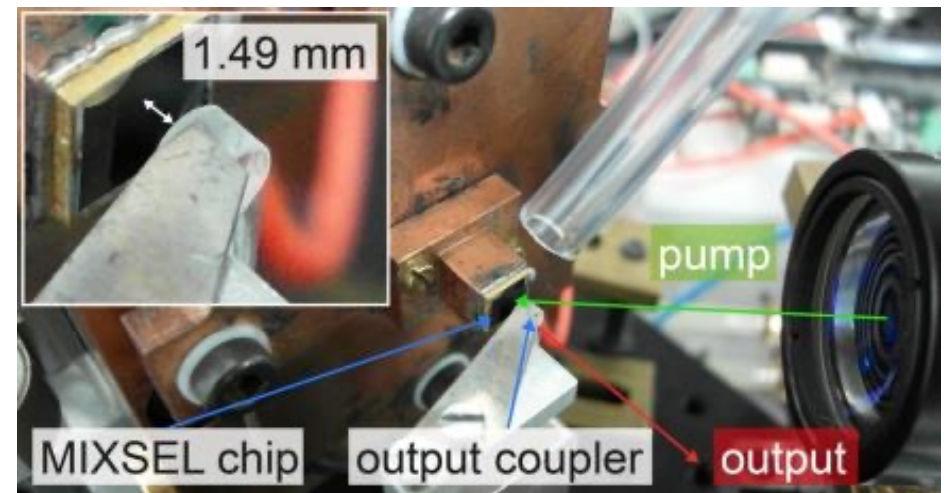
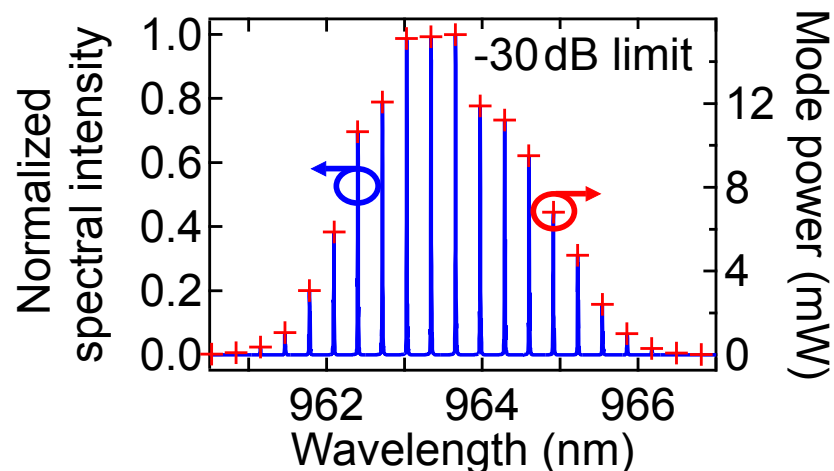
- Repetition rate-tuning from 5 GHz to 101 GHz with single MIXSEL structure
- Watt-level operation up to 15 GHz
- Femtosecond operation at 60 GHz and 101 GHz
- $M^2 < 1.1$ for all measurements



M. Mangold et al., *Opt. Express* **22**, pp. 6099 (2014)

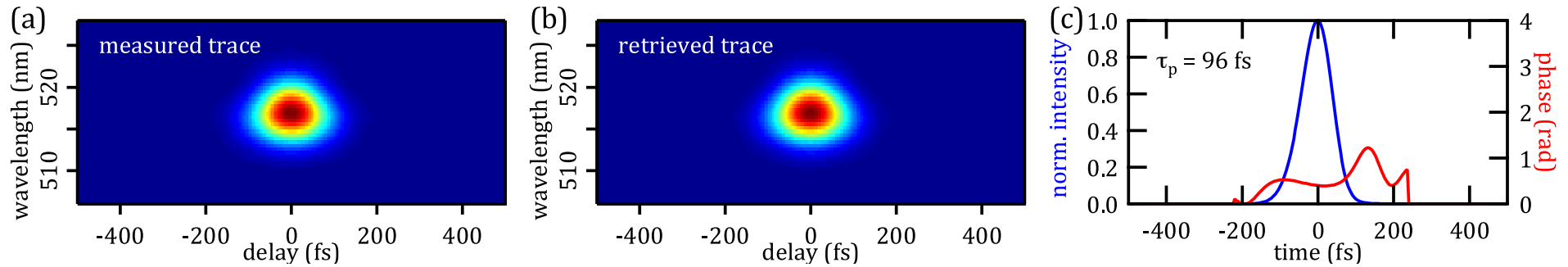


Pulse duration: **570 fs**
Average output power: **127 mW**
Repetition rate: **101.2 GHz**
Av. mode power (-30 dB): **7.5 mW**



M. Mangold et al., *Opt. Express* **22**, pp. 6099 (2014)

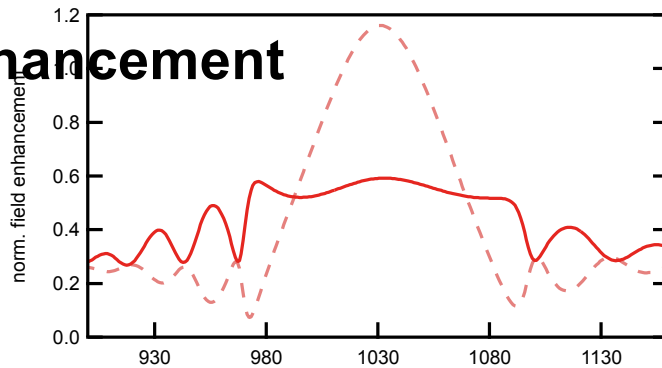
ETH World-record 100-fs 100-mW 1.63-GHz VECSEL



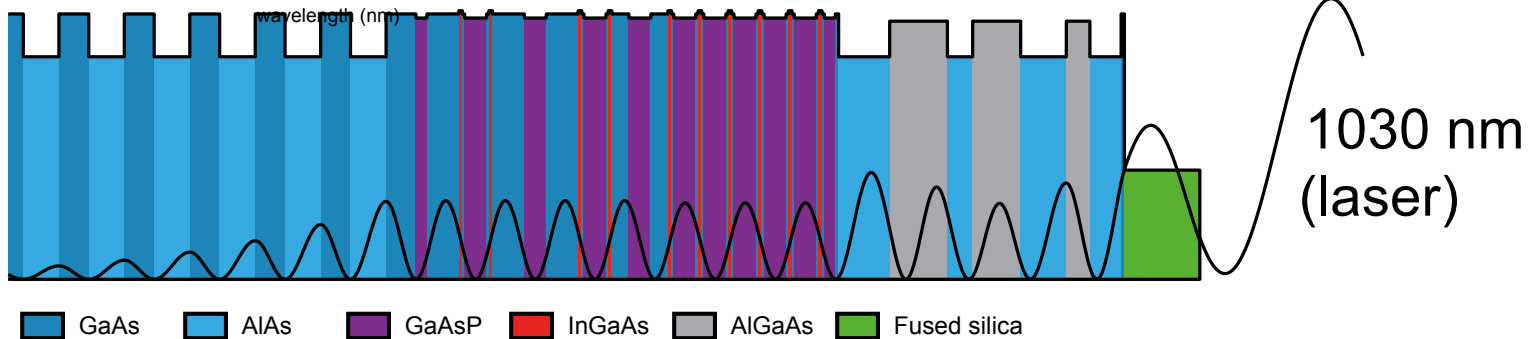
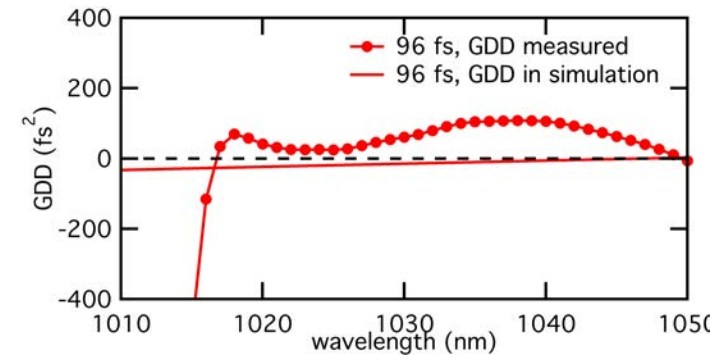
Pulse duration 96 fs
 Pulse repetition rate 1.63 GHz
 Average power 100 mW

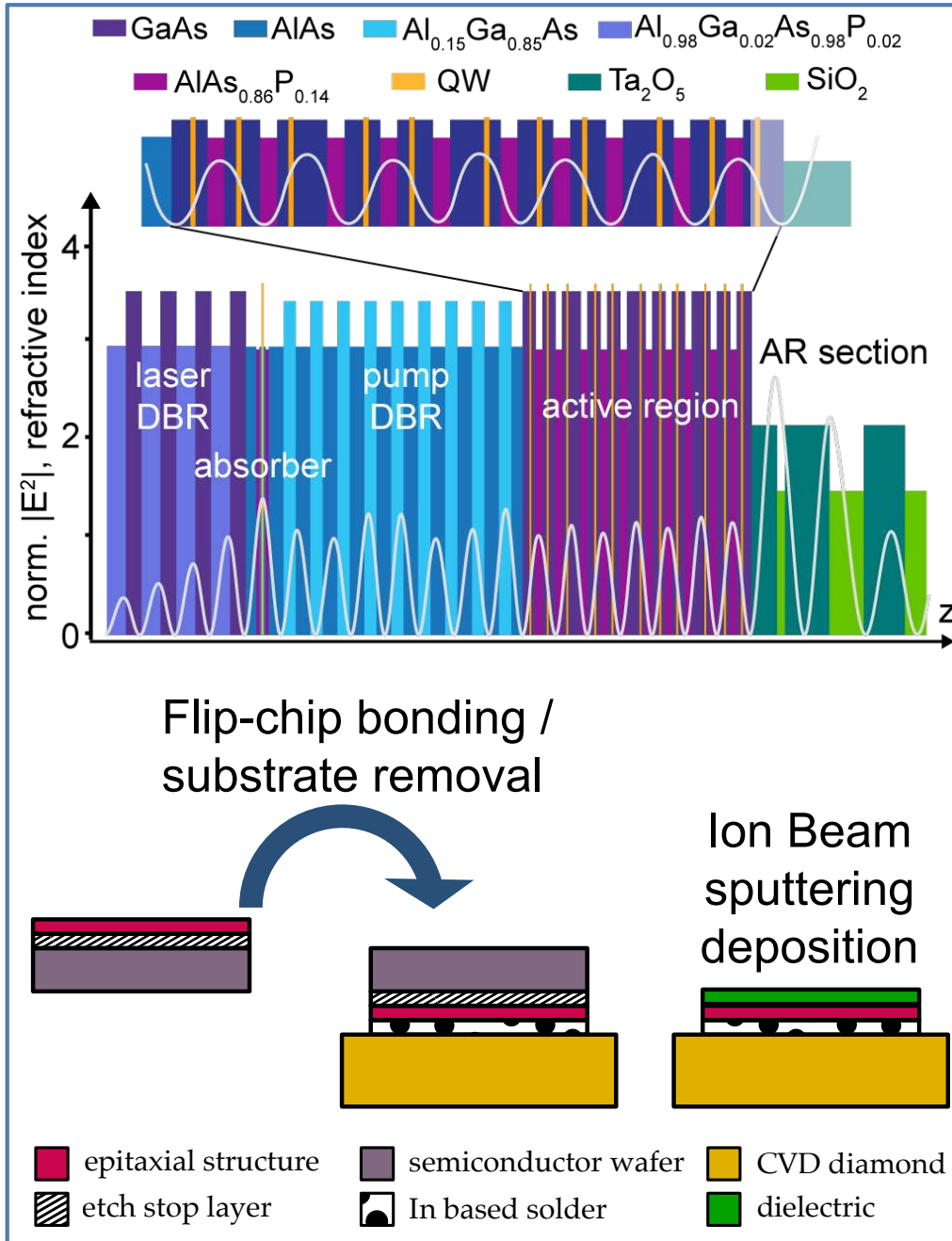
D. Waldburger et al., *Optica* 3, 844–852 (2016)

Field enhancement



Group delay dispersion



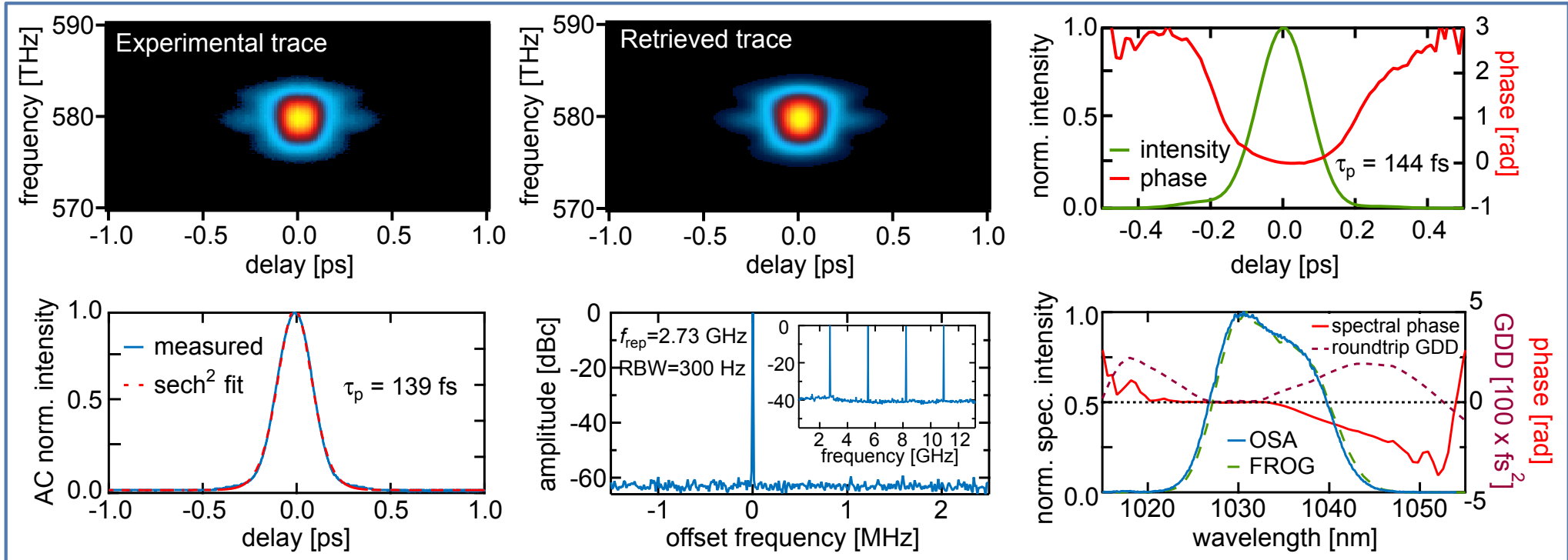


Design optimization

- ⇒ **Quaternary GaAs/AlGaAsP DBR**
 - ⇒ Ga to decrease oxidation
 - ⇒ P for strain compensation
- ⇒ **Strain-compensated absorber**
- ⇒ **Large-bandgap AlAsP strain-compensation for the active region:**
 - ⇒ Reduced TPA losses
 - ⇒ Optimized pump absorption
 - ⇒ Better carrier confinement
 - ⇒ No spectral filtering (broad gain)
- ⇒ **Dielectric IBS top coating (GDD):**
 - ⇒ Precise layer thickness
 - ⇒ Protection against oxidation
 - ⇒ Reduced TPA losses

139-fs MIXSEL at 1.03 μm

Opt. Letters **44**, 25 (2019)

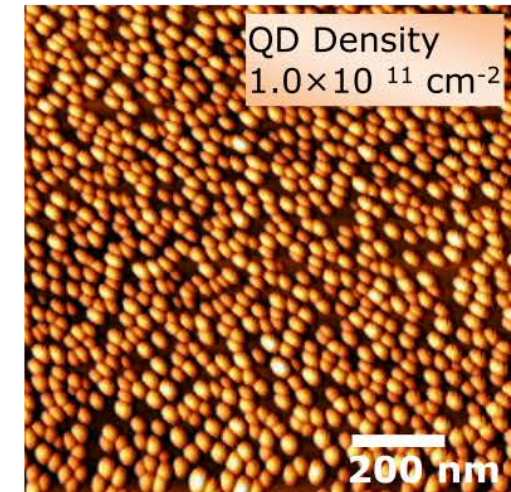
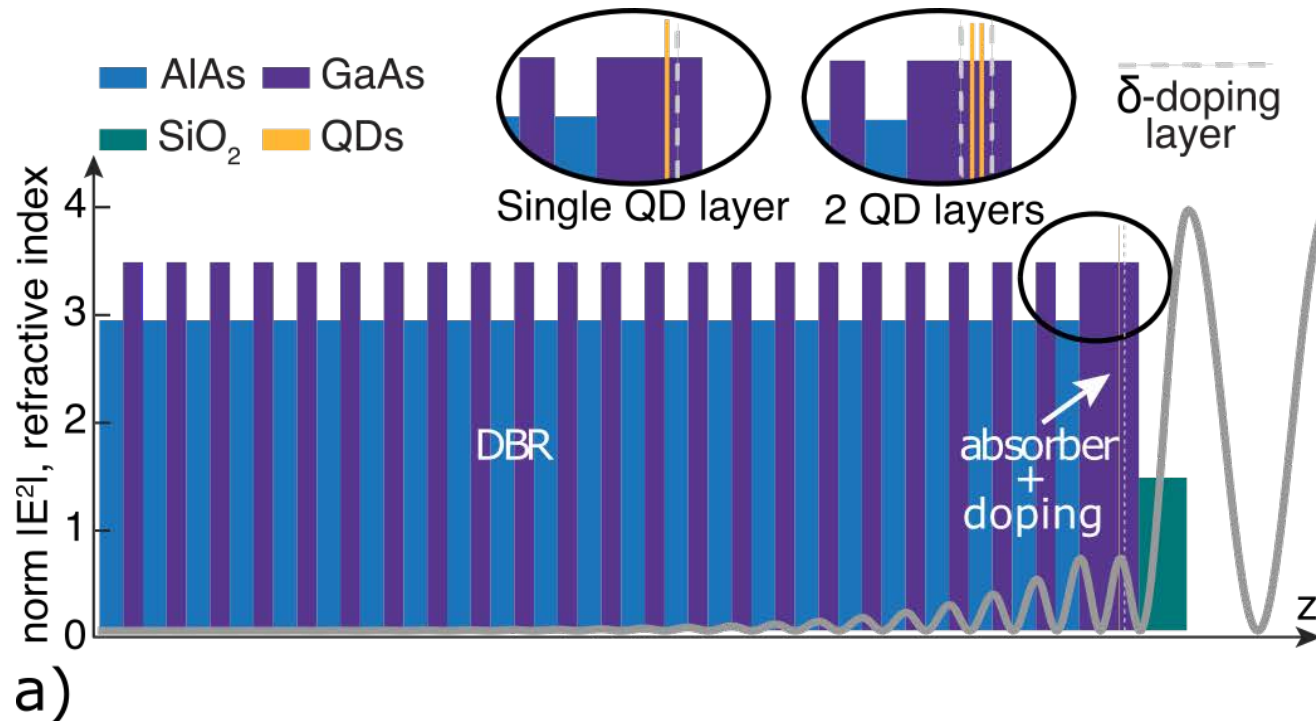


center wavelength [nm]	1033
bandwidth [nm]	13
pulse duration [fs]	139
average output power [mW]	30
pulse repetition rate [GHz]	2.73
Dual-comb operation	✓

- ✓ 13 nm of FWHM bandwidth (prev. 7.4 nm)
- ✓ Central wavelength tuned to C_2H_2
- ✓ First sub-150-fs MIXSEL
- ✓ Sufficient output power for spectroscopy
- ✓ Sufficient resolution for spectroscopy
- ✓ Turn-key for hundreds of hours

C. G. E. Alfieri*, D. Waldburger*, J. Nürnberg, M. Golling, U. Keller, "Sub-150-fs from a broadband MIXSEL", *Opt. Letters* **44**, 25 (2019)

ETH zürich Novel concepts for fast saturable absorbers



- High quality InGaAs quantum dots (QDs)
- Radiative recombination is enhanced with high hole density in QDs with modulation doping (using p-typed δ -doping)
- Low saturation fluence $< 10 \mu\text{J}/\text{cm}^2$

T. Finke, J. Nürnberg, V. Sichkovskiy, M. Golling, U. Keller, J. P. Reithmaier,
“Temperature resistant fast $\text{In}_x\text{Ga}_{1-x}\text{As}/\text{GaAs}$ quantum dot saturable absorber for epitaxial integration into semiconductor surface emitting lasers”

Optics Express, vol. 28, No. 14, pp. 20954-20965, 2020

1. **SESAM, VECSEL and MIXSEL basic device structure**
2. **Dual-comb modelocking and application demonstration**
3. **III-V semiconductor material**
4. **MIXSEL and SESAM modelocked VECSEL**
- ➔ **5. Long wavelength SESAMs ($> 2\mu\text{m}$)**

FIRST 
Center for Micro- and Nanoscience



This project has received funding from the European Research Council (ERC) under the European Union's Horizon 2020 research and innovation programme grant agreement No 787097

started 1. Jan. 2019



Dr. Özgür
Alaydin

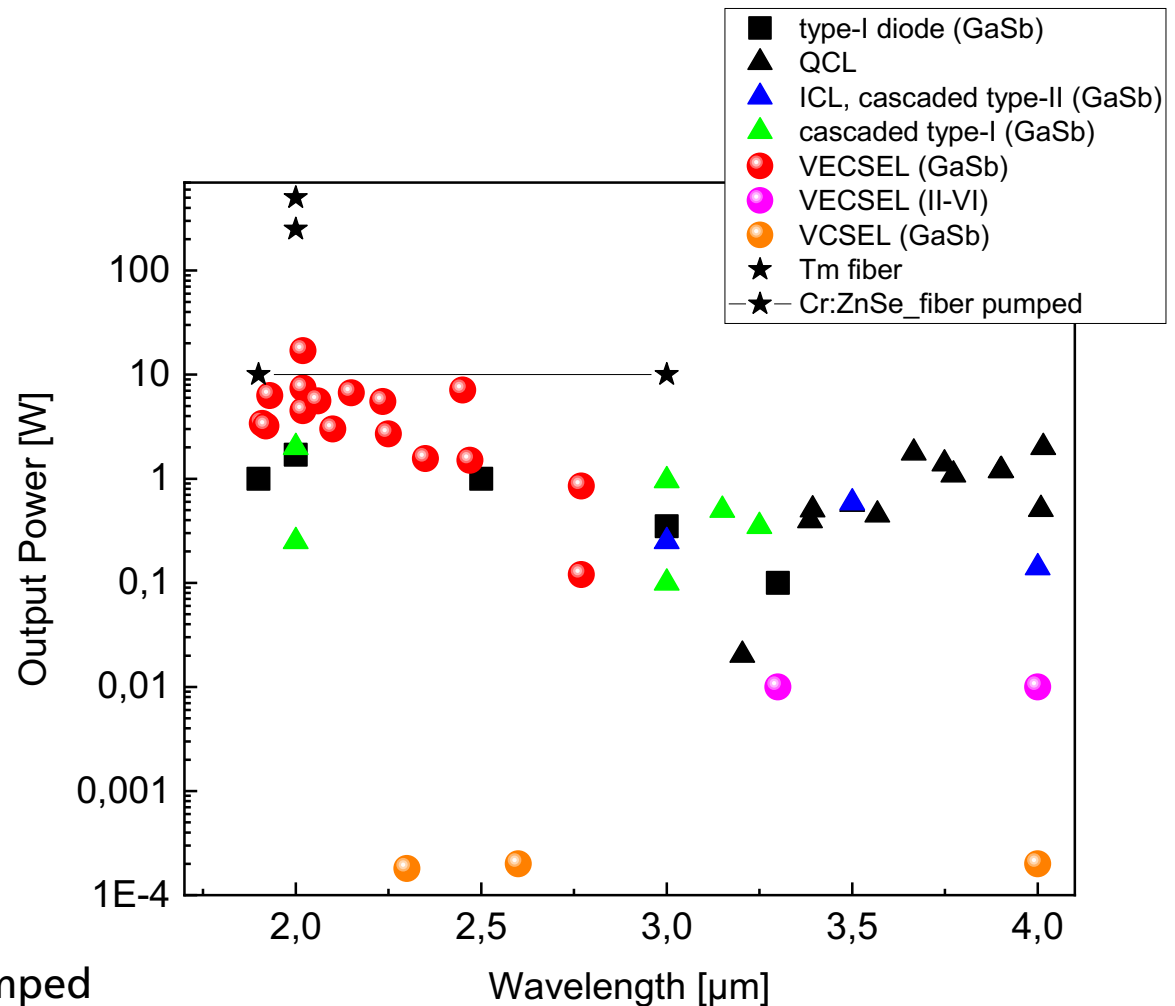


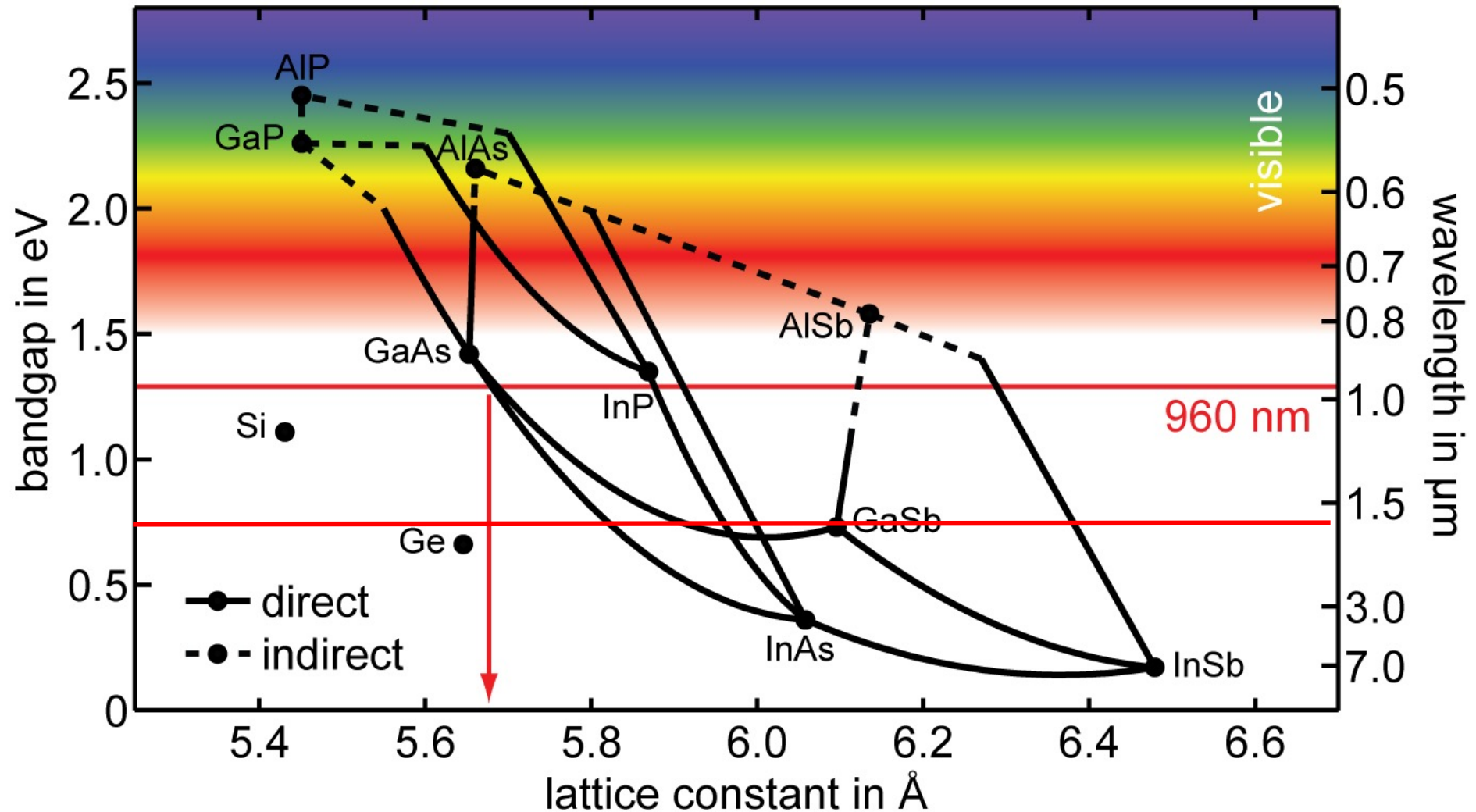
Dr. Matthias
Golling



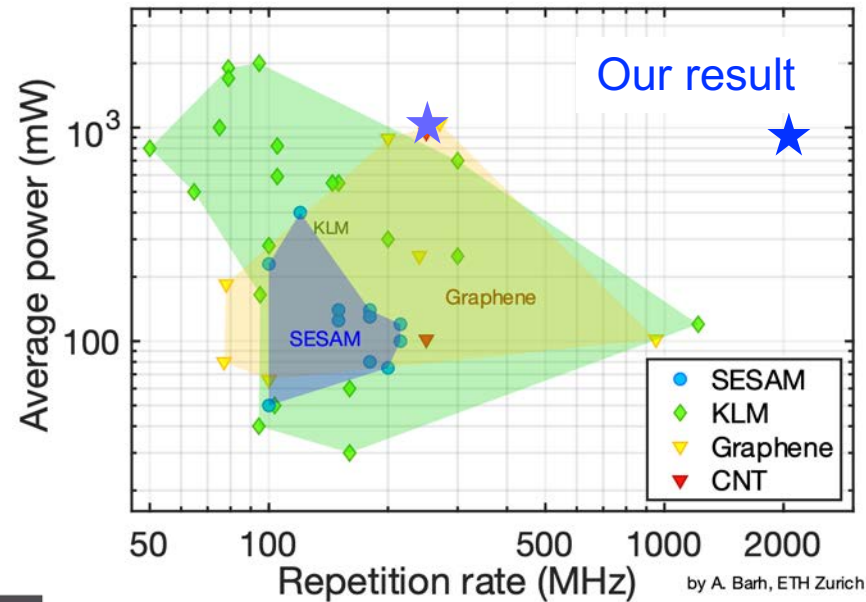
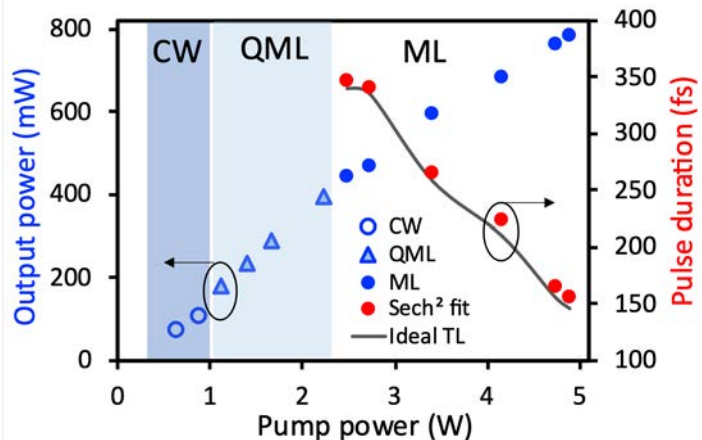
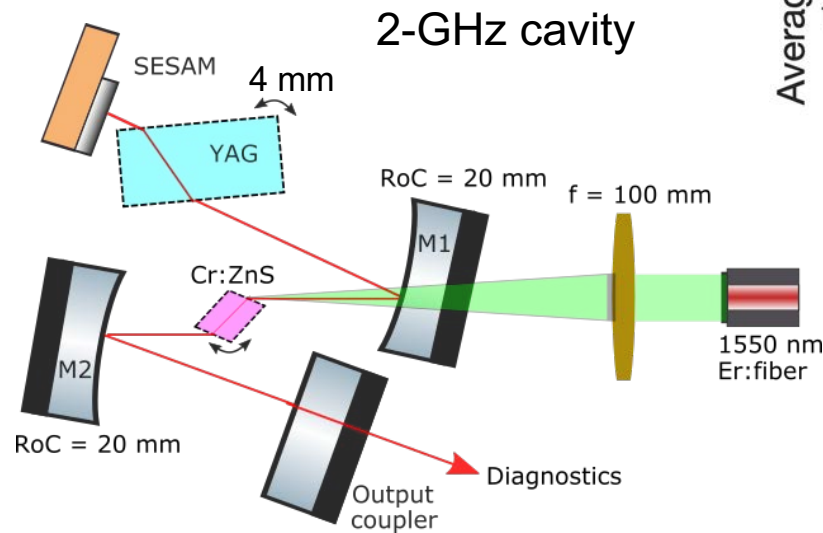
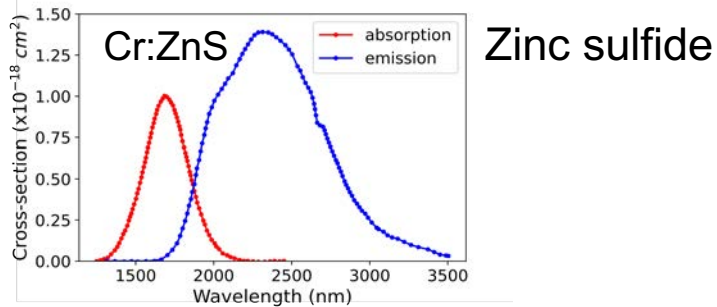
Introduction

- GaSb-based diode laser:
 - 2 – 3 μm
 - up to 2 W with poor beam quality
- QCLs for $\lambda > 3.5 \mu\text{m}$
- ICT, Interband cascaded type-II
- Cascaded type-I
 - 1W at 3 μm
- GaSb-based VECSEL
 - Up to 17 W CW @ RT
 - High beam quality
- II-VI-based VECSEL
 - 3 – 5 μm
- Electrically pumped VCSEL
 - GaSb, type-I, type-II
 - 2 – 4 μm
- Tm fiber laser / Cr:ZnSe, Tm-fiber pumped





- GaSb Substrate, GaSb/AlAsSb DBR
- InGaSb saturable absorbers (exploring both type I and type II structures)
- 2.07- μm SESAMs demonstrated, Phys. Status Solidi C 9, No. 2, 294–297 (2012)

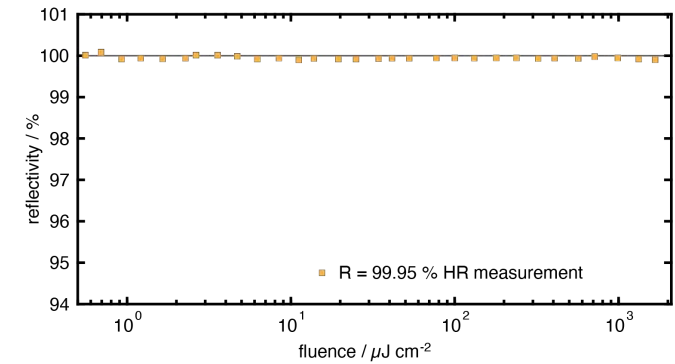
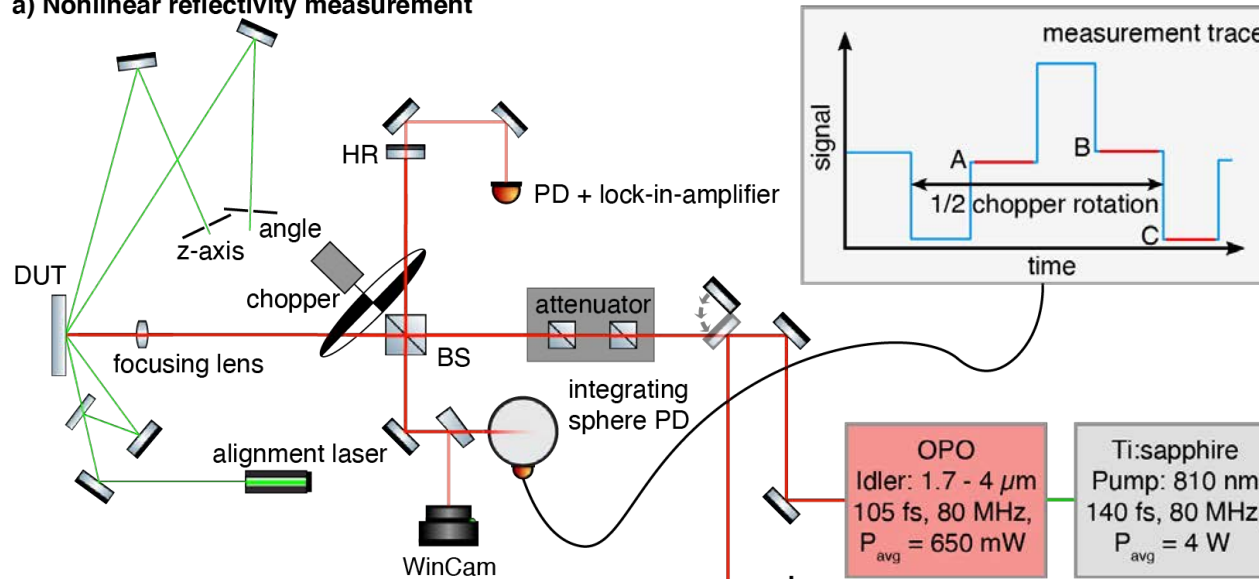


Dr. Ajanta
Barh

- Soliton modelocking with transform-limited pulses
SESAM only starts and stabilizes modelocking!
4 mm YAG gives negative GDD (-1300 fs^2)
ZnS gain crystal gives positive SPM
- **250-MHz Cr:ZnS laser:**
A. Barh et al., *Optics Express*, 29, 5934 (2021)
5% output coupler, **0.8 W (1 W)** average output power with
79 fs (120 fs) pulses, peak power **39 kW (32 kW)**
- **2-GHz Cr:ZnS laser (CLEO postdeadline paper):**
3% output coupler, **0.8 W** average output power with **157 fs**
pulses at **2.04 GHz**, peak power **2.5 kW**

ETH zürich Long-wavelength SESAM characterization

a) Nonlinear reflectivity measurement



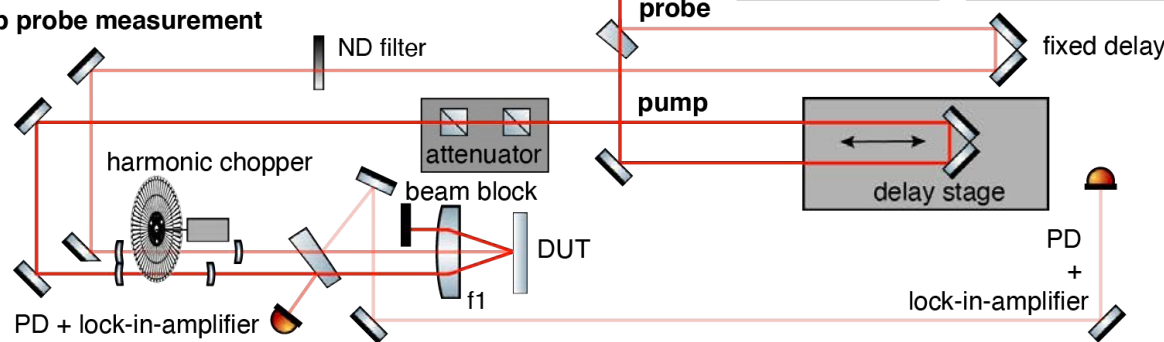
High reflector (HR)

precision measurement:

$$\sigma_R \leq 0.04\%$$

over ≈ 4 orders of magnitude

b) Pump probe measurement



Wavelength range for device under test (DUT): 1.9 μm to 3 μm



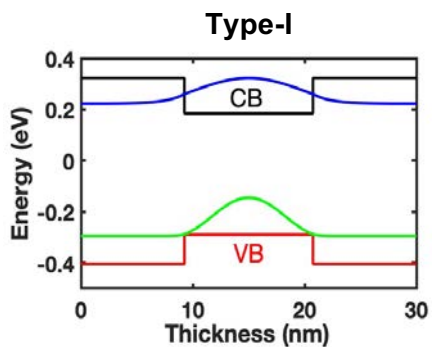
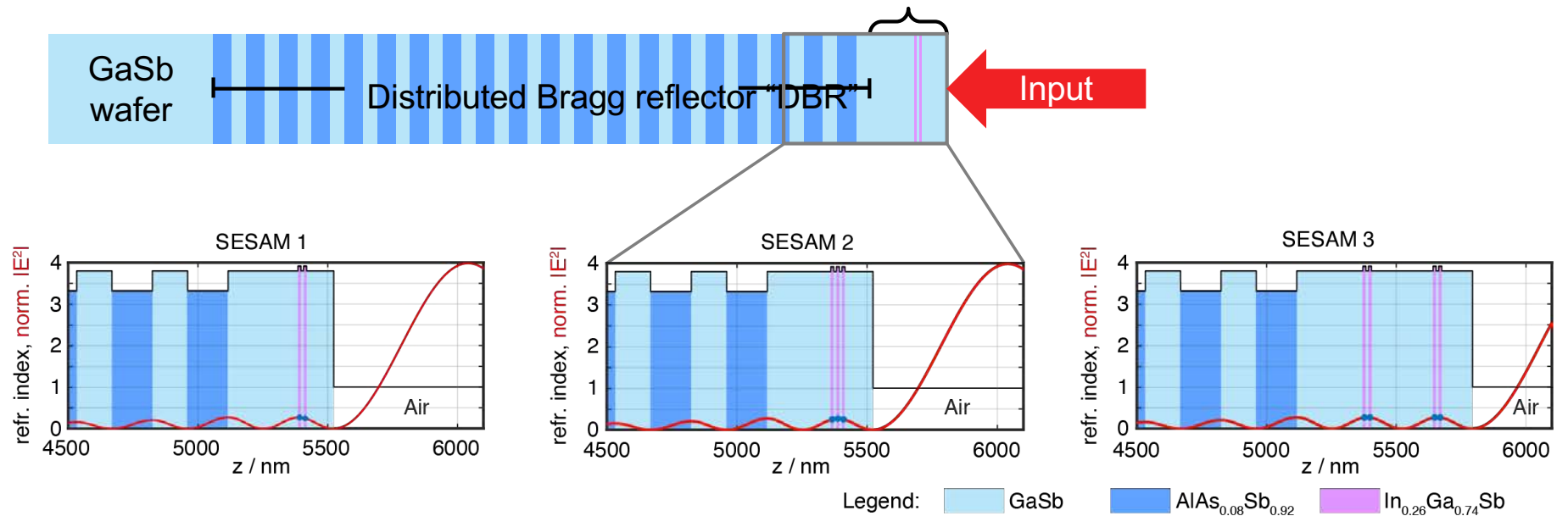
Jonas
Heidrich



Marco
Gaulke

J. Heidrich, M. Gaulke, B. O. Alaydin, M. Golling, A. Barh, U. Keller,
Full optical SESAM characterization methods in the 1.9 to 3- μm wavelength regime, *Opt. Express* **29**, 6647 (2021)

- SESAM = Distributed Bragg reflector (DBR) + QW absorber section
- 20 pair $\text{AlAs}_{0.08}\text{Sb}_{0.92}/\text{GaSb}$ DBR growth with molecular beam epitaxy at $525\text{ }^\circ\text{C}$
- 11.5 nm thick $\text{In}_{0.26}\text{Ga}_{0.74}\text{Sb}$ quantum wells (type I) grown at $455\text{ }^\circ\text{C}$

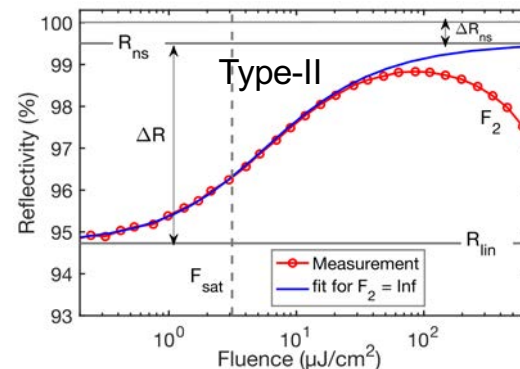
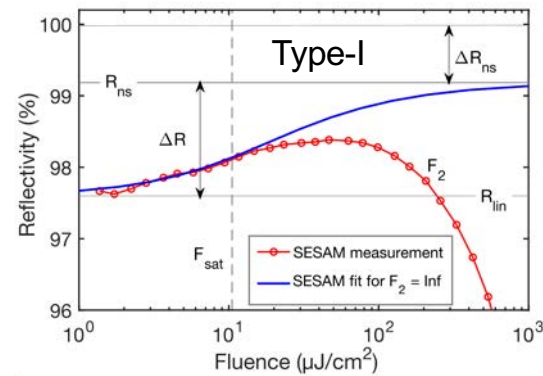


	QWs	F_{Sat} ($\mu\text{J}/\text{cm}^2$)	ΔR (%)	ΔR_{ns} (%)	F_2 (mJ/cm^2)
SESAM 1	2	5	1	0.18	70.6
SESAM 2	3	2.9	1.8	0.15	50.8
SESAM 3	4	2.6	2.4	0.23	29.3

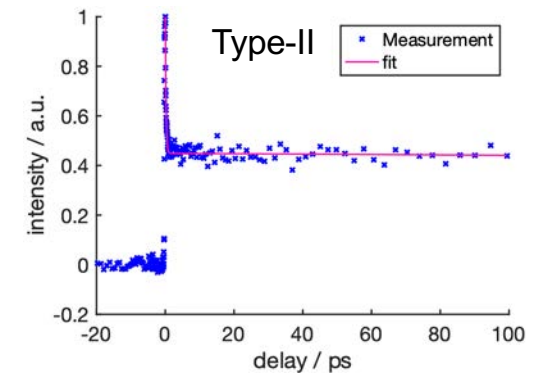
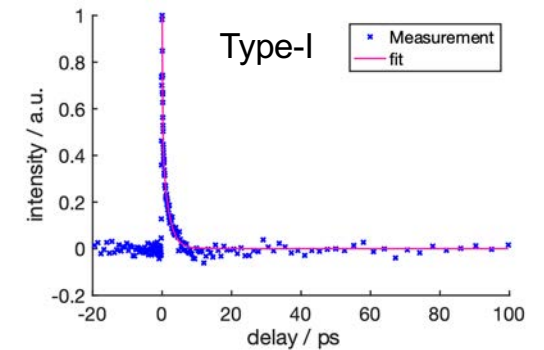
SESAM	Type-I	Type-II
Modulation depth ΔR	1.59 %	4.78 %
Saturation fluence F_{sat}	10.51 $\mu\text{J}/\text{cm}^2$	3.13 $\mu\text{J}/\text{cm}^2$
Non-saturable loss ΔR_{ns}	0.8 %	0.5 %
F_2	18 mJ/cm^2	31 mJ/cm^2
Absorber recovery dynamics		
τ_1	160 fs	300 fs
τ_2	1.9 ps	$> 10^3$ ps
A_{slow}	0.45	0.58

Measured @ 2.36 μm with 100-fs pulses

Nonlinear reflectivity measurement



Pump-probe measurement



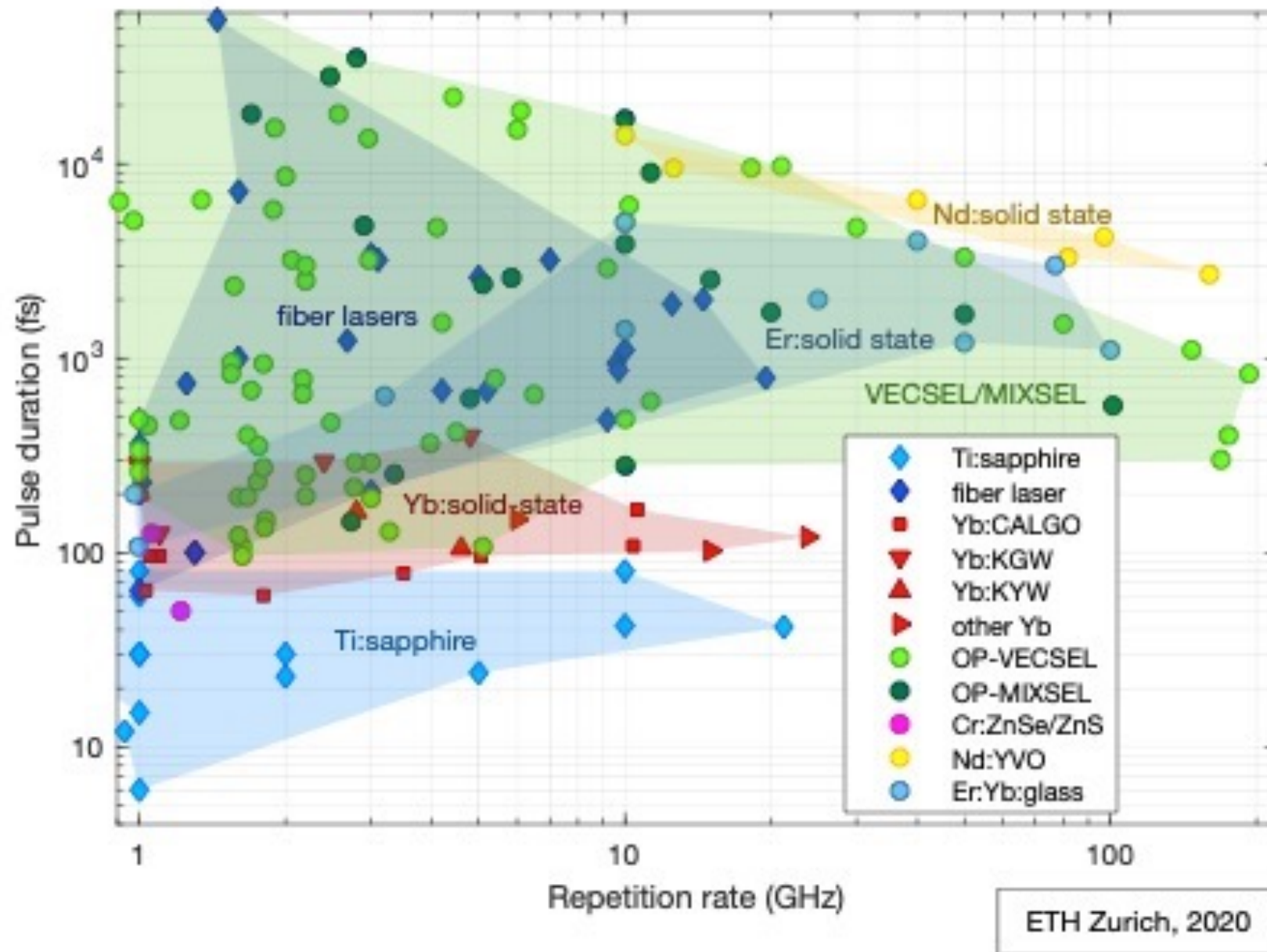
A. Barh, J. Heidrich, B. O. Alaydin, M. Gaulke, M. Golling, C. R. Phillips, U. Keller
 “Watt-level and sub-100-fs self-starting modelocking Cr:ZnS oscillator enabled by GaSb-SESAMs”
Optics Express, vol. 29, No. 4, pp. 5934-5946, 2021

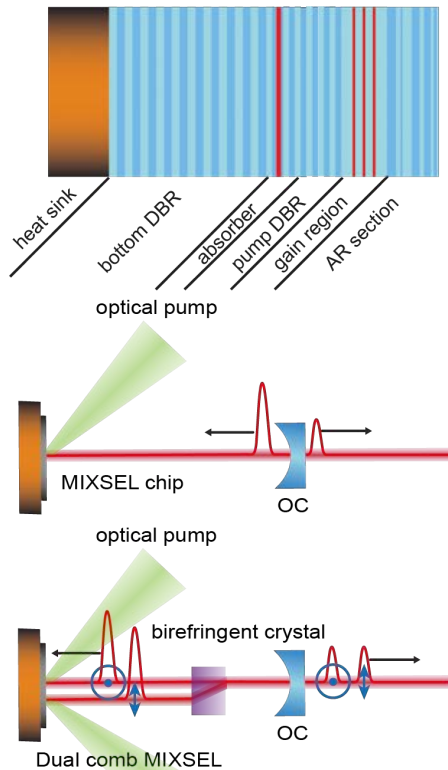
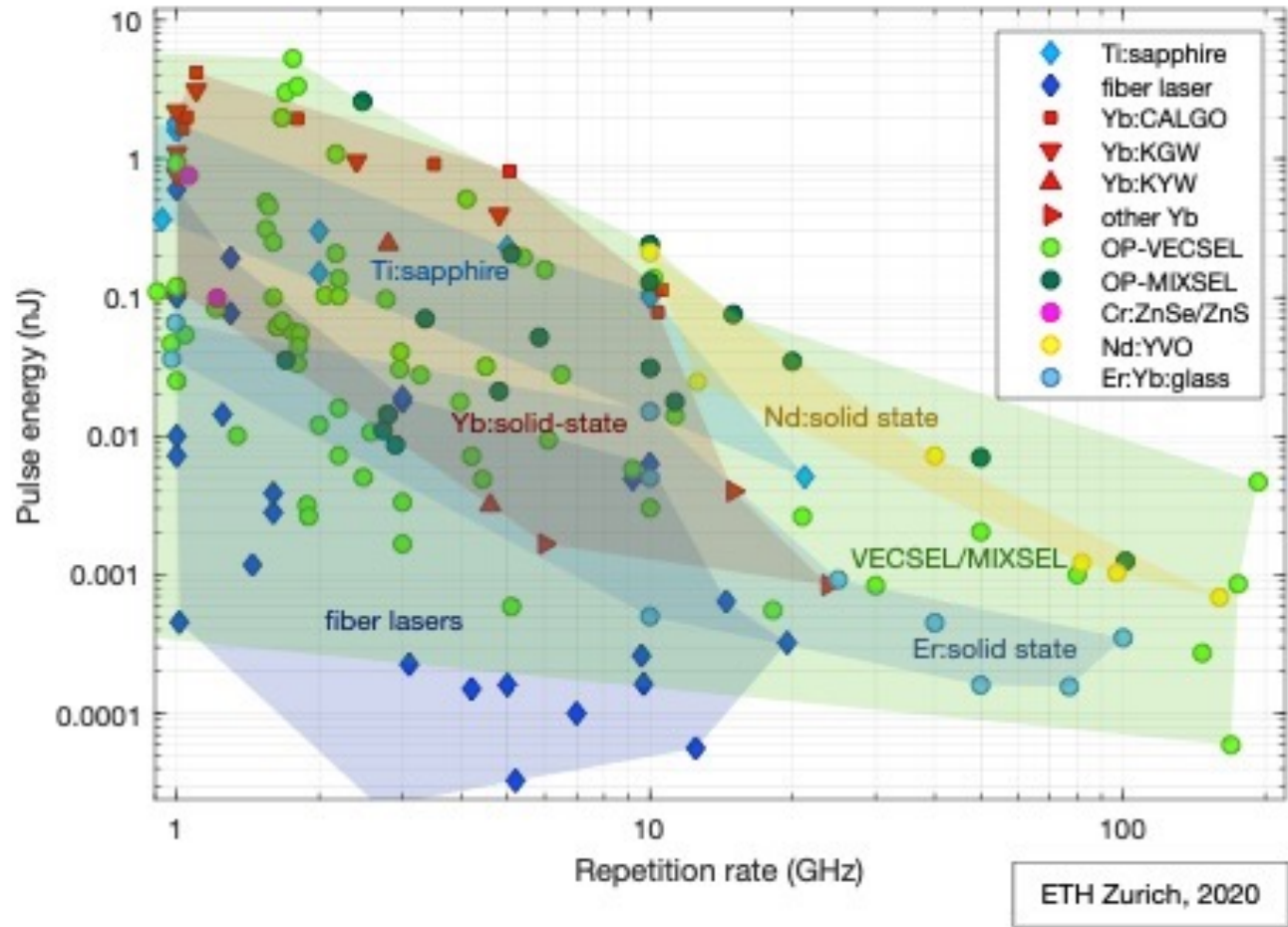
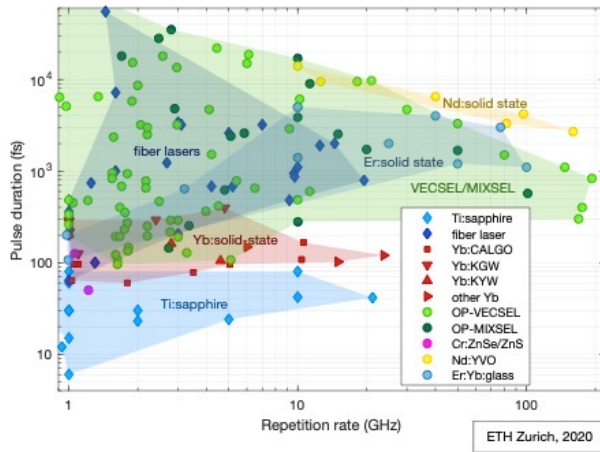
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6. Outlook



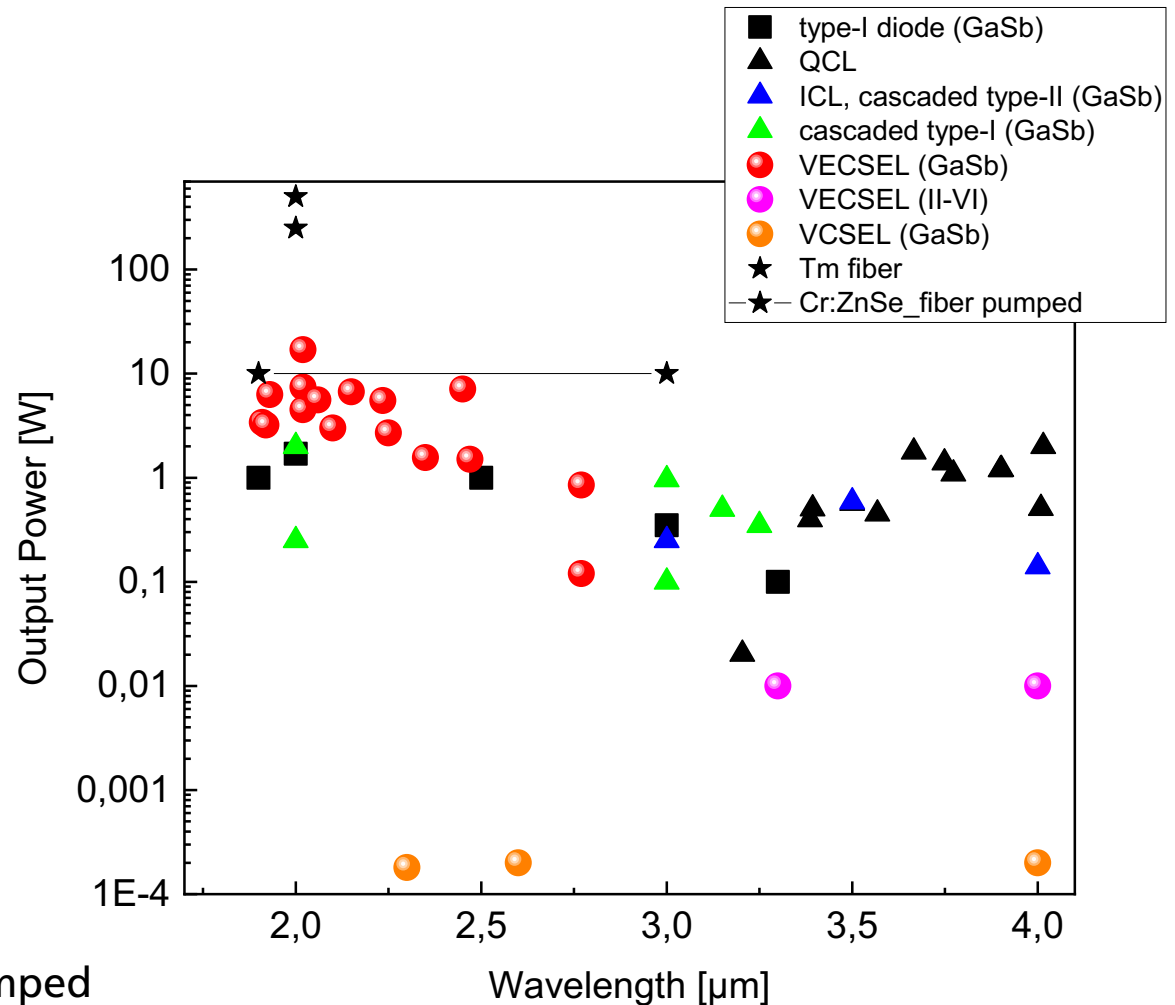




MIXSEL
modelocked integrated external-cavity surface-emitting laser

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U. Keller

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